Supplemental S1: Standard operation procedures (SOP) for physico-chemical characterization

S1-1 Trace impurities

Inductively Coupled Plasma Mass Spectrometry (ICP-MS) Inductively Coupled Plasma Optical Emission Spectrometry (ICP-OES) Technology: Mass an Optical Emission Spectrometry of Materials after dissolution in acids	Category: C. Particle Characterisation ex-situ Institute: KIT Location: Karlsruhe Institute of Technology Institute for Applied Materials (IAM-AWP) Building 688 Hermann-vHelmholtz-Platz 1 D-76344 Eggenstein-Leopoldshafen Germany
Equipment: • ICP-MS: 7500 ce, Agilent • ICP-OES OPTIMA 4300DV Perkin Elmer	Contact Details of Technology Expert: Name: Dr. Christel Adelhelm Phone: +49 721 608-22914 Fax: +49 721 608-922914 E-mail: christel.adelhelm@kit.edu

Short technology description and Main Features:

ICP-MS is a sensitive analytical method (0.000001 – 100%) for rapid multi-element (Li - U except C, N, O, F, Cl) determination in the trace and ultra-trace range of different solid and liquid sample materials, technical products and biological samples. Solid samples are dissolved by subboiled acids. The liquids are aspirated into a spray-chamber, dried, atomized and ionized in an Ar-Plasma (ICP). The element ions are accelerated into a quadrupole mass spectrometer (MS) and detected according to their mass. To eliminate mass interferences the ions pass a reaction cell. The detector intensities are correlated to the intensities of calibration solutions. ICP-OES is a less sensitive (0.0001 – 100%) but robust and precise method for multi-element analysis (Li - U except C, N, O, Halogens). Sample introduction is similar to ICP-MS. In the Argon plasma excited atoms or ions emit light dispersed by an Echelle optic and detected by a segmented diode array. Calibration solutions provide quantification.

Н																	Н
Li	Be	1										В	С	N	0	F	N
0,002	0,0005											0,01					
Na	Mg	1										Al	Si	Р	S	CI	F
0,03	0,002											0,005	5	1	10	5	
Κ	Ca	Sc	Ti	V	Cr	Mn	Fe	Co	Ni	Cu	Zn	Ga	Ge	As	Se	Br	ł
5	0,5	0,005	0,01	0,002	0,005	0,0005	5	0,0005	0,01	0,01	0,002	0,001	0,002	0,01	0,02	0,5	
Rb	Sr	Y	Zr	Nb	Мо	Tc	Ru	Rh	Pd	Ag	Cd	In	Sn	Sb	Te	J)
0,0005	0,0001	0,0002	0,0005	0,0005	0,001		0,0005	0,0002	0,001	0,0001	0,0005	0,0001	0,0005	0,001	0,002	0,002	
Cs	Ва	La	Hf	Та	W	Re	Os	lr	Pt	Au	Hg	TI	Pb	Bi	Po	At	F
0,001	0,0005	0,0001	0,0005	0,0005	0,0005	0,0005	0,01	0,0005	0,001	0,0005	0,001	0,0001	0,001	0,0002			
		Ce	Pr	Nd	Pm	Sm	Eu	Gd	Tb	Dy	Ho	Er	Tm	Yb	Lu		
		0,0001	0,0001	0,0005			0,0002	0,0002		0,0005	0,0001	0,0005	0,0002		0,0001		
	Ra	Ac	Th	Pa	U	Np	Pu	Am	Cm	Bk	Cf	Es	Fm	Md	No	Lw]
Fr	1.04																

Typical detection limits of ICP-MS in $\mu g/L$

Any further Information

The most sensitive analytical methods have been chosen to determine most other elements than the nanomaterials consisted of. Two methods have been used ICP-OES (optical emission spectrometry with inductively coupled plasma) for elements with concentrations above 10 ng/mL or ICP-MS (mass spectrometry with inductively coupled plasma) below 10 ng/mL. Because of the sensitivity of these methods precleaned vessels, subboiled or ultrapure acids and deionized water (18 Ω /cm²) have been used. To identify matrix effects and spectral interferences the purest available substances of SiO₂, Ti metal, ZnO or Ce(NO₃)3*(6-7)H₂O have been analyzed to. Blank solutions have been prepared with the same acid and water to control the blank.

The main compounds have been determined additionally either to show the batch to batch variability and/or to correlate the impurity concentration. For precise element determination ICP-OES and the use of internal standard provides the lowest repeatability.

Nanomaterials dispersed in water or as powder has to be dissolved in acids previous to spectrometric investigation:

SiO₂: 0.4 g nanopowder was dissolved in 2 mL HF ultrapure and diluted to 100 mL or 5 mL of homogenized dispersion was acidified with 0.5 mL HF ultrapure and diluted to 15 mL with water. For ICP-MS further dilution was necessary.

ZnO: 0.05 g nanopowder was dissolved in 2 mL HCl subboiled at 80 °C and made up to volume 50 mL with deionized water. For ICP-MS further dilution was necessary.

TiO₂: 5 mL of homogenized dispersion was acidified with 1 mL HF ultrapure and 0.2 mL HNO₃ subboiled. After heating at 80 °C the clear solution was diluted to15 mL with deionized water. For ICP-MS further dilution was necessary.

CeO₂: 5 mL of homogenized dispersion was acidified with 2 mL HNO₃ subboiled and H₂O₂ suprapure .After heating at 80 °C the clear solution was diluted to10 mL with deionized water. For ICP-MS further dilution was necessary.

S1-2 Solubility

	Category: C. Particle Characterisation in and ex-situ and/or
Water Solubility- dissolution test	Institute: Institut Català de Nanotecnologia (ICN) Location: Campus UAB Contact Details of Technology Expert: Jordi Piella Tel. +34-937374624 Jordi.piella@icn.cat

Short technology description

Water solubility is defined as the saturation mass concentration of the substance in water at a given temperature. However, when talking about nanoparticles it may be a relatively misleading term and a more accurate definition is necessary. Two main processes exist when adding nanoparticles in a specific environment: dispersion and dissolution. The first one is related to the number of particles in suspension, while the second one refers to the release of ions form the particles. The OCDE procedure does not clearly differentiate these two concepts. Moreover, dissolution and dispersion are often mutually affected. In the present project, the solubility of a nanoparticle is understood has the concentration of free ions in the solution in equilibrium with the particle in a controlled environment.

Material

All experiments are performed in Milli-Q[®] water. Concentration of ions in the sample is determined spectrophotometrically and the standard procedure depends on the ions to be determined.

Procedure

Test is performed in Milli-Q[®] water at 25°C, circumneutral pH and under static equilibrium conditions to avoid interferences. The concentration of the substance is chosen to a value that it is approximated to a concentration used for in vitro experiments.

The sample is diluted with Milli-Q[®] water until a concentration of 100 ppm and incubated at 25°C. If it is in powder form, the solution is sonicated (Brandson 2510) for 15 min to achieve well dispersion. Aliquots are taken at different time points (until 30 days), centrifuged at high speed and the supernatant filtrated with the use of a regenerated cellulose centricone (Millipore) to ensure removal of all the nanoparticles from the sample. The amount of ions absorbed by the filter is calculated with the use of standards. Finally, the concentration of free ions is measured spectrophotometrically (UV-Vis spectrophotometer, Shimadzu UV-2401) with the corresponding standard procedure for each substance (SiO₂[<u>13</u>], ZnO[<u>14</u>], TiO₂[<u>15</u>, <u>16</u>]). Due to a lack in the procedure, tests for Polystyrene and CeO₂ nanoparticles were not done. Further discussion is presented in later sections.

Main Features (Equipment capabilities):

UV-Vis spectrophotometer (Shimadzu UV-2401) for absorbance measurement from 200 nm to 900 nm

Typical Samples & Images:

- OECD guideline for the testing of chemicals. Test 105.[12]
- 4500-SiO₂ D. Heteropoly Blue Method: Greenberg, A. E., Standard methods for the examination of water and wastewater. 16th edition. American Public Health Association, Washington, 1985.
- 3500-Zn F. Zincon Method: Greenberg, A. E., Standard methods for the examination of water and wastewater. 18th edition. American Public Health Association, Washington, 1985.

S1-3 Crystalline phase

Electron Microscopy and Focussed Ion Beam Nanostructuring Technology:	Category: C. Particle Characterisation in- and ex-situ
 Scanning Electron Microscopy (SEM) Transmission Electron Microscopy (TEM) Focussed Ion Beam (FIB) Nanostructuring Equipment: TEM FEI TITAN 80-300 with Cs image corrector, EDX spectrometer, monochromator, and high-resolution imaging energy filter Philips CM200 FEG/ST ZEISS922 Omega Field-emission (FE)-SEM FEI Quanta 650 ESEM FE-SEM ZEISS LEO 1530 FIB FEI Strata 400 	Institute: Laboratory for Electron Microscopy (LEM), KIT Location: Laboratory for Electron Microscopy (LEM) Karlsruhe Institute of Technology (KIT) Campus South, Building 30.22 Engesserstr. 7 D-76131 Karlsruhe Germany Contact Details of Technology Expert: Name: Dr. Reinhard Schneider Phone: +49 721 608-43719 E-mail: reinhard.schneider@kit.edu

To determine the inner structure of solid-body particles, transmission electron microscopy (TEM) techniques are a well-established analytical means besides, e.g., X-ray diffraction (XRD) (Figure 1a). In more detail, the real structure of a material can directly be determined by high-resolution TEM (HRTEM) imaging, where the contrast features do clearly reveal whether the particles are amorphous or crystalline.

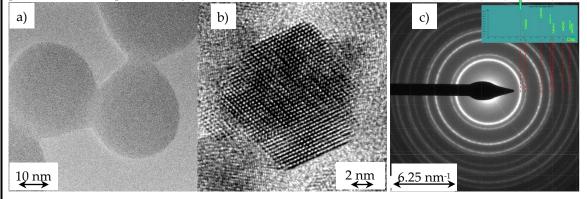


Fig. 1: HRTEM image of silica (a) and CeO₂ nanoparticles (b), SAED pattern recorded from a large number of CeO₂ nanoparticles (c).

Exemplary, this can be recognized from the HRTEM images in Figs. RS1a and b), showing SiO₂ nanoparticles of the batch SilNP002 with amorphous structure and an individual single-crystalline CeO₂ particle (CeO₂NP_006) of approximately 12 nm in size, respectively. For the latter particle the viewing direction is along the [110] zone axis and the corresponding distances of visible {111} and {002} lattice planes amount to about 0.312 nm and 0.271 nm. Nowadays, through the use of state-of-the-art instruments equipped with electron-optical systems for correcting the spherical aberration of the objective lens, a lateral resolution of 0.1 nm and better can be achieved, which allows to visualize clusters of atoms or even single metal atoms lying on extremely thin carbon films (Figure 1b, Figure 1c). However, the accuracy in measuring the crystal-lattice spacing strongly depends on the quality of the microscope calibration, which is usually done by reference samples with known structure.

Keeping this in mind, differences in determining lattice parameters from laboratory to laboratory can also be caused by not well performed calibration procedures. In general, reliable structural data with ± 0.005 nm as a typical number can be obtained by HRTEM imaging. Thus, XRD measurements, yielding lattice parameters in nanometers with uncertainties in the 5th digit, are more accurate [RS5]. In addition to imaging techniques, structure analyses are also possible in TEM by applying electron-diffraction methods as given via the selected-area electron diffraction (SAED) pattern of ceria nanoparticles (batch CeO₂NP_009) in Fig. RS1c. In this figure the experimentally obtained SAED pattern is compared with a simulated one, which distinctly furnishes proof of the presence of CeO₂. Thus as shown in this example, electron diffraction gives information not only about the lattice parameters and symmetry of a crystal, but also about the stoichiometry of a compound, i.e. the present chemical phase.

S1-4 Crystalline Size

	Category:
	C. Particle Characterisation in and ex-situ
	Institute: Institut Català de Nanotecnologia (ICN)
Equipment Name:	Location: Campus UAB
	Contact Details of Technology Expert:
XRD	Jordi Piella
	Tel. +34-937374624
	Jordi.piella@icn.cat

Short technology description / Overview

Maybe the most versatile and widely used characterization tool for materials science and now also for nanotechnology. XRD is based on the optical interferences when a monochromatic radiation passes through a gap that has the same length than its wavelength. As X-Ray have similar wavelengths than the interatomic lengths inside crystals (in the order of Angstroms) when pass through a crystal, this acts as a diffracting net: diffracts the x-rays with a concrete direction and intensity and a pattern of peaks is obtained

Procedure

XRD measurements are performed using a powder diffractometer (PANalytical X'Pert) operating with a Cu K α radiation source (λ =1.541Å). If the sample is suspended in liquid phase, the solid is extracted out by centrifugation and dried in an oven at 70°C to eliminate all the moisture.

For crystalline size determination, D_{hkl} is calculated applying the Scherrer formula, $D_{hkl} = 0.9 \lambda/B_{hkl} \cos\theta$, to the line width, B_{hkl} , at half maximum corrected for the instrumental broadening assuming Gaussian profiles.

Equipment:

- PANalytical X'Pert diffractometer operating with a Cu Kα radiation source (λ=1.541Å) or Co Kα (λ=1.789Å).
- Composition of the NPs (and purity)
- Arrangement of the atoms inside the NPs (crystalline phase)
- Size of the crystal using Scherrer's formula
- Size, crystal face, purity, crystal defects, degree of oxidation
- Sonicator (Branson 2510)
- Centrifuge (Hermle Z36HK)

Typical Samples & Images:

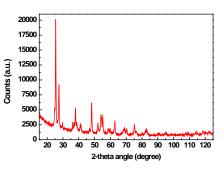


Figure 1: XRD spectrum of commercial Degussa P25 purchased from Sigma-Aldrich.

S1-5 Crystallite-size / particle-size distribution by TEM

Electron Microscopy and Focussed Ion Beam Nanostructuring	Category: C. Particle Characterisation in- and ex- situ
 Technology: Scanning Electron Microscopy (SEM) Transmission Electron Microscopy (TEM) Focussed Ion Beam (FIB) Nanostructuring Equipment: TEM FEI TITAN 80-300 with Cs image corrector, EDX spectrometer, monochromator, and high-resolution imaging energy filter Philips CM200 FEG/ST ZEISS922 Omega Field-emission (FE)-SEM FEI Quanta 650 ESEM FE-SEM ZEISS LEO 1530 FIB FEI Strata 400 	Institute: Laboratory for Electron Microscopy (LEM), KIT Location: Laboratory for Electron Microscopy (LEM) Karlsruhe Institute of Technology (KIT) Campus South, Building 30.22 Engesserstr. 7 D-76131 Karlsruhe Germany Contact Details of Technology Expert: Name: Dr. Reinhard Schneider Phone: +49 721 608-43719 E-mail: reinhard.schneider@kit.edu

Because of its high lateral resolution, TEM is certainly well suited for measuring the size of an individual nanoparticle. However, problems can arise when nanoparticles are strongly agglomerated, hindering to distinguish between single particles. Moreover, the specific shape of a particle – i.e. spherical, plate-like, completely irregular, and so on – can complicate particle-size analyses since then a definition is needed what "particle size" does mean. Hence, from this point of view the simplest and therefore also best case for particle-size analysis is well-separated spherical particles. Here, automated routines of digital image analysis can often be applied successfully to find the size distribution. For more complicated configurations like, e.g., agglomerated particles or particles with elongated form, there are sometimes solutions of the above-mentioned problems which combine manual analyses with automated ones. Few corresponding examples of our QNano project, namely where fully digital routines failed, are presented in the following.

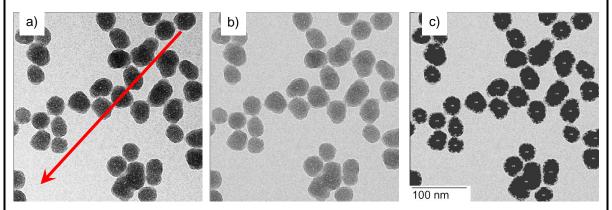


Fig. 1: Original TEM image of silica nanoparticles (a), image after background equalization (b), and with marked particles by applying a gray-level threshold (c).

The first example of silica nanoparticles concerns agglomeration. As demonstrated in Fig. 1, even for slightly agglomerated nanoparticles the sizes cannot be measured automatically. Fig. 1a shows the raw-data image taken from the SiO₂ particles (batch SilNP007), exhibiting a nearly similar size. Obviously, they touch each other which causes problems in the automatic particle separation.

In addition, before performing any digital image analysis, the background-brightness level has to be corrected in the case of not evenly illuminated pictures (there is a gradual increase in intensity from the upper right to the lower left, see arrow in Fig. 1a). This can be done by suited correction tools implemented within different image-processing programs (e.g., Adobe Photoshop). Then, after this background equalization (Fig. 1b) a particle-analysis tool as, e.g., the software package Digital Micrograph (Gatan) can be applied. First, a threshold in the gray values is set to select particles. As particles are connected, the threshold must be adjusted to identify single particles (cf. Fig. 1c). Since the further analysis counts slightly smaller particles, this discrepancy is measured and added to determined particle sizes. Finally, the results of the digital image analysis are filtered to rule out interconnected particles.

As imaginable, the size distribution of strongly interconnected particles cannot be analyzed directly with this routine. In this case, a possible way-out is a fit-by-eye of ellipses to discernible particles as shown in Fig. 2 for silica nanoparticles (batch SilNP010). The ellipses can be further processed with the above-mentioned automatic routine. Since the chosen ellipse areas are smaller than the real particles, after analysis a certain offset value has to be added to the measured size.

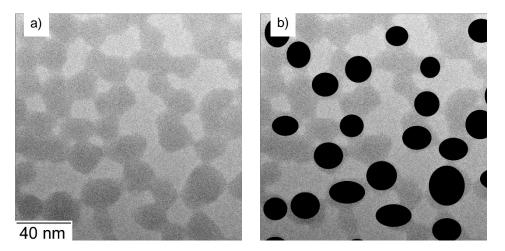


Fig. 2: Original TEM image of strongly interconnected silica nanoparticles (a), same image with drawn ellipses for further digital image analysis (b).

As evident from Fig. 2 the particles are only partly analyzed as the ellipses must not touch each other for the applied processing technique (i.e. Digital Micrograph). Also not all particles have an ellipsoid shape, so this procedure introduces some errors. To overcome this problem, another software tool was applied, as shown in Fig. 3. In Fig. 3a the particles have irregular shapes, so their contours were drawn free-hand. The situation is quite different for the CeO₂ nanoparticles shown in Fig. RS4b. In this projection, where the particles appear rhombus-like, their contours were marked with a polygon tool in the image analysis software (i.e. Adobe Photoshop). Afterwards the contours of all particles were analyzed automatically. The output of the routine can be varied widely, e.g. a circular diameter can calculated from the circumferences of the individual particles (Fig. 3a) or their length and width can be measured (Fig. 3). The advantage of this method is the analysis of the individual contours, so overlapping particles pose no difficulties.

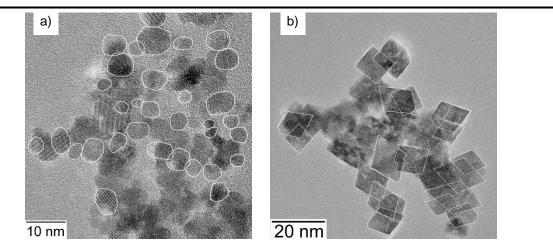


Fig. 3: HRTEM image of CeO₂ nanoparticles, (a) batch CeO₂NP_002 and (b) CeO₂NP_007. For determining the particle-size distribution either irregularly-shaped contours (a) or polygon-like ones (b) were chosen to mark individual nanoparticles and to measure their sizes.

References

- [1] D.B. Williams, C.B. Carter, Transmission Electron Microscopy A Textbook for Materials Science, Springer Science+Business Media, New York, 2009.
- [2] Q. Zhang, J. Xie, Y. Yu, J. Yang, J.Y. Lee, Tuning the crystallinity of Au nanoparticles, small 6 (2010), 523-527.
- [3] H. Hofmeister, Forty years study of fivefold twinned structures in small particles and thin films, Cryst. Res. Technol. 33 (1998), 3-25.
- [4] K. Dub, F. Ernst, M.C. Pelsozy, J. Barthel, K. Tillmann, Expansion of interatomic distances in platinum catalyst nanoparticles, Acta Materialia 58 (2010) 836–845.
- [5] B. Gamm, H. Blank, R. Popescu, R. Schneider, A. Beyer, A. Gölzhäuser, D. Gerthsen, Quantitative highresolution transmission electron microscopy of single atoms, Microscopy and Microanalysis 18 (2012), 212– 217.
- [6] F.H. Herbstein, How precise are measurements of unit-cell dimensions from single crystals?, Acta Cryst. B56 (2000), 547-557.

S1-6a Representative Electron Microscopy (TEM) picture(s)

Electron Microscopy and Focussed Ion Beam Nanostructuring	Category: C. Particle Characterisation in- and ex-situ				
Technology:Scanning Electron Microscopy (SEM)	Institute: Laboratory for Electron Microscopy (LEM), KIT				
Transmission Electron Microscopy (TEM)	Location:				
Focussed Ion Beam (FIB) Nanostructuring	Karlsruhe Institute of Technology (KIT)				
	Campus South, Building 30.22				
Equipment:	Engesserstr. 7				
• TEM FEI TITAN 80-300 with Cs image corrector,	D-76131 Karlsruhe				
EDX spectrometer, monochromator, and high-	Germany				
resolution imaging energy filter	Contact Details of Technology Expert:				
Philips CM200 FEG/ST	Name: Prof. Dr. Dagmar				
ZEISS922 Omega	Gerthsen				
• Field-emission (FE)-SEM FEI Quanta 650 ESEM	Phone: +49 721 608-43200				
• FE-SEM ZEISS LEO 1530	Fax: +49 721 608-43207				
• FIB FEI Strata 400	E-mail: <u>dagmar.gerthsen@kit</u> .edu				

Short technology description/Overview:

Different electron-microscopic techniques, including scanning electron microscopy (SEM), transmission electron microscopy (TEM) as well as scanning TEM (STEM), are applied to characterize the properties of nanoparticles and agglomerates thereof. Detailed information about the particle size and surface topography is obtained by field-emission SEM with a lateral resolution down to approximately 1 nm, whereas the crystal structure can be elucidated by electron diffraction in TEM and direct imaging at atomic resolution via high-resolution TEM (HRTEM). Both SEM and TEM investigations are combined with energy dispersive X-ray spectroscopy (EDXS) to reveal the chemical composition of the material in a quantitative manner, which can also be characterized along a line (line profiling) and two-dimensionally (X-ray mapping). An additional analytical tool for TEM inspection of particles at a high spatial resolution in the order of 1 nm is electron energy loss spectroscopy (EELS), which allows their quantitative element analysis, but also chemical-bond analyses by characterizing energy-loss near-edge structures (ELNES). Element distributions can be imaged through EELS line profiles and by energy-filtered TEM (EFTEM).

A target preparation of nanoparticle assemblies is facilitated by combined focused ion beam (FIB) milling and SEM imaging, allowing for example a stepwise sectioning of single particles. These experiments can be supplemented by in-situ EDXS analyses and low-kV HAADF (high-angle annular dark-field) STEM imaging, yielding strong atomic-number contrast.

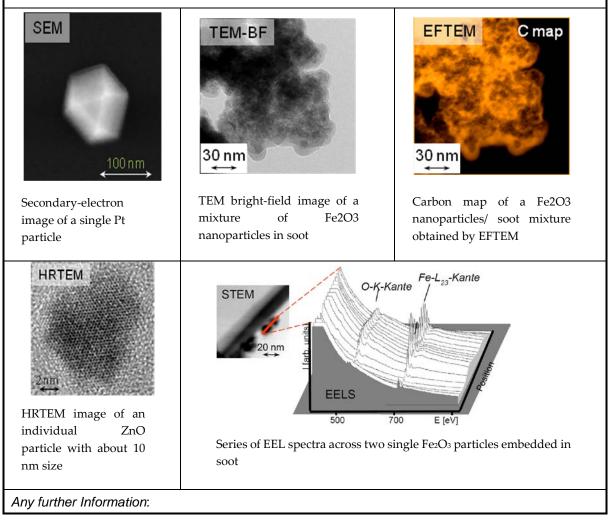
Main Features (Equipment Capabilities):

TEM/STEM FEI TITAN 80-300	FE-SEM ZEISS LEO 1530 and	Dual-beam FIB FEI Strata 400				
cubed	FE SEM FEI Quanta 650 ESEM	• Materials milling with Ga+				
• Operation modes and	• Accelerating voltages from 1	ions in the energy range from				
techniques (at 80 kV and 300	kV to 30 kV	1 to 30 kV – minimum				
kV): TEM, Lorentz-mode	• Secondary-electron (SE)	structure size of ~10 nm				
TEM, aberration-corrected	imaging with optimum	• Preparation and lift-out of				
HRTEM, STEM, electron	resolution of ~1 nm	TEM lamellae				
diffraction (SAED, CBED),		• In-lens SE imaging (about 1				
EDXS, EELS/ EFTEM,		nm resolution with electron				

Limitations / constrains

For investigations, powder material can be directly put on an electron-conducting support. For TEM/STEM characterization the particle size should be smaller than 200 nm. All samples have to be stable under high-vacuum conditions (except for SEM imaging with the FEI Quanta ESEM). Depending on the composition, the sample might be damaged by the electron beam (this holds especially organic material and polymers). EDXS allows detection of elements with atomic number $Z \ge 5$ (EELS is able to detect $Z \ge 3$).

Typical structures & designs



S1-6b Representative Electron Microscopy (TEM)

Technology: Transmission Electron Microscopy (TEM)	Category: C. Particle Characterisation in- and ex-situ Location: Univleeds
<i>Equipment:</i> Gatan SC600 CCD camera Oxford Instruments 80 mm2 X-max SDD EDX	Contact Details of Technology Expert: Name: Yunhong Jiang E-mail: pedyj@leeds.ac.uk
detector running INCA software	

FEI Tecnai F20 FEGTEM has been responsible for testing all batches of nanoparticles in this task. The equipment was operated at 200 kV fitted with Gatan SC600 CCD camera and Oxford Instruments 80 mm² X-max SDD EDX detector running INCA software. The microscope is operated in bright field mode with an extraction voltage of 3800 V and at spot size 3. The high resolution capabilities will obtain the information about atomic structure of the specimen. This TEM system is fully loaded including high angle annular dark field detector and X-ray energy disperse spectrometry. TEM samples of the NPs were prepared by nebulizing a thereof produced dispersion on a Cu grid (400 mesh) covered with a combined holey and ultrathin (about 3 nm) carbon film.

TEM sample preparation:

Sample preparation is very important for TEM observation and analysis. There are many ways available for preparing TEM sample. The facilities of TEM sample preparation has been focused on metallic materials, semiconductors, ceramics, and geo-science samples. The thickness of sample is between 10 and 200 nm depending on the material and the kind of observation. Samples are also to be electrically conductive, stable under vacuum and free of hydrocarbon contamination.

S1-7 Particle size distribution of the aerosol

	Category: C. Particle Characterization in and ex-situ					
Scanning Mobility Particle Sizer (SMPS)	Institute: KIT					
	Location: Institute for Technical Chemistry (ITC)					
	Contact Details of Technology Expert:					
	Name: M.Sc. Sonja Mülhopt					
	Phone: ++49-721/608-2-3807					
	Fax: ++49-721/608-2-4303					
	E-mail: muelhopt@kit.edu					

Short technology description/Overview:

As inhalation is one of the main uptake routes of nanoparticles into human bodies the particle size distribution of aerosolized NP is of interest. In Quality-Nano it is determined by Scanning Mobility Particle Sizer (SMPS) after suspending them in clean air.

Aerosolization

Depending on the kind of particle collective the corresponding method of aerosolization was chosen: bulk material of higher amounts was dispersed by rotating brush generator (RBG1000, Palas GmbH, Karlsruhe, Germany) whereas liquid suspensions were sprayed with the electrospray aerosol generator 3840 (TSI Inc., MN, USA). Nanoparticle powders of low amounts were suspended in liquid and also sprayed with the electrospray aerosol generator 3840.

Preparation of nanoparticle suspensions

From test particles delivered as powder a stock solution in pure water was prepared and sonified in the bath (USR 57, Merck EuroLab). This stock solution was suspended in 1 ml electro conductive solution, mostly in 5 mMol HNO₃.



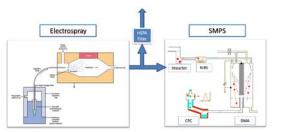


Figure 1: *left*: view to the cone of the electrospray generator while aerosol generation; *right*: the electrospray aerosol generator 3840 (TSI Inc., MN, USA) coupled with the scanning mobility particle sizer SMPS (TSI Inc., MN, USA)

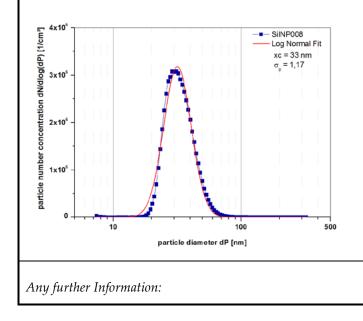
Table 1: relevant specifications of the Model 3480 Elec	ctrosprav Aerosol Generator
Tuble 1 , relevant specifications of the model of too Elev	enospiny meroson demenutor

Mode of operation	Generation of aerosols from liquid solutions or suspensions using
	an electrospray method
Capillary dimension	25 μm, 250 mm length
Particle type	Solids or nonvolatile liquids soluble in 20 mM ammonium acetate
	solution in ultrapure water or 0.05% trifluoroacetic acid in ultrapure
	water. Suspensions in some solvents up to a particle size of 100 nm.
Initial droplet diameter	150 nm nominal
Particle generation rate	>10 ⁷ particles/cm ³
Particle size range	2 to 100 nm
Liquid conductivity	0.2 S/m nominal

Measuring the number size distribution

Number size distributions were measured using a scanning mobility particle sizer (SMPS, DMA 3071 with CPC 3775, TSI). Aerosols typically show a log-normal distribution of size. The number size distribution was measured at least three times. The data were corrected regarding sampling losses using the penetration factor for tubing according to Soderholm [34] and analyzed by determining the mean +- standard deviation of the three number measurements in each size channel. The resulting particle number size distribution dN/dlog(d_P) [1/cm³] can be characterized by the three parameters of the log-normal fits: the modal value x_m [nm], the geometric standard deviation σ_{geo} [-/-] and the total number concentration c_N [1/cm³]. These three parameters are reported in the data sheets.

Typical Samples & Images:



S1-8a Particle size distribution (DLS)

	Category: C. Particle Characterization
Equipment Name:	Institute: Campus UCD
	Contact Details of Technology Expert:
Malvern Zetasizer Nano ZS	eugene.mahon@cbni.ucd.ie

Overview

Dynamic Light Scattering which can measure suspended particle hydrodynamic radius across a large range.

Sample Protocol: Stöber Silica Aqueous Suspension DLS Size Measurement Protocol (modified from protocol developed by Dr. Sonia Ramirez)

- 1. Wear appropriate personal protective gear and take appropriate precautions when handling nanomaterials.
- 2. Power up instrument at least 30 min in advance of measurements.
- 3. Suspend particle sample to the required concentration in MilliQ water.
- 4. Take the required volume of particle solution to fill the DLS cuvette to the recommended mark. Quartz or optical-quality glass cuvettes are generally preferred, but good quality plastic cuvettes may be substituted. All cuvettes, but in particular the more scratch-prone plastic cuvettes, should be routinely inspected prior to use and discarded if surface scratches or defects are visible.
- 5. Pre-rinse clean cuvette with filtered deionised water at least 3 times prior to loading sample. This is best done in a clean bench if available. Disposable plastic cuvettes should also be rinsed to eliminate any dust that might have deposited on them.
- 6. Recommendations for loading cuvette prior to analysis:
 - 6.1. Load sample into cuvette using minimum volume necessary to ensure liquid level is at least 2 mm above the entrance height of the laser beam for your particular instrument configuration (or refer to the instrument manual for recommended filling height for your cell and instrument configuration). *Do not overfill cuvettes past the recommended level, as overfilling can lead to thermal gradients that will adversely impact measurement accuracy.* For microcuvettes with a sample well insert, fill the well with sample, but do not fill beyond the well lip.
 - 6.2. Take care not to touch the cuvette windows with your bare hands while loading. Wipe the outside of glass or quartz cuvettes with lens paper to ensure cleanliness. If using disposable plastic cuvettes, do not wipe outside surface as this may leave scratches that will interfere with measurements.
 - 6.3. Cap the cuvette to prevent dust contamination and evaporation of solution.
 - 6.4. Inspect the cuvette to insure that air bubbles are not attached to the optical window area. If necessary, *gently* tap cuvette on a non-metallic padded surface to release bubbles before placing the cuvette in the sample holder, or, if necessary, repeat the loading procedure with fresh sample. *Never shake cuvette, as this may introduce air bubbles or entrap air in the sample well of some microcuvettes.*
 - 6.5. Place the cuvette correctly in the sample holder; i.e. optical windows should be facing the incident beam and detector.
- 7. The recommended measurement temperature (temperature of the test material) is near to or slightly above laboratory temperature. Measurements should not be conducted outside the range (20 to 25.5) °C. Recommended refractive index and viscosity values for the suspending medium (H2O) used in the calculation of z-average size from DLS measurements are given in table 1. If your instrument permits accurate temperature control, perform the size measurement at 25°C.

Refractive Index: 1.332 (suitable for wavelengths in the 488-750 nm range within the temperature range of 20 to 25.5°C)

If your instrument does not allow or require user input of viscosity and refractive index values, use the default settings for pure water at the measurement temperature, and report these values with your data.

Temperature T	Absolute Viscosity	Temperature T	Absolute Viscosity
[°C]	[mPa·s]	[°C]	[mPa·s]
20	1.002	20.5	0.989
21	0.977	21.5	0.966
22	0.954	22.5	0.943
23	0.932	23.5	0.921
24	0.910	24.5	0.900
25	0.890	25.5	0.880

Table 1. Viscosity values used in the calculation of z-average size from DLS when water is used
as suspending medium

Other values can be interpolated using the above data.

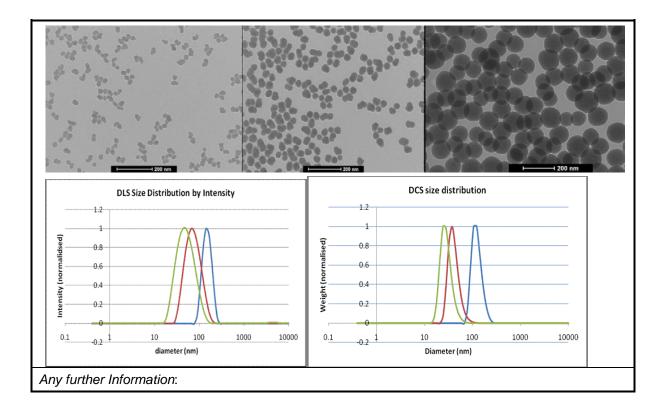
- 8. Allow 4 min equilibration time at the measurement temperature (25oC if possible) if the volume of sample used is 1mL or less. Larger sample volumes may require longer equilibration times. The temperature should be controlled and measured with a precision of 0.1 °C. Accuracy of the temperature measurement device should be better than 0.5 °C.
- 9. Take 3 different aliquots from the diluted sample (as per point 3) and make 3 independent measurements or repeats. This should be done for each received material. This will allow us to establish measurement repeatability. Measurement duration should be set according to instrument manufacturer's recommendations.4
- 10. If scattering intensity exceeds the optimum count rate for your instrument as stipulated by the manufacturer, the test materials can be diluted. To perform the dilutions use deionised water (18m resistance) filtered to at least 0.2 μ m or smaller.
- 11. If contamination or dust particles appear to be present in the test material (e.g., based upon high data variability or the occurrence of large size modes)
 - 11.1. Change the cuvette and use fresh sample. Repeat steps 6-10
 - 11.2. If the problem is not solved, the test materials can be filtered prior to analysis using a syringe filter in the range $0.2 0.45 \mu m$ pore size.

Main Features (Equipment Capabilities):

- Size measurement from 1nm (diameter) to 10 microns using patented *NIBS* (Non-Invasive Back Scatter) technology
- Zeta potential of proteins and particles from 3.8 nm up to 100 microns (diameter) using patented *M3-PALS* technology
- Sample concentrations from 0.1ppm to 40%w/v

Typical Samples & Images:

DLS distribution (bottom left) of fluorescent Stöber silica with for comparison TEM and DCS (Differential Centrifugal Sedimentation) results.



S1-8b Particle size distribution (DLS)

	Category:
	C. Particle Characterisation in- and ex-
	situ
Technology:	Location:
Dynamic Light Scattering (DLS)	Univleeds
J	Contact Details of Technology Expert:
	Name: Yunhong Jiang
	E-mail: pedyj@leeds.ac.uk

Short technology description / Overview:

Dynamic Light Scattering (DLS) is an important tool for characterizing the size of nanoparticles in solution. DLS measures the light scattered from a laser that passes through a colloidal solution and by analyzing the modulation of the scattered light intensity as a function of time, the hydrodynamic size of particles and particle agglomerates can be determined. DLS is a valuable tool for determining and measuring the agglomeration state of nanoparticles as a function of time or suspending solution. When DLS sizing data is compared to Transmission Electron Microscopy images, the aggregation state of the particles can be determined. In an unagglomerated suspension, the DLS measured diameter will be similar or slightly larger than the TEM size. If the particles are agglomerated, the DLS measurement is often much larger than the TEM size and can have a high polydispersity index (large variability in the particle size).

The Malvern Zetasizer series combines a particle size analyzer, zeta potential analyzer and molecular weight analyzer for particles and molecules from below a nanometer in size to several microns. The systems measure size using dynamic light scattering. Zeta potential and electrophoretic mobility use electrophoretic light scattering, and molecular weight use static light scattering. For particles in situ in biofluids (e.g. cell culture media), additional care is needed in performing the experiments and in interpreting the data, especially given the known relationship between size and scattering (i.e. a few large agglomerates can mask the presence of a large number of small particles).

DLS sample preparation:

A concentration should be chosen such that the result is independent of the concentration chosen. The maximum concentration should be less than 1% by volume to avoid particle interaction. The minimum concentration should generate a minimum count rate of 10,000 counts per second (10kcps) for water as the dispersant. The recommended concentration is in the range of 0.1% (for particles as small as a few nm) to 0.0001% (for particles as large as 1 μ m) by volume. Ultrasonication was used to remove air bubbles or to breakup agglomerates. Keep in mind that in some cases the primary particles may be damaged. The size range is from 1 nm up to 6 μ m, based on 1 g/cm³ density.

S1-9 Gas sorption analysis

	Category:
	C. Particle Characterisation in and ex-situ
	Institute: UU
Gas sorption analysis	Location: Ångström lab
	Contact Details of Technology Expert:
	Johan Forsgren johan.forsgren@angstrom.uu.se

Short technology description / Overview

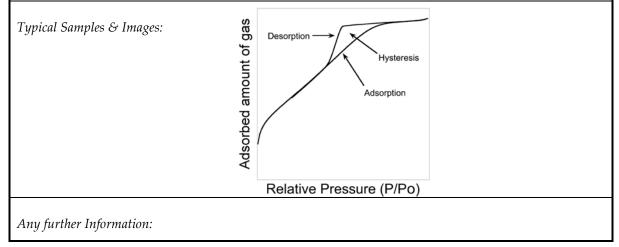
Gas sorption analysis enables measurement of specific surface area, pore volume and pore size distribution of dry particles. The technique is based on the gradual multilayer formation of physisorbed gas molecules on solid surfaces at different pressures. An isotherm is obtained by measuring the amount of adsorbed gas molecules on the sample at different pressures, and the data is used for calculations of specific surface area, pore volume and pore size distribution. The adsorption branch in the isotherm is used to determine the specific surface area according to the BET-equation and information about the pores in the powder can for instance be obtained by applying the BJH-equation to the desorption branch. The BJH-equation is a modified version of the Kelvin equation describing desorption of molecules from condensed gas contained in small pores. Another way to determine the porous properties of a powder is to use density functional theory (DFT) on the isotherm, which is a more modern and accurate method. The nature of the technique only allows for analysis of pores in the meso to micro size range as the limited size of these pores makes the gas condense inside the pores below the saturation pressure (capillary condensation), and it is this phenomenon that enables analysis of the pores in the sample.

For accurate measurement, the sample needs to be degassed properly in order to remove all water from the surface prior to analysis, preferably over 110°C. Between 0.1g and 0.5g of sample is generally a good quantity for analysis.

The analysis is carried out using an ASAP 2020 (Micromeritics) at 77K (-196°C) with N_2 as analysis gas.

Main Features (Equipment Capabilities):

- Specific surface area
- Pore volume
- Pore size distribution



S1--10 Zeta potential (surface charge)

	Category:
	C. Particle Characterisation in and ex-situ
Zeta potential	Institute: UU, Location: Ångström lab
	Contact Details of Technology Expert:
	Johan Forsgren johan.forsgren@angstrom.uu.se

Short technology description / Overview

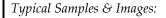
The zeta potential describes the electrical potential at the slipping plane in the electrical double layer of dispersed particles, i.e. the potential between the dispersion medium and the stationary layer of fluid surrounding the particles. The magnitude of the zeta potential relates to the surface charge of the particles and the pH of the dispersion medium. The ions in the dispersion medium (and hence the pH) affect the nature of the electrical double layer around the particles where a positive charge is built up under acidic conditions and vice versa. Therefore is pointless to measure the zeta potential without knowing the pH of the suspension. The pH value where the zeta potential is zero is called the isoelectric point (IEP) and is the point where the stability of the colloidal suspension is lowest. A colloidal suspension is generally considered stabile at zeta potentials greater than ±30mV. At low zeta potential, the electrostatic repulsion between the particles in suspension is low and the particles tend to flocculate.

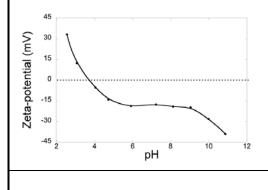
The zeta potential does not only serve as a measure of the stability of the colloidal suspension of particles, but can also be used as an indicator of the surface charge of the particles as there is no direct way to measure this property. The zeta potential is measured using electrophoresis where particles in suspension are subjected to an electric field and the velocity of the moving particles is measured using light scattering techniques. From the velocity of the particles, the zeta potential can be obtained using the Henry equation.

The zeta potential is preferably measured in aqueous electrolytes containing 10⁻²-10⁻³ M salt. For example, the particles can be suspended in an 10⁻³ M KCl electrolyte where the pH is adjusted with 10⁻² M solutions of HCl and NaOH.

Main Features (Equipment Capabilities):

- Measurement of zeta potential of particles in suspension at different pH
- Assessment of colloidal suspension stability
- Determination of isoelectric point of particles





S1-11 Photocatalytic activity

	Category:	
	C. Particle Characterisation in and ex-situ	
	Institute: Institut Català de Nanotecnolog	gia
Equipment Name:	(ICN)	
24.000 - 00000	Location: Campus UAB	
Photocatalytic Activity test	Contact Details of Technology Expert:	
5 5	Jordi Pie	ella
	Tel. +34-9373746	524
	Jordi.piella@icn.cat	

Short technology description/Overview

The principle of the photo catalysis by nanoparticles is straightforward. Under a radiation source, and upon adsorption of photons with energy higher than the band gap, electrons are excited from the valence band to the conduction band, creating electron-hole pairs. These charge carriers, in particular the electrons from the conduction band, migrate to the surface of the particle -where the reactions take place- and facilitate reduction reactions. The capture of holes and electrons by adsorbed species generate a variety of highly reactive radicals and intermediate species such as OH-, O2-, H2O2 capable of producing the oxidation of organic matter. In an aqueous media, the kinetic of the photocatalytic reactions mediated by nanoparticles can be followed spectrophotometrically by studying the degradation of organic dyes such as Rhodamine B (RhB), Methylene Blue or some phenol derivatives during photo-oxidation. Thus, by testing the photocatalytic degradation of RhB as a model contaminant it is possible to have an approximation of the potential environmental applications for the removal of contaminants from wastewater.

Material

Rhodamine B (RhB)

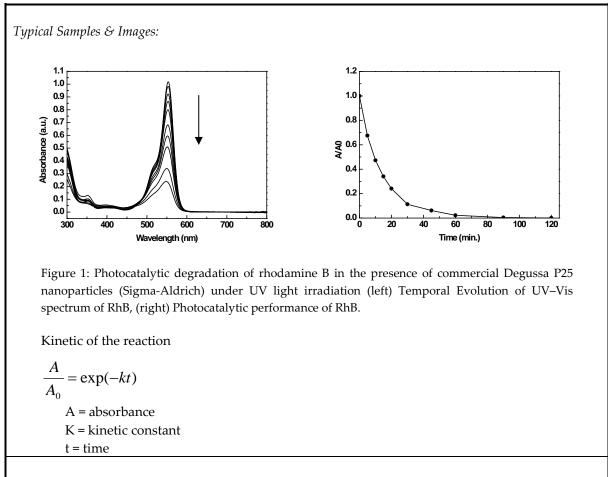
Procedure

Photocatalytic activity test is performed in Milli-Q[®] water at ambient temperature (25^oC) and circumneutral pH as a function of the decolorization of RhB with time.

An aqueous solution of tested particles is stirred with RhB dye (1 mM). If the sample is in powder form, the solution is previously sonicated for 15 minutes to properly disperse the particles before RhB addition. The solution is kept in dark conditions and allowed to reach the absorption-desorption equilibrium among the photocatalyst for 30 min. UV Lamp (100 W, 365 nm, Ted Pella, Inc.) is used as a light source to trigger the photocatalytic reaction. The average light intensity striking on the surface of the reaction solution is around 8.9 mW/cm². After UV irradiation for some time, 1 mL of the sample is taken and the absorbance of RhB remaining in the supernatant is measured using a UV-Visible spectrophotometer (Shimadzu UV-2401). In the case that the particles absorb in the same range as RhB, centrifugation of the solution at high speed is done prior to the measurements.

Main Features (Equipment capabilities):

UV-Vis spectrophotometer (Shimadzu UV-2401) for absorbance measurement form 300 nm to 800 nm.



Any further Information:

Beydoun, D.; Amal, R.; Low, G.; McEvoy, S. Role of nanoparticles in photocatalysis. Journal of Nanoparticle Research 1999, 1, 439-458.

S1--12 Octanol-Water partition coefficient Pow

	Category:
	C. Particle Characterisation in and ex-situ
	Institute: Institut Català de Nanotecnologia
Equipment Name:	(ICN)
	Location: Campus UAB
Octanol-Water partition coefficient	Contact Details of Technology Expert:
	Jordi Piella
	Tel. +34-937374624 Jordi.piella@icn.cat

Short technology description

The partition coefficient (P) is defined as the ratio of the equilibrium concentrations of a dissolved substance in a two-phase system consisting of two largely immiscible solvents. In the case of n-octanol and water:

$$P_{ow} = \frac{C_{n-oc \tan ol}}{C_{water}}$$

The partition coefficient, being the quotient of two concentrations or the quotient of the fractions of the test substance in the two phases multiplied by a fixed volume ratio, is dimensionless and is usually given in the form of its logarithm to base ten.

Octanol-water partition coefficient can be measured in two different ways: regarding the concentration of ions from the nanoparticles or in terms of the number of nanoparticles in each phase. The last one is the one presented here. However, in this case the results become highly dependent on the type of coating on the surface of the particles and thus it partially loses its sense. Moreover, particles synthetized in aqueous solution are obvious to be more affine to water than octanol.

Material

1-Octanol (99%) was purchased from Sigma-Aldrich. Milli-Q[®] water is used in all the experiments. Water taken directly from an ion exchange should not be used.

Procedure

Before a partition coefficient is determined, the two solvents are mutually saturated at the temperature of the experiment. To do this, it is practical to shake two large stock bottles, one containing n-octanol and a sufficient quantity of water, and the other containing water and a sufficient quantity of n-octanol, for 24 hours on a mechanical shaker, and then to let them stand long enough to allow the phases to separate.

Equal volume of dispersed nanoparticles in water and n-octanol are mixed for 12 hours at 25°C. Then the two phases are allowed to separate for 2 hours and the concentration of nanoparticles in the n-octanol phase are analysed by Inductively Coupled Plasma Mass Spectrometry (ICP-MS) Agilent instrument (Model: 7500cx) with a detection limit of 0.02386 ppb . In case that the nanoparticles are in powder form, the sample is sonicated (Brandson 2510) for 15 min for better dispersion. Since ICP-MS cannot be used for polystyrene nanoparticles, the presence of these particles in the octanol phase is measured by comparing the absorbance of the n-octanol phase before and after the experiment.

Main Features (Equipment capabilities):

Inductively Coupled Plasma Mass Spectrometry (ICP-MS) Agilent instrument (Model: 7500cx) with a detection limit of 0.02386 ppb.

Typical Samples & Images:

S1-13 Radical Formation Potential

	Category: C. Particle Characterization in and
	ex-situ
	Institute: KIT
	Location: Eggenstein-Leopoldshafen, Campus
<i>Test for reactive oxygen species by DCF (DCF test):</i>	North
	Contact Details of Technology Expert:
	Name: Dr. Silvia Diabate
	Phone: ++49-721/608-2-2692
	E-mail: silvia.diabate@kit.edu

Material

- 5 mM 2′,7′-dichlorodihydrofluorescein-diacetate (DCFH2-DA, Invitrogen, Karlsruhe, Germany) in ethanol, stored in aliquots at -20°C
- 0.01 N sodium hydroxide (NaOH) solution, prepared from NaOH pellets (Merck, Darmstadt, Germany).
- Phosphate buffered saline (PBS) without Ca²⁺, without Mg²⁺, pH 7.4 (Invitrogen, Karlsruhe, Germany)
- Peroxidase from horseradish (HRP, Sigma, Taufkirchen, Germany)
- 30% hydrogen peroxide (H₂O₂, Sigma, Taufkirchen, Germany)

$Test\ procedure$

The test uses the oxidation of the non-fluorescent 2',7'-dichlorodihydrofluorescein (DCFH₂) to the fluorescent 2',7'-dichlorofluorescein (DCF) as an indicator for the presence of reactive oxygen species. Therefore, the commercial substance DCFH₂-DA must be deacetylated with NaOH. 0.1 ml of 5 mM DCFH₂-DA in ethanol is mixed with 2.4 mL of 0.01 N NaOH and incubated at room temperature (24°C) for 30 min. For neutralization, 10 ml PBS is added and kept on ice in the dark until use. Just prior to use, HRP is added as a catalyst (2.2 U/ml). The DCFH₂ concentration in the working solution is 40 μ M.

Suspensions of test particles are sonified for 10 min and different concentrations are prepared in PBS. H₂O₂ standard preparations (0.04 to 10 μ M) are prepared as well. The test solutions are mixed 1:1 (v/v) with the prepared DCFH₂ solution and incubated at 37°C for 15 min in the dark. The solution is then centrifuged (20,000 × g for 15 min) to remove the particles and the fluorescence of the supernatant is monitored at 485 nm excitation and 530 nm emission using a fluorescence microplate reader (e.g. BIO-TEK FL600 from MWG-Biotech AG, Ebersberg, Germany). Solutions containing polystyrene nanoparticles were centrifuged for 1 h. Results are expressed as fold changes of the particle free sample.

Main Features (Equipment Capabilities):

Fluorimeter, 485 nm excitation and 530 nm emission

References

Cathcart, R., Schwiers, E., and Ames, B.N. (1983). Detection of picomole levels of hydroperoxides using a fluorescent dichlorofluorescein assay. Anal. Biochem. 134, 111-116.

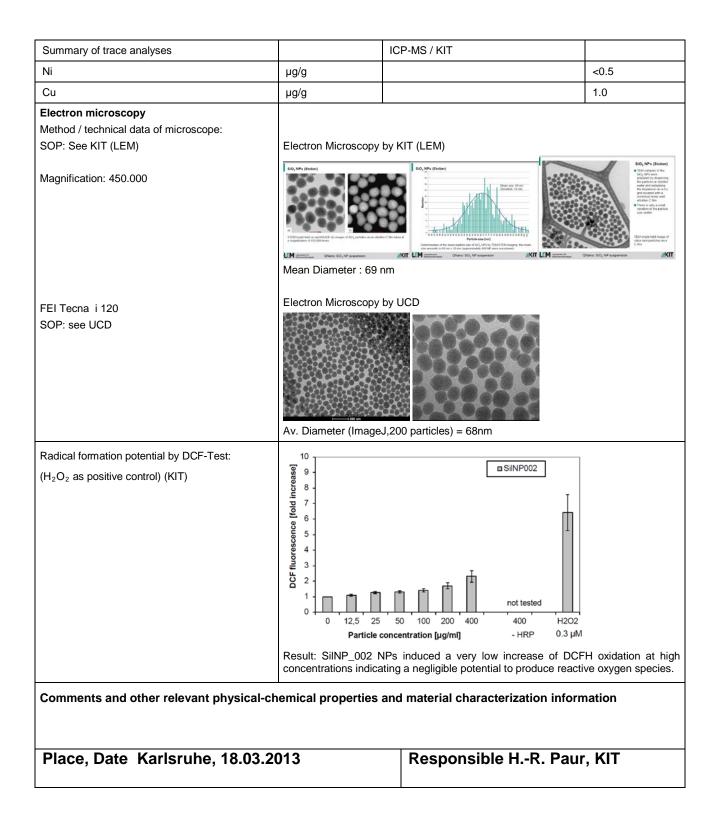
Foucaud, L., Wilson, M.R., Brown, D.M., and Stone, V. (2007). Measurement of reactive species production by nanoparticles prepared in biologically relevant media. Toxicol. Lett. 174, 1-9.

Any further Information:

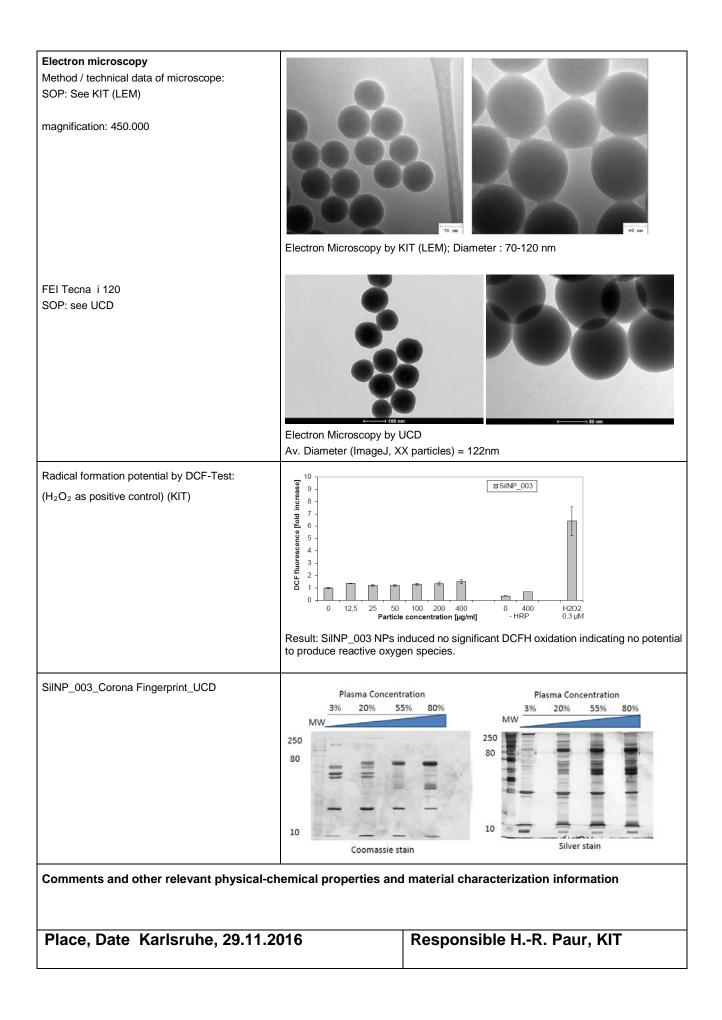
about 100 mg of particles are necessary for the test

Supplemental S2: Physicochemical characterization data sheets of silica NMs from Stöber synthesis

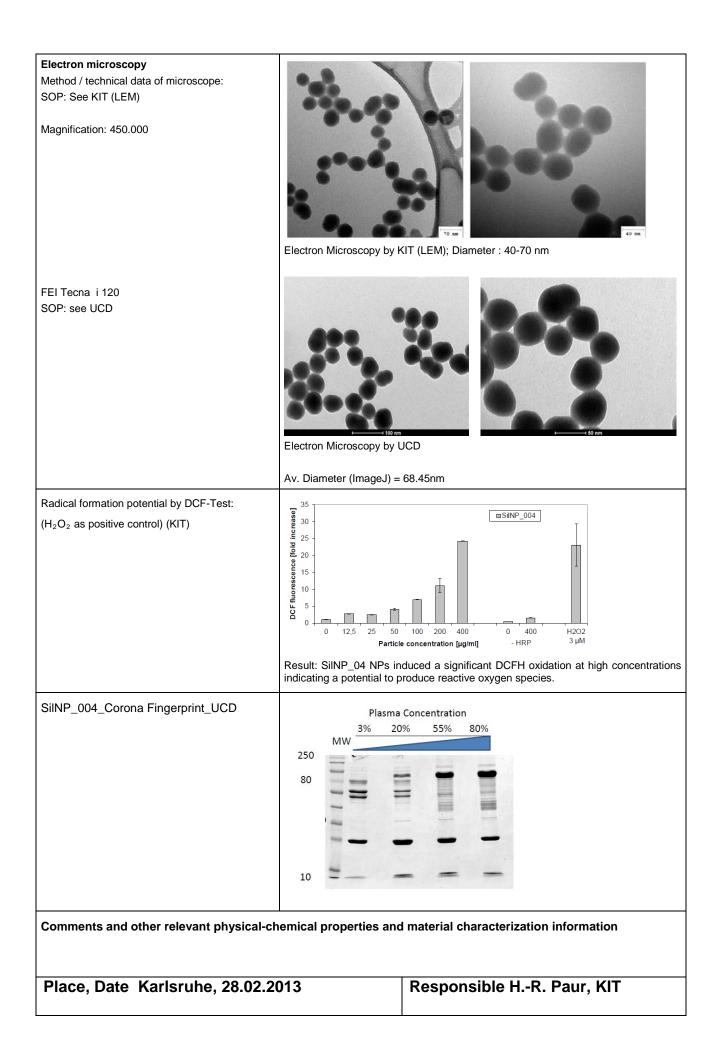
Na	ENTATIVE 1 anomaterial lo according to M/MONO(200	dentifica o OECD	tion	ualit	Syl	Vano
Nanomaterial		Silica		Manufacturer /Institute:		
Particle Code		SilNP	_002	Eugene Mahon , provided by UCD		
Composition		SiO ₂				
Method of pro	duction		r-Synthesis	Technology Expert: Euger	ie mano	וזכ
·				Suspension 🛛	Powde	r 🗆
Kind of susp	pension:			pH	Pure wa ?? none	
Property			unit	Method / Institute		Value
Agglomeration/aggr	regation			HRTEM (KIT)		Aggregated
Crystalline phase				D5000 Diffractometer /UU PANalytical X'Pert diffractometer	er /ICN	Amorphous
Crystallite size				HRTEM (KIT)		n.a.
Octanol-water partit	ion coefficient			Extraction/ ICP-MS (ICN)		P _{ow} =0
Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)		10% / 10 min	
Porosity			-/- or %	n.a.		n.a.
Pour density			cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	d	n.a.
Redox potential						
				Zetasizer Nano ZS /UU		82.7±0.35 (PDI: 0.049)
Size distribution: (suspension in water)	Modal value X	lue X _M (PDI) nm	1111	Zetasizer Nano ZS /UCD		87.4(PDI:0.057)/N M: 67.5
	Total concentr	ation	mg/ml			0.1 – 2 mg/ml
Size distribution: (Aerosol)	Modal value X	_Μ (σ _{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by AGF2.0		40 nm (soluble comp.?) 70 nm (σ _{geo} =1.42
	Total concentr	ation	mg/cm ³ or #/cm ³			1 x 10 ⁵ /cm ³
Solubility in	I		g/l			
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)		30.8±2.1	
Specific surface area		cm²/g	BET by ASAP2020 (UU)		n.a.	
Surface chemistry						
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU		-51.7 ± 1.2eV (pH 9.23)	



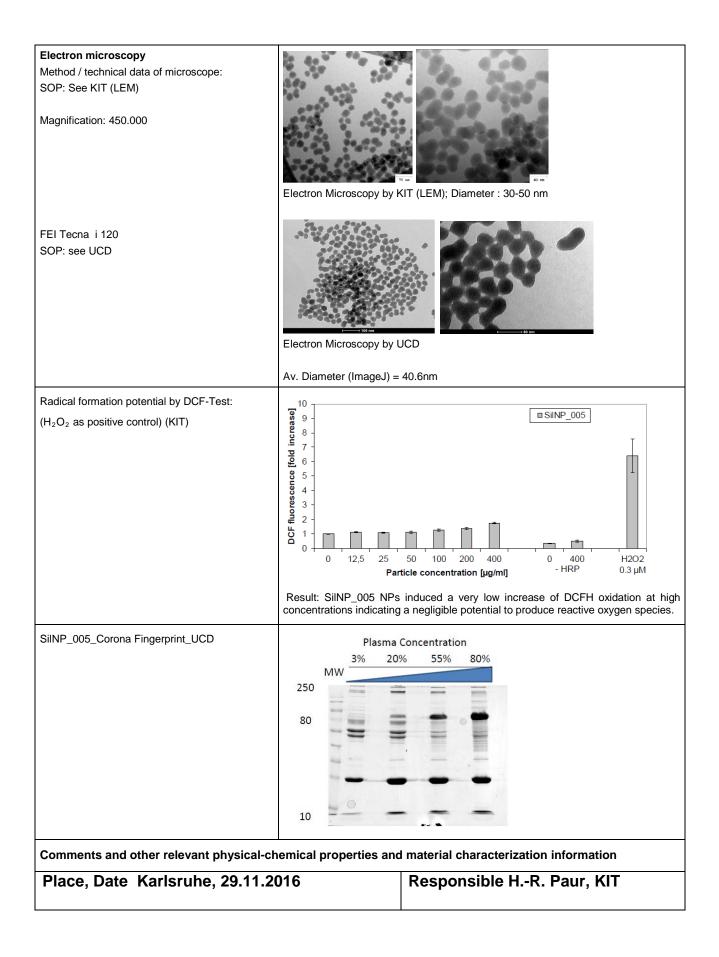
Na	NTATIVE TES nomaterial Identi according to OE /MONO(2009)20	fication CD	Research Infrastructu	Nano
Nanomaterial r	name Si	lica-NP		
Particle Code	Si	INP_003	Manufacturer /Institute/Date	
			Eugene Mahon ; provided by	UCD; 10/2011
Composition	Si	O ₂	Technology Expert: Eugene M	lahon
Method of proc	luction St	öber-Synthesis		
Kind of suspension:				
Property		unit	Method / Institute	Value
Agglomeration/aggree	gation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partitic	n coefficient		Extraction/ ICP-MS (ICN)	n.a.
Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	medium
Porosity		-/- or %	n.a.	n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	n.a.
Size distribution: (suspension in	Modal value X_M (PD	I) nm	Zetasizer Nano ZS /UCD DCS (UCD) (RWtAv / RNumAv)	129.3 (PDI:0.017)/ NM: 109.4 102.7/99.8
water)	Total concentration	mg/ml		1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{ge}		SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	118 (σ _{geo} =1.12)
	Total concentration	mg/cm ³ or #/cm ³		7.31x 10 ³ /cm ³
Solubility in		g/l		
Solubility in H_2O		g/l	Extraction/ ICP-MS (ICN)	392.2 g/L
Specific surface area		cm²/g	BET by ASAP2020 (UU)	n.a.
Surface chemistry				
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-60.9±10.2eV (pH 8.74)
Summary of trace and	alyses		ICP-MS / KIT	
В		µg∕g		22.0
Na		hð\ð		36.0
К		hð\ð		12.4
Са		µg/g		36.0



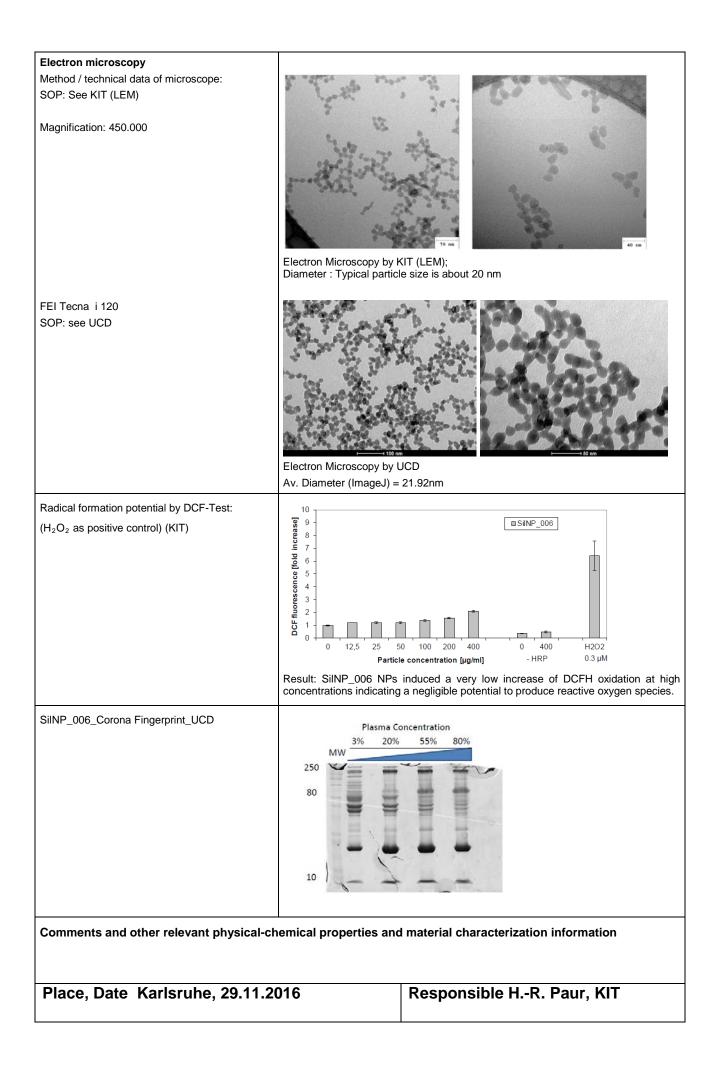
REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			ion	Research Infrastructure	Nano
Nanomaterial name Silica-		NP			
Particle Code		SilNP_	_004	Manufacturer /Institute/Date	
				Eugene Mahon ; provided by UC	C; 10/2011
CompositionSiO2Method of productionStöber		r-Synthesis	Technology Expert: Eugene Mahon		
Kind of susp	ension:			Suspension Image: Suspended in pH Power pH n.d. stabilizer none	water
Property			unit	Method / Institute	Value
Agglomeration/aggre	gation			HRTEM (KIT)	Agglomerated
Crystalline phase				D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN	Amorphous
Crystallite size				HRTEM (KIT)	n.a.
Octanol-water partition	n coefficient			Extraction/ ICP-MS (ICN)	
	Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none
Porosity			-/- or %	n.a.	n.a.
Pour density	Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	n.a.
Size distribution: (suspension in	Modal value X _M (PDI)		nm	Zetasizer Nano ZS /UCD DCS (UCD) (RWtAv / RNumAv)	75.15 (PDI:0.042) NM: 59.9 61.9/56.9
water)			mg/ml		1mg/ml
Size distribution: (Aerosol)	Modal value X _M		nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	65 (σ _{geo} =1.125)
	Total concentra	tion	mg/cm ³ or #/cm ³		1.04x 10 ⁴ /cm ³
Solubility in			g/l		
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	298.0 g/L	
Specific surface area		cm²/g	BET by ASAP2020 (UU)	n.a.	
Surface chemistry					
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-54.9 ± 14.0eV (pH 8.93)	
Summary of trace analyses			ICP-MS / KIT		
В		hð\ð		14.8	
Na		hð\ð		30.0	
Mg		hð\ð		10.0	
Са		µg/g		46.0	
Zn		µg∕g		0.8	



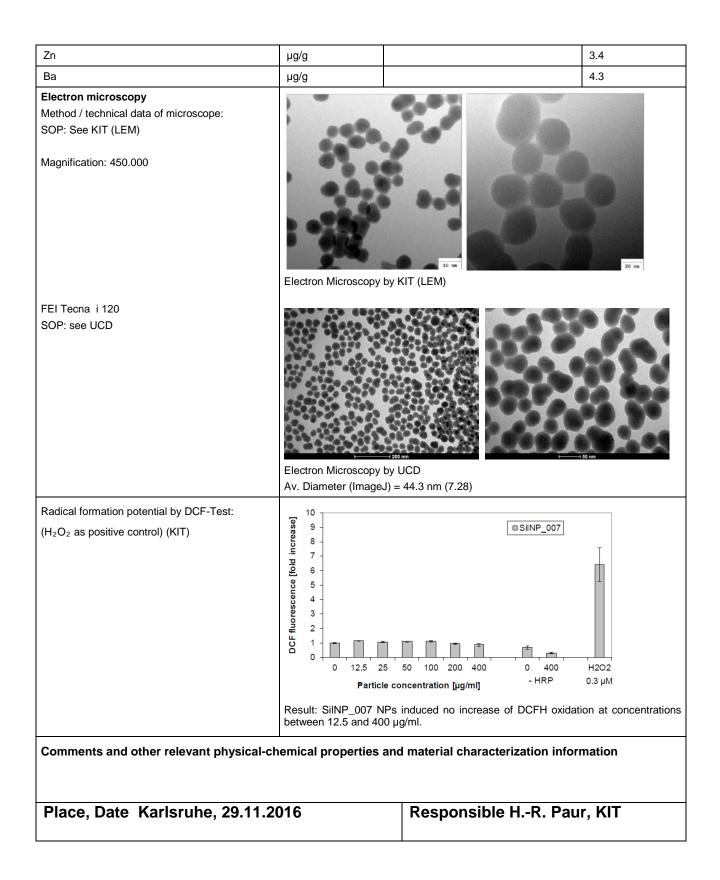
REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			Research Infrastructure	Vano
Nanomaterial nameSilica-Particle CodeSilNP_			Manufacturer /Institute/Date Eugene Mahon ; provided by UCD; 10/2011 Technology Expert: Eugene Mahon	
Composition Method of proc	SiO ₂ uction Stöber-Synthesis			
Kind of suspension:			Suspension Image: Constraint of the system Powder Suspended in pH Pure was pH n.d. stabilizer none None	
Property		unit	Method / Institute	Value
Agglomeration/aggre	gation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU)	Amorphous
Crystallite size			PANalytical X'Pert diffractometer (ICN) HRTEM (KIT)	n.a.
			Extraction/ ICP-MS (ICN)	n.a.
Octanol-water partition coefficient Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	n.a.
Size distribution:	Modal value X_M (PDI)	nm	Zetasizer Nano ZS /UCD	64.4(PDI:0.091)/ NM: 43.9
(suspension in water)			DCS (UCD) (RWtAv / RNumAv)	45.5 / 41.9
,	Total concentration	mg/ml		1 mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	52 nm (σ _{geo} =1.25)
	Total concentration	mg/cm ³ or #/cm ³		1.05x 10 ⁵ /cm ³
Solubility in		g/l		
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	165.0 g/L
Specific surface area		cm²/g	BET by ASAP2020 (UU)	n.a.
Surface chemistry				
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-51.1 ± 13.9eV (pH 8.91)
Summary of trace analyses			ICP-MS / KIT	
Cu		µg/g		6.0



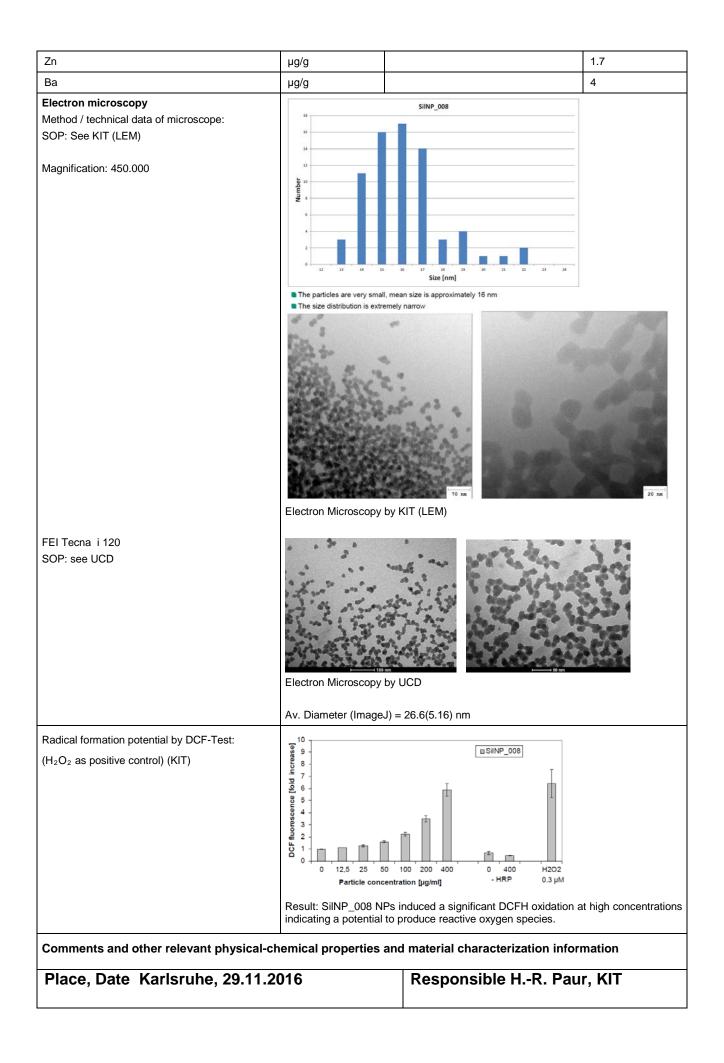
REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			Research Infrastructure uality	Vano	
Nanomaterial name Particle CodeSilica-N SilNP_Composition Method of productionSiO2 StöberKind of suspension:			Manufacturer /Institute/Date Eugene Mahon ; provided by UCD; 10/2011		
		2 per-Synthesis	Technology Expert: Eugene Mahon		
			SuspensionImage: Markow PowderSuspended in pHPure water n.d. nonestabilizernone		
Property		unit	Method / Institute	Value	
Agglomeration/aggr	egation		HRTEM (KIT)	Agglomerated	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous	
Crystallite size			HRTEM (KIT)	n.a.	
Octanol-water partiti	on coefficient		Extraction/ ICP-MS (ICN)	n.a.	
Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	medium	
Porosity	Porosity		n.a.	n.a.	
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	n.a.	
Size distribution: (suspension in	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD DCS (UCD) (RWtAv / RNumAv)	87.7 (PDI:0.231) NM: 41.2 48.8/37.25	
water)	Total concentration	mg/ml		1mg/ml	
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	58 (σ _{geo} =1.46)	
	Total concentration	mg/cm ³ or #/cm ³		5.88x 10 ⁴ /cm ³	
Solubility in	•	g/l			
Solubility in H_2O		g/l	Extraction/ ICP-MS (ICN)	55.6 g/L	
Specific surface are	Specific surface area		BET by ASAP2020 (UU)	n.a.	
Surface chemistry					
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-45.3±6.6eV (pH 7.72)	
Summary of trace analyses			ICP-MS / KIT		
В		hð\ð		40.0	
Na		µg∕g		32.0	
к		hð\ð		24.0	
Са		hð\ð		82.0	
Cu		hð\ð		18.0	
Zn		µg/g		6.2	



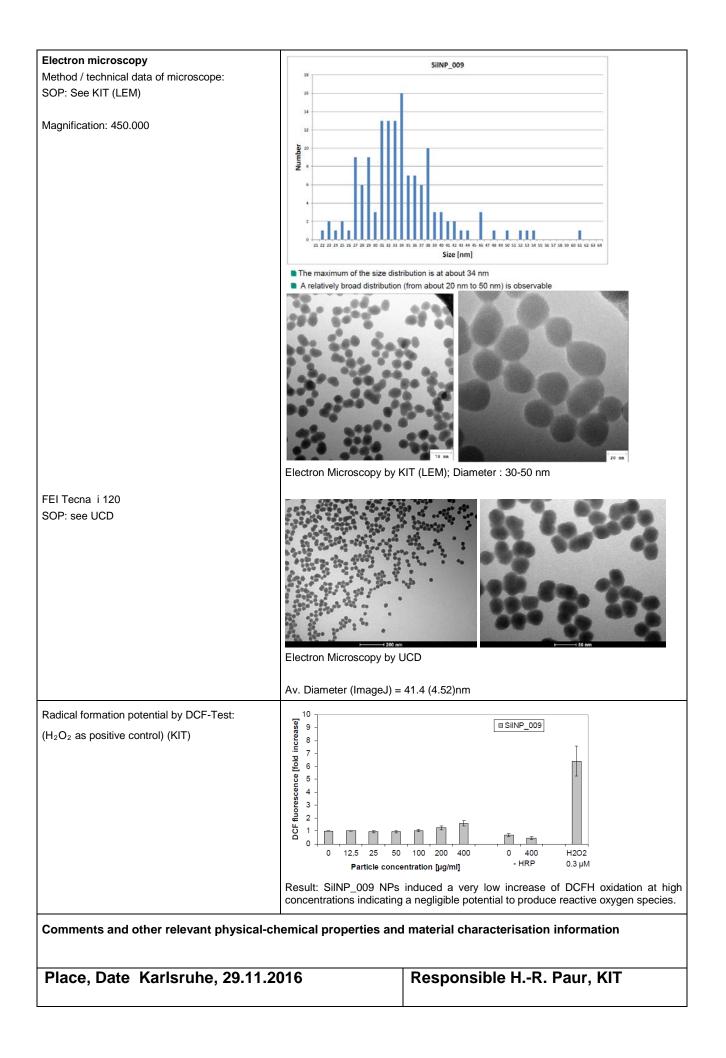
REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			Research Infrastructure uality	Nano
Nanomaterial name Particle CodeSilica- SilNP_CompositionSiO2 StöberMethod of productionStöber			Manufacturer /Institute/Date Eugene Mahon ; provided by UCD; 10/2011 Technology Expert: Eugene Mahon	
		 er-Synthesis		
Kind of susp			Suspension Image: Constraint of the system Suspended in Pure with the system pH n.d. stabilizer none	ater
Property		unit	Method / Institute	Value
Agglomeration/aggre	gation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU)	Amorphous
			PANalytical X'Pert diffractometer (ICN)	
Crystallite size	on coofficient		HRTEM (KIT) Extraction/ ICP-MS (ICN)	n.a. n.a.
Octanol-water partition coefficient Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	n.a.
Size distribution: (suspension in	Modal value X_M (PDI)	nm	Zetasizer Nano ZS /UCD DCS (UCD) (RWtAv / RNumAv)	67.2 (PDI:0.131) NM: 42.5 47.1/43.8
water)	Total concentration	mg/ml		1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	53.0
	Total concentration	mg/cm ³ or #/cm ³		3.62x 10 ⁴ /cm ³
Solubility in		g/l		
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	109.0 g/L
Specific surface area	l.	cm²/g	BET by ASAP2020 (UU)	n.a.
Surface chemistry				
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-66.2mV (pH 8.80)
Summary of trace analyses			ICP-MS (KIT)	
В		hð\ð		4.7
Na		hð\ð		21
Mg		hð\ð		4.4
AI		µg/g		6.1
К		hð\ð		13
Са		hð\ð		67
Fe		hð\ð		2.7
Cu		µg/g		3.9



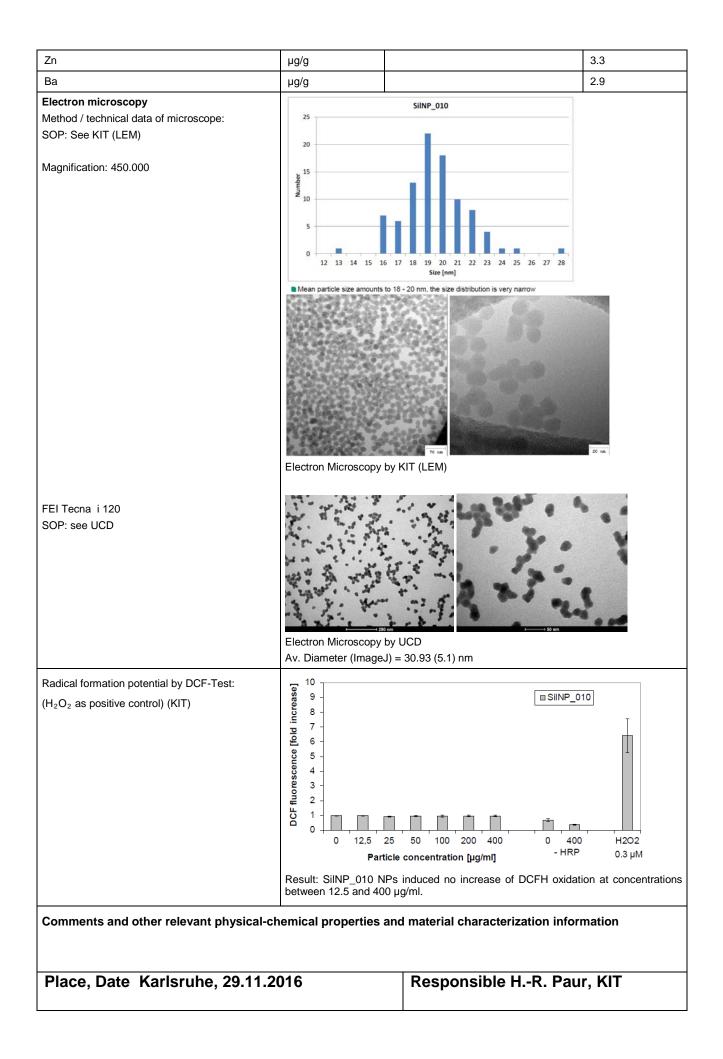
Na	ENTATIVE TEST nomaterial Identific according to OEC M/MONO(2009)20/F	cation D	Research Infrastructure	Vano	
Nanomaterial	name Silic	a-NP			
Particle Code	SilN	P_008	Manufacturer /Institute/Date		
			_ Eugene Mahon ; provided by UCE); 10/2011	
Composition	SiO	_	Technology Expert: Eugene	Mahon	
Method of pro	duction Stol	per-Synthesis	Suspension 🛛 Powde	,	
Kind of susp	ension:		Suspended in Pure wa pH n.d. stabilizer none		
Property		unit	Method / Institute	Value	
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous	
Crystallite size			HRTEM (KIT)	n.a.	
Octanol-water partiti	on coefficient		Extraction/ ICP-MS (ICN)	n.a.	
Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none	
Porosity		-/- or %	n.a.	n.a	
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	n.a	
Size distribution:	Modal value X_M (PDI)	nm	Zetasizer Nano ZS /UCD	36.5 (PDI: 0.175) NM: 19.9	
(suspension in water)			DCS (UCD) (RWtAv / RNumAv)	23.2/22.6	
,	Total concentration	mg/ml		1mg/ml	
Size distribution: (Aerosol)	Modal value X_{M} (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	33 (σ _{geo} =1.17)	
	Total concentration	mg/cm ³ or #/cm ³		8.3x 10 ⁴ /cm ³	
Solubility in		g/l			
Solubility in H_2O		g/l	Extraction/ ICP-MS (ICN)	62.37 g/L	
Specific surface area	a	cm²/g	BET by ASAP2020 (UU)	n.a.	
Surface chemistry					
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-38.0mV (pH 7.78)	
Summary of trace ar	nalyses		ICP-MS (KIT)		
В		µg/g		4.9	
Na		hð\ð		35	
Mg		hð\ð		2.1	
AI		hð\ð		2.1	
К		µg/g		30	
Са		µg/g		56	
Fe		µg/g		2.1	
Cu		µg/g		2.1	



Aggiomeration/aggregation IMRTEM (KIT) Aggiomerated Crystalline phase D5000 Diffractometer /UU PANalytical X Per diffractometer /ICN Amorphous Crystalline pratition coefficient Extraction /ICP-MS (ICN) n.a. Choodamin-B BleachingUV-B-100 10mg/ml in Water (ICN) n.a. n.a. Protocatalykic activity ri- or % n.a. n.a. Pour density cm3/g (BJH) Pore Size Distribution and Volume by ASAP2020 (UU) n.a. Size distribution: suspension in vater) Modal value X _M (PDI) nm Zetasizer Nano ZS /UCD fi.3 (PDI:0093) NM: 43.7 Size distribution: suspension in vater) Modal value X _M (PDI) nm Zetasizer Nano ZS /UCD fi.3 (PDI:0093) NM: 43.7 Size distribution: vater) Modal value X _M (rgue) nm SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray 50 Solubility in g/l fill point fill point fill point Solubility in g/l fill point fill point fill point Solubility in	Na	ENTATIVE TEST F anomaterial Identifica according to OECE M/MONO(2009)20/R	ation D	uality	Nano
Part Loode Silve_D09 Eugene Mahon : provided by UCD; 10/2011 Composition SiQ : Sidber-Synthesis Eugene Mahon : provided by UCD; 10/2011 Kind of suspension: Sidber-Synthesis Suspended in PH Pure water none Rind of suspension: unit Method / Institute Value stabilizer None Property unit Method / Institute Value Agglomeration/aggregation HRTEM (KT) Agglomerated Drystalline phase Interm (KT) Agglomerated Dystalline phase Interm (KT) na Agglomerated Dystalline phase Interm (KT) na Agglomerated Dystalline phase Interm (KT) na Agglomerated Dystalline size Interm (KT) na Agglomerated Optionating main Work Recomments Bleaching/UV-B-100 none Optionating main Work Na Size distribution and Volume by ASAP2020 (UU) Ne Agglomerated Size distribution: Modal value Xu (repu) nm Zeatazer Nano ZS /UC MM 43.7 Size distribution: Ne Agglom Size distributio	Nanomaterial	name Silica	a-NP		
Composition Method of production SiO₂ Stöber-Synthesis Technology Expert: Eugene Mahon Kind of suspension: Suspension Suspension Powder n.d. pH n.d. pH n.d. pH n.d. pH Nue Aggiomerationagaregation unit Method / Institute Value Value Aggiomerationagaregation PANEWICK Aggiomerated Amorphous Crystalline size Intermediate Protectallytical XPent diffractometer /UU PANalytical XPent diffractometer /UN PANalytical XPent diffractometer /UN PANALYTER n.a. Optical diffractometer /UN Panewishical XPent diffractometer /UN Panewishical XPent diffractometer /UN PANALYTER n.a. n.a. Optical different Crystalline Size Distribution diffractometer /UN Panewishical XPENT n.a. n.a. Size distribution: Redestribution: Aerosol) Modal value X _M (PDI) nm Size XINT disper	Particle Code SilNP_		P_009	Manufacturer /Institute/Date	
Method of production Stöber-Synthesis Fremology Expent: Eugene watter Kind of suspension: Suspension Suspension Suspension Pure water n.d. Property unit Method / Institute Value Aggiomeration/aggregation HITEK (KT) Aggiomerated Crystallite size Phonalycical X Pen diffractometer //CN n.a. Crystallite size HRTEK (KT) n.a. Crystallite size HRTEM (KT) n.a. Crystallite size HRTEM (KT) n.a. Crystallite size HRTEM (KT) n.a. Photocatalytic activity cm3/g (BJH) Pore Size Distribution and Unorphous Photocatalytic activity cm3/g (BJH) Pore Size Distribution and Unorphous Size distribution: mg/ml ma n.a. Size distribution: mg/ml Size distribution: n.a. Size distribution: mg/ml mg/ml Size distribution: fi s (DL) (RWW / RNumAv) 43 40.7 Size distribution: mg/ml mg/ml Size distribution: fi s (DL) (RWW / RNumAv)				Eugene Mahon ; provided by UCI	D; 1 0/20 11
Kind of suspension: Suspension ⊠ Powder □ Suspended in pH pH n.d. pH n.d. none Property unit Method / Institute Value Aggiomeration/aggregation HRTEM (KT) Aggiomerated Crystalline phase D5000 Diffractometer /UU PANalyscial X Pert diffractometer /UU PANalyscial X Pert diffractometer /UU PANalyscial X Pert diffractometer /UN PANalyscial X Pert diffractometer /UN PANalysci Pert Panalyscial X Pert diffractometer /UN PANalysci Pert Panaly	Composition SiO ₂			Technology Expert: Eugene Mah	on
Kind of suspension: Suspended in pH stabilizer Pure water n.d. none Property unit Method / Institute Value Agalomeration/aggregation PA HRTEM (KIT) Agalomerated Crystalline phase In HRTEM (KIT) Amorbous Crystalline phase In HRTEM (KIT) Nacorbous Crystalline phase In HRTEM (KIT) Nacorbous Crystalline phase In HRTEM (KIT) Nacorbous Crystalline phase In Rhodamin-B BleachingUV-B-100 (10P/MS (ICN)) n.a. Created-water partition coefficient In Rhodamin-B BleachingUV-B-100 (10P/MS (ICN)) none Portosity -for % n.a. n.a. n.a. Pour density ord% (BLH) Pore Size Distribution and Volume by ASAP2020 (UU) n.a. Size distribution: water) Modal value X _{ic} (PDi) nm Size Size Distribution and Volume by ASAP2020 (UU) 10mg/ml Size distribution: water) Modal value X _{ic} (rgso) nm Size Size Distribution and Volume by ASAP2020 (UU) 10mg/ml Size distribution: water) Modal value X _{ic} (rgso) nm Size Size Distribut	Method of pro	duction Stöb	er-Synthesis		
Aggiomeration/aggregation INTEM (KIT) Aggiomerated Crystalline phase D5000 Diffractometer /UU PANalytical X Pert diffractometer /UU PANalytical X Pert diffractometer /UN PANalytical X Pert / 2000 (UU) n.a. Size distribution: water) Modal value X _M (PDI) nm mg/m³ or #/cm³ SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray 50 Solubility in	Kind of susp	ension:		Suspended in <u>Pure w</u> pH <u>n.d.</u>	
Crystalline phase D5000 Diffractometer /UU PANalytical X Pert diffractometer /UU PANalytical X Pert diffractometer /UU PANalytical X Pert diffractometer /CN Amorphous Crystallite size HRTEM (KIT) n.a. Dotanol-water partition coefficient Extraction / ICP-MS (ICN) n.a. Photocatalytic activity Rhodamine BleachingUV-B-100 10mg/ml in Water (ICN) none Portocatalytic activity -/- or % n.a. n.a. Portocatalytic activity -/- or % n.a. n.a. Portocatalytic activity main Rhodamine BleachingUV-B-100 10mg/ml in Water (ICN) n.a. Pour density cm3/g (BJH) Pore Size Distribution and Volume by ASAP2020 (UU) n.a. Size distribution: suspension in valer) Modal value X _W (PDI) nm Zetasizer Nano ZS /UCD 61.3 (PDI:0.093) NN: 43.7 Size distribution: Aerosol) Modal value X _W (rogo) mg/ml SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray 50 Solubility in g/l Extraction/ ICP-MS (ICN) 81.8 g/L Subulity in H_2O g/l Extraction/ ICP-MS (ICN) 81.8 g/L Subulity in H_2O g/l Extraction/ ICP-MS (ICN) 81.8 g/L Subulity in H_2O g/l Extraction/ ICP-MS (ICN) 81.8 g/L Surface chemistry EV Ze	Property		unit	Method / Institute	Value
PANalytical X Pert diffractometer /ICNPANalytical X:Pert diffractometer /ICNCrystallite sizeHRTEM (KIT)n.a.Convecting transmission coefficientExtraction / ICP-MS (ICN)n.a.Photocatalytic activityRhodamine Bleaching/UV-B-100nonePhotocatalytic activityrn a.Rhodamine Bleaching/UV-B-100nonePoor density-/- or %n.a.n.a.Poor densitycm3/g(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)n.a.Poor densitycm3/g(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)n.a.Size distribution: suspension in vater)Modal value X _M (PDI)nmZetasizer Nano ZS /UCD61.3 (PDI:0.093) NM: 43.7Size distribution: water)Modal value X _M (PDI)nmSMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray50Solubility ing/lExtraction / ICP-MS (ICN)81.8 g/LSolubility ing/lExtraction / ICP-MS (ICN)81.8 g/LSurface chemistryg/lExtraction / ICP-MS (ICN)81.8 g/LSurface chemistryeVZetasizer Nano ZS /UU difference6.6Surface chemistryg/lExtraction / ICP-MS (ICN)81.8 g/LSurface chemistryg/lExtraction / ICP-MS (ICN)81.8 g/LSurface chemistryeVZetasizer Nano ZS /UU difference6.6Surface chemistryg/lICP-MS (KIT)5.6Surface chemistryig/gICP-MS (KIT)5.6Nig/g <td>Agglomeration/aggr</td> <td>egation</td> <td></td> <td>HRTEM (KIT)</td> <td>Agglomerated</td>	Agglomeration/aggr	egation		HRTEM (KIT)	Agglomerated
Detanol-water partition coefficient Image: market partition coefficient Extraction/ ICP-MS (ICN) n.a. Photocatalytic activity -/- or % n.a. none Poorosity -/- or % n.a. n.a. Pour density cm3/g (BJH) Pore Size Distribution and (BJH) Pore Size	Crystalline phase				Amorphous
Photocatalytic activity Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN) none Porosity -f or % n.a. n.a. Poor density cm3/g (BJH) Pore Size Distribution and Volume by ASAP2020 (UU) n.a. Poor density mddal value X_M (PDI) nm Zetasizer Nano ZS /UCD 61.3 (PDI:0.093) NM: 43.7 Size distribution: suspension in water) Modal value X_M (PDI) nm Zetasizer Nano ZS /UCD 61.3 (PDI:0.093) NM: 43.7 Size distribution: water) Modal value X_M (PDI) nm Zetasizer Nano ZS /UCD 61.3 (PDI:0.093) NM: 43.7 Size distribution: water) Modal value X_M (Gpeo) nm SMPS TSI, DMA 3071 with CPC 3022 / KIT 50 Size distribution: Acrosol) Modal value X_M (Gpeo) nm SMPS TSI, DMA 3071 with CPC 3022 / KIT 50 Solubility in g/l Extraction / ICP-MS (ICN) 81.8 g/L Solubility in g/l Extraction / ICP-MS (ICN) 81.8 g/L Specific surface area cm²/g BET by ASAP2020 (UU) n.a. Surface chemistry eV Zetasizer Nano ZS /UU -51.7mV (PH 8.72) Summary of trace analyses </td <td>Crystallite size</td> <td></td> <td></td> <td>HRTEM (KIT)</td> <td>n.a.</td>	Crystallite size			HRTEM (KIT)	n.a.
number of the set of the se	Octanol-water partiti	on coefficient		Extraction/ ICP-MS (ICN)	n.a.
$ \begin{array}{c c c c c } \begin{tabular}{ c c } \hline \hline \begin{tabular}{ c c } \hline \hline \begin{tabular}{ c c } \hline $	Photocatalytic activi	ty		_	none
Pour density Volume by ASAP2020 (UU) Size distribution: isuspension in water) Modal value X _M (PDI) nm Zetasizer Nano ZS /UCD 61.3 (PDI:0.093) NM: 43.7 Size distribution: (Aversol) Total concentration mg/ml DCS (UCD) (RWtAv / RNumAv) 43/ 40.7 Size distribution: (Aversol) Modal value X _M (σ_{geo}) nm SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray 50 Solubility in Modal value X _M (σ_{geo}) nm SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray 50 Solubility in Modal value X _M (σ_{geo}) nm SMPS TSI, DMA 3071 with CPC 3022A / KIT 50 Solubility in Modal value X _M (σ_{geo}) nm SMPS TSI, DMA 3071 with CPC 3022A / KIT 50 Solubility in g/l Extraction/ ICP-MS (ICN) 81.8 g/L Solubility in H_2O g/l Extraction/ ICP-MS (ICN) 81.8 g/L Specific surface area cm²/g BET by ASAP2020 (UU) n.a. Surface chemistry g/l ICP-MS (KIT) 56 Saumary of trace analyses ICP-MS (KIT) 54 Na µg/g	Porosity		-/- or %	n.a.	n.a.
Size distribution: isuspension in water) Modal value X_{M} (PDI) nm CS (UCD) (RWtAv / RNumAv) 43/ 40.7 Total concentration mg/ml 1mg/ml Size distribution: Aerosol) Modal value X_{M} (σ_{geo}) nm $3022A / KIT$ dispersed by electrospray 4.9x 10 ⁴ /cm ³ Total concentration mg/cm ³ or #/cm ³ 4.9x 10 ⁴ /cm ³ Solubility in g/1 Extraction/ ICP-MS (ICN) 81.8 g/L Specific surface area cm ² /g BET by ASAP2020 (UU) n.a. Surface chemistry eV Zetasizer Nano ZS /UU -51.7mV (pH 8.72) Summary of trace analyses ICP-MS (KIT) -5.6 Na $\mu g/g$ 5.6 Na $\mu g/g$ 6.2 Summary of trace analyses 1CP-MS (KIT) -5.7mV (pH 8.72) Summary of trace analyses 1.2 Summary of trace analyse	Pour density		cm3/g		n.a.
valer)Total concentrationmg/ml1mg/mlSize distribution: (Aerosol)Modal value X _M (σ_{geo})nmSMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray50Total concentrationmg/cm³ or #/cm³4.9x 10 st /cm³Solubility ing/lExtraction/ ICP-MS (ICN)81.8 g/LSolubility in H_2Og/lExtraction/ ICP-MS (ICN)81.8 g/LSolubility in H_2Og/lExtraction/ ICP-MS (ICN)81.8 g/LSolubility in Generative areacm²/gBET by ASAP2020 (UU)n.a.Surface chemistryeVZetasizer Nano ZS /UUch1.7mV (pH 8.72)Summary of trace analysesICP-MS (KIT)5.6Naµg/g1.95.4Naµg/g1.93.2Alµg/g1.91.9Alµg/g1.41.9Caµg/g3.31.2Caµg/g3.33.3Cuµg/g1.2.52.8	Size distribution:	Modal value X_M (PDI)	nm	Zetasizer Nano ZS /UCD	
Total concentrationmg/ml1mg/mlSize distribution: (Aerosol)Modal value X_M (σ_{geo})nmSMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray50Total concentrationmg/cm³ or #/cm³4.9x 10*/cm³Total concentrationmg/cm³ or #/cm³4.9x 10*/cm³Solubility ing/lExtraction / ICP-MS (ICN)81.8 g/LSolubility in M_2Og/lExtraction / ICP-MS (ICN)81.8 g/LSolubility in M_2Og/lExtraction / ICP-MS (ICN)81.8 g/LSurface chemistryg/lExtraction / ICP-MS (ICN)81.8 g/LSurface chemistryeVZetasizer Nano ZS /UU-51.7mV (pH 8.72)Summary of trace analysesICP-MS (KIT)5.6Naµg/g5.654Naµg/g1.93.2Alµg/g1.93.2Caµg/g1.23.3Cuµg/g3.314Feµg/g3.312.5Znµg/g3.33.3Cuµg/g1.2.52.8	(suspension in			DCS (UCD) (RWtAv / RNumAv)	43/ 40.7
$\begin{array}{c c c c c c c } \begin{tabular}{ c c c c } \begin{tabular}{ c c c c c } \begin{tabular}{ c c c c c c c } \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	water)	Total concentration	mg/ml		1mg/ml
$\begin{array}{ c c c c c } \begin{tabular}{ c c c c } \begin{tabular}{ c c c c c } \begin{tabular}{ c c c c c } \begin{tabular}{ c c c c c c c } \begin{tabular}{ c c c c c c c } \begin{tabular}{ c c c c c c c } \begin{tabular}{ c c c c c c c } \begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	Size distribution:				50
Total concentrationIngremon witcheSolubility ing/lExtraction/ ICP-MS (ICN)81.8 g/LSolubility in H2Og/lExtraction/ ICP-MS (ICN)81.8 g/LSpecific surface areacm²/gBET by ASAP2020 (UU)n.a.Surface chemistryZeta potential (surface charge)eVZetasizer Nano ZS /UU-51.7mV (pH 8.72)Summary of trace analysesICP-MS (KIT)-3µg/g5.6Naµg/g54Mgµg/g3.2Alµg/g12Caµg/g14"eµg/g3.3Cuµg/g3.3Cuµg/g12.5Znµg/g3.3	(Aerosol)	Modal value X_{M} (σ_{geo})	nm		
Solubility in H2Og/lExtraction/ ICP-MS (ICN)81.8 g/LSpecific surface areacm²/gBET by ASAP2020 (UU)n.a.Surface chemistryZeta potential (surface charge)eVZetasizer Nano ZS /UU-51.7mV (pH 8.72)Surmary of trace analysesICP-MS (KIT)3µg/g5.6Naµg/g54Mgµg/g1.9AIµg/g3.2Caµg/g12Caµg/g14Feµg/g3.3Cuµg/g2.8		Total concentration	mg/cm ³ or #/cm ³		4.9x 10 ⁴ /cm ³
Specific surface areacm²/gBET by ASAP2020 (UU)n.a.Surface chemistry </td <td>Solubility in</td> <td></td> <td>g/l</td> <td></td> <td></td>	Solubility in		g/l		
Surface chemistryeVZetasizer Nano ZS /UU-51.7mV (pH 8.72)Zeta potential (surface charge)eVZetasizer Nano ZS /UU-51.7mV (pH 8.72)Summary of trace analysesICP-MS (KIT)5.63µg/g5.6Naµg/g54Mgµg/g1.9Alµg/g3.2Kµg/g12Caµg/g14Feµg/g3.3Cuµg/g2.8	Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	81.8 g/L
Zeta potential (surface charge)eVZetasizer Nano ZS /UU-51.7mV (pH 8.72)Summary of trace analysesICP-MS (KIT)-56Bµg/g5.654Naµg/g541.9Alµg/g3.23.2Kµg/g1212Caµg/g143.3Cuµg/g3.32.5Zuµg/g2.53.3Cuµg/g2.83.4	Specific surface are	a	cm²/g	BET by ASAP2020 (UU)	n.a.
ICP-MS (KIT) (pH 8.72) Summary of trace analyses μg/g 5.6 A μg/g 54 Na μg/g 1.9 AI μg/g 3.2 Ca μg/g 12 Ee μg/g 14 Cu μg/g 3.3 Cu μg/g 2.8	Surface chemistry				
B µg/g 5.6 Na µg/g 54 Mg µg/g 1.9 AI µg/g 3.2 K µg/g 12 Ca µg/g 14 Fe µg/g 3.3 Cu µg/g 12.5 Zn µg/g 12.8	Zeta potential (surfa	ce charge)	eV	Zetasizer Nano ZS /UU	
Na µg/g 54 Mg µg/g 1.9 Al µg/g 3.2 K µg/g 12 Ca µg/g 14 =e µg/g 3.3 Cu µg/g 12.5 Zn µg/g 2.8	Summary of trace a	nalyses		ICP-MS (KIT)	
Mg µg/g 1.9 AI µg/g 3.2 K µg/g 12 Ca µg/g 14 Fe µg/g 3.3 Cu µg/g 12.5 Zn µg/g 2.8	В		hð\ð		5.6
AI µg/g 3.2 K µg/g 12 Ca µg/g 14 =e µg/g 3.3 Cu µg/g 12.5 Zn µg/g 2.8	Na		hð\ð		54
x µg/g 12 Ca µg/g 14 Fe µg/g 3.3 Cu µg/g 12.5 Zn µg/g 2.8	Mg		hð\ð		
Image: Note Image: Note Ca µg/g 14 =e µg/g 3.3 Cu µg/g 12.5 Zn µg/g 2.8	Al				
Fe µg/g 3.3 Cu µg/g 12.5 Zn µg/g 2.8	К		hð\ð		
μg/g 12.5 Zn μg/g 2.8	Са		hð\ð		
Zn μg/g 2.8	Fe		hð\ð		
	Cu				
Ba μg/g 2.6	Zn		hð\ð		2.8
	Ва		hð\ð		2.6



Na	ENTATIVE TEST I nomaterial Identific according to OECI M/MONO(2009)20/F	ation D	Research Infrastructure	Vano
Nanomaterial	name Silic	a-NP		
Particle Code	SilN	P_010	Manufacturer /Institute/Date	
			_ Eugene Mahon ; provided by UCE); 10/2011
Composition	SiO ₂	-	Technology Expert: Eugene	Vlahon
Method of pro	duction Stoc	er-Synthesis	Suspension 🛛 Powde	,
Kind of susp	ension:		Suspended in Pure wa pH n.d. stabilizer none	
Property		unit	Method / Institute	Value
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partiti	on coefficient		Extraction/ ICP-MS (ICN)	n.a.
Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	n.a.
Size distribution:	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD	40.1 (PDI:0.174) NM: 20.7
(suspension in water)			DCS (UCD) (RWtAv / RNumAv)	26.4/25.0
,	Total concentration	mg/ml		1mg/ml
Size distribution: (Aerosol)	Modal value X_{M} (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	33 (σ _{geo} =1.00)
	Total concentration	mg/cm ³ or #/cm ³		2.2x 10 ⁵ /cm ³
Solubility in		g/l		
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	117.4 g/L
Specific surface area	3	cm²/g	BET by ASAP2020 (UU)	n.a.
Surface chemistry				
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-39.9mV (pH 7.69)
Summary of trace ar	nalyses		ICP-MS (KIT)	
В		hð\ð		5.6
Na		hð\ð		47
Mg		hð\ð		2
AI		µg/g		2.
К		hð\ð		12
Са		hð\ð		15
Fe		hð\ð		1.7
Cu		hð\d		11.1



Supplemental S3: Physicochemical characterization data sheets of silica NMs from flame synthesis

Na	NTATIVE TEST P/ nomaterial Identificat according to OECD I/MONO(2009)20/RE	ion	Research Infrastructure	Nano
Nanomaterial nameAerosiParticle CodeSilNP_			Manufacturer /Institute: DEGUSSA, provided by KIT – ITC	
Composition Method of proc	SiO ₂ duction Flame	synthesis	Name: Sonja Mülhopt	
Kind of susp	Kind of suspension:		Suspension Powde Suspended in pH stabilizer	r 🛛
Property		unit	Method (Institute)	Value
Agglomeration/agg	regation		HRTEM (KIT)	aggregated
Crystalline phase	Crystalline phase		D5000 (UU) PANalytical X'Pert diffractometer	amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water part	ition coefficient		Extraction/ ICP-MS (ICN)	P _{OW} =0
Photocatalytic activ	Photocatalytic activity		Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	80% / 2 min
Porosity		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	0.43
Pour density		g/l		
Redox potential				
Size distribution (suspension in	Modal value X _M (PDI)	nm	Zetasizer Nano ZS (UCD) (after 1h sonification)	142.7 (PDI=0.145)
water)	Total concentration	mg/ml		0.1 mg/ml
Size distribution (aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A (KIT) dispersed by rotating brush generator	127 (σ _{geo} =1.4)
	Total concentration			2.0 x 10 ⁴ / cm ³
Solubility in		g/l		
Solubility in H ₂ O	Solubility in H ₂ O		Extraction/ ICP-MS (ICN)	23.7±1.7
Specific surface ar	Specific surface area		BET by ASAP2020 (UU)	196
Surface chemistry				
Zeta potential (surf	ace charge)		Zetasizer Nano ZS (UU)	-22.8±0.8eV (pH 5.00)

Summary of trace analyses		ICP-MS (KIT)	
Ni	µg/g		0.1
Cu	µg/g		0.2
Electron microscopy Method / technical data of microscope: See KIT-LEM Magnification:	Electron Microsco	reference of the second	WILL Strategy WILL Strategy WILL Strategy
Radical formation potential by DCF-Test: (H_2O_2 as positive control) (KIT)	measurements us	ze looks to around 20 nm from 1 ing ImageJ.	0 distance
	Result: SilNP_001	50 100 200 400 400 cle concentration [µg/ml] - HRP NPs induced a very low increase ating a negligible potential to produc	
Comments and other relevant physical-cl			
Place, Date Karlsruhe, 29.11.2	016	Responsible HR.	Paur, KIT

Na	ENTATIVE TEST F nomaterial Identifica according to OECI //MONO(2009)20/R	ation)	Research Infrastructure	Vano
Nanomaterial	name Silica	a-NP	Manufacturer /Institute/Date	
Particle Code	SilNF	P_012	Christopher Anderlohr ; provided	by KIT; 10/2011
Composition	SiO ₂		Technology Expert: DiplIng. Chri	stopher Anderlohr
Method of pro	duction Flam	e-Synthesis		
Kind of susp	ension:		Suspension Powde Suspended in	r ⊠
Property		unit	Method / Institute	Value
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partiti	on coefficient		Extraction/ ICP-MS (ICN)	P _{ow} =0
Photocatalytic activit	y		Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	non-porous
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	0.14
Size distribution:	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD	214.2 (PDI:0.215)/ NM: 125.2
(suspension in water)			DCS (UCD) (RWtAv / RNumAv)	n.a.
,	Total concentration	mg/ml		1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI. DMA 3071 with CPC 3022A / KIT dispersed by electrospray	160 (σ _{geo} =1.59)
	Total concentration	mg/cm ³ or #/cm ³		n.a.
Solubility in		g/l		
Solubility in H_2O after 30 days		mg/ml	Extraction/ ICP-MS (ICN)	6
Specific surface area	a	cm²/g	BET by ASAP2020 (UU)	72.3
Surface chemistry				
Zeta potential (surfa	ce charge)	eV	Zetasizer Nano ZS /UU	-16.2 ± 5.8mV (pH 4.58)

Summary of trace analyses		MS / KIT
Na	µg/g	6.6
Mg	hā\à	1.9
Al	hð\ð	22.6
К	hð\ð	6.6
Са	hð\ð	20.3
Ti	hð\ð	0.7
Cr	hð\ð	< 1
Mn	hð\ð	0.20
Fe	hð\ð	12.4
Ni	hð\ð	<0.5
Cu	hð\ð	0.26
Zn	hâ\à	1.6
Pb	hð\ð	0.13
Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000		
FEI Tecna i 120 SOP: see UCD	Electron Microscopy by KIT	(LEM); Diameter : 10-60 nm
UNIVLEEDS TEM/ SEM-EDX	Av. Diameter (ImageJ) ~49 SilNP 0012 Av. Diameter =	
Padical formation potential by DCE Test		
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	The second secon	1000 0.2 44
Comments and other relevant physica	Result: SiINP_012 NPs indu from 12.5 and 400 µg/ml.	uced a weak increase of DCFH oxidation at concentration
Place, Date Karlsruhe, 29.11	.2016	Responsible HR. Paur. KIT

Na	ENTATIVE TEST F Inomaterial Identifica according to OECI M/MONO(2009)20/R	ation D	Research Infrastructure	Vano
Nanomaterial	name Silica	a-NP	Manufacturer /Institute/Date	
Particle Code	SilNF	P_013	Christopher Anderlohr ; provided	by KIT; 10/2011
Composition	SiO ₂		Technology Expert: DiplIng. Chris	stopher Anderlohr
Method of pro	duction Flam	e-Synthesis		
Kind of susp	ension:		Suspension Powder Suspended in	r 🛛
Property		unit	Method / Institute	Value
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partiti	on coefficient		Extraction/ ICP-MS (ICN)	P _{ow} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	non-porous
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	0.13
Size distribution:	Modal value X_M (PDI)	nm	Zetasizer Nano ZS /UCD	187.2 (PDI:0.18)/ NM: 122.8
(suspension in water)			DCS (UCD) (RWtAv / RNumAv)	n.a.
inator)	Total concentration	mg/ml		1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	166 (σ _{geo} =1.55)
	Total concentration	mg/cm ³ or #/cm ³		n.a.
Solubility in		g/l		
Solubility in H ₂ O after 30 days		mg/ml	Extraction/ ICP-MS (ICN)	8.75
Specific surface area		cm²/g	BET by ASAP2020 (UU)	77.5
Surface chemistry				
Zeta potential (surfa	ce charge)	eV	Zetasizer Nano ZS /UU	-16.2 ± 7.4mV (pH 4.53)

Summary of trace analyses	ICP-MS / KIT	
Na	hð\ð	8.5
Mg	hâ\a	1.3
AI	hâ\a	3.2
К	hā\ā	6.0
Са	hð\ð	6.2
Mn	hð\ð	0.15
Fe	hð\ð	8.3
Cu	hð\ð	0.26
Zn	hð\ð	1.1
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000		
FEI Tecna i 120 SOP: see UCD	Electron Microscopy by KIT (LEM); D Electron Microscopy by UCD Electron Microscopy by UCD Av. Diameter (ImageJ) ≈ 38nm (Std.	
UNIVLEEDS TEM/ SEM-EDX	SilNP 0013 Av. Diameter =56.83 nm	Do Do Do Do Do Do Do Do Do Do
Radical formation potential by DCF-Test:		
$(H_2O_2 \text{ as positive control})$ (KIT)	10 9 9 10 9 10 10 10 10 10 10 10 10 10 10	USINP_013
Comments and other relevant physi		ak increase of DCFH oxidation at concentration
	· · · · · · · · · · · · · · · · · · ·	
Place, Date Karlsruhe, 29.	1.2016 Respo	nsible HR. Paur, KIT

Na	anomaterial Identi according to OE //MONO(2009)20	fication CD	Research Infrastructure	Nano
Nanomaterial	name Si	lica-NP	Manufacturer /Institute/Date	
Particle Code	Si	NP_014	Christopher Anderlohr ; provide	ed by KIT; 10/2011
Composition Method of pro		O ₂ ame-Synthesis	Technology Expert: DiplIng. Cl	nristopher Anderlohr
Kind of susp		,	Suspension Power Suspended in	
Property		unit	Method / Institute	Value
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partiti	on coefficient		Extraction/ ICP-MS (ICN)	P _{ow} =0
Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	non-porous
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	0.13
Size distribution: Modal value X_M (PDI) (suspension in water)		I) nm	Zetasizer Nano ZS /UCD	H ₂ O: 217.9 (PDI:0.275)/ NM: 113.1 HNO ₃ : 1667 (PDI:0.641)/ NM: 825.6 NaOH: 344.4 (PDI:0.434)/ NM: 114.1
			DCS (UCD) (RWtAv / RNumAv)	n.a.
	Total concentration	mg/ml		1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{ge}	_{>}) nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	32.5 (σ _{geo} =1.27)
	Total concentration	mg/cm ³ or #/cm ³		1.6x 10⁵
Solubility in	-1	g/l		
Solubility in H ₂ O after 30 days		mg/ml	Extraction/ ICP-MS (ICN)	6.5
Specific surface area	a	cm²/g	BET by ASAP2020 (UU)	76.1
Surface chemistry				
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-15.5 ± 6.9mV (pH 4.39)

Summary of trace analyses	ICP-MS / KIT	г
Na	hâ\â	4.5
Mg	hā\ā	0.5
AI	hā\ā	1.0
Ca	hð\ð	6.2
Mn	hð\ð	<0.05
Fe	hð\ð	8.5
Ni	hð\ð	<0.5
Cu	µg/g	0.15
Zn	µg/g	0.6
Pb	µg/g	<0.05
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000		1 1
FEI Tecna i 120 SOP: see UCD	Electron Microscopy by KIT (LEM);	Diameter : 10-80 nm
UNIVLEEDS TEM/ SEM-EDX	Electron Microscopy by UCD Av. Diameter (ImageJ) = 40.6nm	A) Spectrum 8
	100 nm	
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	10 9 8 7 7 9 6 5 4 1 0 0 12.5 25 50 100 200 400 Particle concentration [µg/m]	Image: SilNP_014 Image: Si
Comments and other relevant physica	Result: SilNP_014 NPs induced a we from 12.5 and 400 µg/ml.	eak increase of DCFH oxidation at concentration
Place, Date Karlsruhe, 29.11	.2016 Resp	onsible HR. Paur, KIT

Na	NTATIVE TEST nomaterial Identific according to OEC I/MONO(2009)20/F	ation D	uality	Vano
Nanomaterial r	name Silic	a-NP	Manufacturer /Institute/Date	
Particle Code	SilN	P_015	Christopher Anderlohr ; provided	by KIT; 10/2011
Composition Method of proc	SiO SiO	2 ne-Synthesis	Technology Expert: DiplIng. Chris	stopher Anderlohr
Kind of suspension:			Suspension Powder Suspended in pH stabilizer none	
Property		unit	Method / Institute	Value
Agglomeration/aggre	gation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partition	on coefficient		Extraction/ ICP-MS (ICN)	P _{ow} =0
Photocatalytic activity	/		Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	non-porous
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	0.06
Size distribution: (suspension in water)	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD	H ₂ O: 434.1 (PDI: 0.293)/ NM: 98.2 HNO ₃ : 1283 (PDI: 0.425)/ NM: 955.75 NaOH: 384.9 (PDI: 0.261)/ NM: 318.9
			DCS (UCD) (RWtAv / RNumAv)	n.a.
	Total concentration	mg/ml		1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	36.3 (σ _{geo} =1.21)
	Total concentration	mg/cm ³ or #/cm ³		1.2x 10 ⁴
Solubility in	1	g/l		
Solubility in H ₂ O after 30 days		mg/ml	Extraction/ ICP-MS (ICN)	7
Specific surface area		cm²/g	BET by ASAP2020 (UU)	29.4
Surface chemistry				
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-19.0 ± 7.7mV (pH 4.34)

Summary of trace analyses	IC	P-MS / KIT
Li	hð\ð	<0.1
Na	hð\ð	4.3
Mg	hð\ð	3.4
Al	hð\ð	12
Са	hð\ð	7.8
Mn	hð\ð	0.25
Fe	hð\ð	6.7
Ni	hð\ð	0.7
Cu	hð\ð	0.49
Zn	hð\ð	1.7
Pb	hð\ð	<0.1
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microscopy by K	KIT (LEM); Diameter : 15-150 nm
UNIVLEEDS TEM/ SEM-EDX	200 m	13- 14 15 pectrum 6 15 pect
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)		SIINP_015
Comments and other relevant physical	Result: SiINP_015 NPs in from 12.5 and 400 µg/ml.	nduced a weak increase of DCFH oxidation at concentration
Place, Date Karlsruhe, 29.11	.2016	Responsible HR. Paur, KIT

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			Research Infrastructure	Vano	
Nanomaterial r	name Silica-	NP	Manufacturer /Institute/Date		
Particle Code	SilNP	_016			
			Christopher Anderlohr ; provided	by KII; 10/2011	
Composition	Composition SiO ₂		Technology Expert: Christopher A	nderlohr	
Method of proc	_	-Synthesis			
		Cynanoolo	Suspension Powde	r 🛛	
Kind of suspension:			Suspended in pH stabilizer <u>none_</u>		
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglomerated	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X´Pert diffractometer (ICN)	Amorphous	
Crystallite size			HRTEM (KIT)	n.a.	
Octanol-water partition	n coefficient		Extraction/ ICP-MS (ICN)	P _{ow} =0	
Photocatalytic activity	tocatalytic activity		Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none	
Porosity		-/- or %	n.a.	non-porous	
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	0.07	
Size distribution: (suspension in water)	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD DCS (UCD) (RWtAv / RNumAv)	H ₂ O: 253.3 (PDI: 0.276)/ NM: 160.15 HNO ₃ : 1486 (PDI: 0.498)/ NM: 893.95 NaOH: 151 (PDI: 0.348)/ NM: 31.68 n.a.	
	Total concentration	mg/ml		1mg/ml	
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	37.7 (σ _{geo} =1.26)	
	Total concentration	mg/cm ³ or #/cm ³		n.a.	
Solubility in	1	g/l			
Solubility in H ₂ O afte	r 30 days	mg/ml	Extraction/ ICP-MS (ICN)	9.5	
Specific surface area		cm²/g	BET by ASAP2020 (UU)	31.1	
Surface chemistry					
Zeta potential (surfac	e charge)	eV	Zetasizer Nano ZS /UU	-18.1 ± 5.6mV (pH 4.29)	

Summary of trace analyses		ICP-MS / KIT	
Li	µg∕g		<0.1
Na	hð\ð		6.0
Mg	µg/g		2.0
AI	µg/g		2.8
К	µg/g		<2
Са	µg/g		7.4
Mn	hð\ð		<0.05
Fe	hð\ð		4.8
Ni	hð\ð		0.6
Cu	hð\ð		0.49
Zn	hð\ð		1.3
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microso	copy by KIT (LEM); Diameter : 24	0-120 nm
UNIVLEEDS TEM/ SEM-EDX	100 nm		A Spectrum 4
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	0 10 0 10 0 10 0 12 0 12		SIINP_016
Comments and other relevant physica	Result: SilNP_0 from 12.5 and 4	00 μg/ml.	of DCFH oxidation at concentrations
Place, Date Karlsruhe, 29.11	1.2016	Responsible	HR. Paur, KIT

Na	NTATIVE TEST nomaterial Identific according to OEC MONO(2009)20/	cation D	esearch Infrastructure	Vano	
Nanomaterial	Nanomaterial name Silica-NP		Manufacturer /Institute/Date		
Particle Code	SilN	IP_017	Christopher Anderlohr ; provided	by KIT; 10/2011	
Composition Method of prod	SiO duction Flar	² ne-Synthesis	Technology Expert: Christopher	Anderlohr	
Kind of suspension:			Suspension Powder Suspended in pH pH		
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglomerated	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous	
Crystallite size			HRTEM (KIT)	n.a.	
Octanol-water partition coefficient			Extraction/ ICP-MS (ICN)	P _{ow} =0	
Photocatalytic activity			Rhodamin-B Bleaching/UV-B-100 10mg/ml in Water (ICN)	none	
Porosity		-/- or %	n.a.	non-porous	
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	0.07	
Size distribution: (suspension in water)	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD	H ₂ O: 263 (PDI:0.319)/ NM: 191.26 HNO ₃ : 1293 (PDI:0.473)/ NM: 818.26 NaOH: 147.1 (PDI:0.330)/ NM: 34.52	
			DCS (UCD) (RWtAv / RNumAv)	n.a.	
	Total concentration	mg/ml		1mg/ml	
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	36.3 (σ _{geo} =1.31)	
	Total concentration	mg/cm ³ or #/cm ³		n.a.	
Solubility in	1	g/l			
Solubility in H ₂ O afte	r 30 days	mg/ml	Extraction/ ICP-MS (ICN)	1.8	
Specific surface area	l	cm²/g	BET by ASAP2020 (UU)	38.8	
Surface chemistry					
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU	-18.3 ± 6.0mV (pH 4.22)	

Summary of trace analyses		ICP-MS / KIT	
Li	µg/g		<0.1
Na	µg/g		5.3
Mg	µg/g		2.1
AI	µg/g		15.3
К	µg/g		<2
Са	µg/g		9.2
Mn	µg/g		0.12
Fe	µg/g		7.1
Ni	µg/g		<0.5
Cu	µg/g		0.28
Zn	µg/g		2.5
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microscopy b	by KIT (LEM); Diameter : 20-	-120 nm
UNILEEDS TEM/ SEM-EDX	100 nm		2 3 4 keV
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	10 9 9 8 8 4 5 4 9 5 4 9 0 2 4 1 0 0 12,5 25 Particle	T T T T T T T T T T T T T T T T T T T	SIINP_017
Comments and other relevant physica	Result: SilNP_017 NF indicating a potential t	Ps induced a significant DCF o produce reactive oxygen s	
Place, Date Karlsruhe, 29.1	1.2016	Responsible H	IR. Paur, KIT

Supplemental S4: Physicochemical characterization data sheets of zinc oxide NMs

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.		Research Infra	structure	Nano	
Nanomaterial r	name	ZnO NPs B1-1			
	Particle Code ZnO_NP001		Manufacturer /Institute/	Date	
			Yunhong Jiang; provid	ed by Univ	/leeds; 03/2012
Composition	Composition ZnO		Technology Expert: Yu	nhong liar	na
Method of proc	duction	B2B Synthesis		interig etai	'9
			Suspension] Powde	er 🛛
Kind of susp	Kind of suspension:		Suspended in pH stabilizer	none	
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	crystalline	e
Crystalline phase	-		D5000 Diffractometer (UU)	Amorpho	ous
			PANalytical X'Pert diffractometer (ICN)		
Crystallite size			HRTEM (KIT)		
Octanol-water partition	on coefficient		Extraction/ ICP-MS (ICN)	Extraction/ ICP-MS (ICN)	
Photocatalytic activity	/		Rhodamin-B Bleaching/UV- 10mg/ml in Water (ICN)	B-100	high
Porosity		-/- or %	n.a.		
Pour density		cm3/g	(BJH) Pore Size Distribution Volume by ASAP2020 (UU		n.a.
Size distribution: (suspension in	Modal value X_M (I	nm (IQc	Zetasizer Nano ZS /UCD DCS (UCD) (RWtAv / RNum	NAV)	656 (PDI:0.336)/ NM: 426.3 n.a.
water)	Total concentration	n mg/ml			1mg/ml
Size distribution:			SMPS TSI, DMA 3071 with	CPC	n.a.
(Aerosol)	Modal value X_{M} (o	σ _{geo}) nm	3022A / KIT dispersed by electrospray		
Solubility in		g/l			
Solubility in H ₂ O afte	Solubility in H ₂ O after 30 days		Extraction/ ICP-MS (ICN)		7
Specific surface area	l	cm²/g	BET by ASAP2020 (UU)		n.a.
Surface chemistry					
Zeta potential (surfac	e charge)	eV	Zetasizer Nano ZS /UU	Zetasizer Nano ZS /UU -	

Summary of trace analyses		ICP-MS (KIT)	Assay1	Assay2
Na	hð\ð		7.0	6.4
Mg	hð\ð		2.5	<2.0
Al	hð\ð		3.6	2.9
Ca	hð\ð		7.2	6.0
Fe	µg/g		7.7	8.0
Ni	μg/g		1.7	1.9
Cu	μg/g		1.8	1.9
Sr	μg/g		22.0	23.3
Cd	μg/g		3.5	3.7
Ва	μg/g		0.1	0.1
ТІ	μg/g		1.5	1.5
Pb	hð\ð		11.4	11.3
Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microsco	by by KIT (LEM); Diameter : 30-	200 nm	
UNIVLEEDS TEM/ TEM-EDX	ZnO NPs B1-1	20 0 0 0 0 0 0 0 0 0 0 0 0 0		2n0 81
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	14 12 12 12 10 0 0 0 0 0 0 Pa	$\begin{bmatrix} x \\ x \\ y \\ z \\ z$	□ZnO_NP001	
Comments and other relevant physical	concentrations fro	2001 induced a moderate in om 25 to 400 μg/ml. es and material characteriz		dation a
Place, Date Karlsruhe, 29.11	.2016	Responsible H	R. Paur, KIT	

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.		Research Infrast	tyl	Nano	
Nanomaterial	name Z	nO NPs B 1-2	Manufacturer /Institute/D	ate	
Particle Code	Particle Code ZnO_NP002		Yunhong Jiang; provide		leeds: 03/2012
				-	
Composition		nO OB Cumtheorie	Technology Expert: Yunh	iong Jian	g
Method of proc	buction B	2B Synthesis	Suspension	Powde	r 🛛
Kind of susp	Kind of suspension:		Suspended in pH stabilizer	none	
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	crystalli	ne
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorp	hous
Crystallite size			HRTEM (KIT)		
Octanol-water partition	on coefficient		Extraction/ ICP-MS (ICN)		P _{OW} =0
Photocatalytic activit	y		Rhodamin-B Bleaching/UV-B- 10mg/ml in Water (ICN)	100	high
Porosity		-/- or %	n.a.		
Pour density		cm3/g	(BJH) Pore Size Distribution Volume by ASAP2020 (UU)	and	
Size distribution:	Modal value X_M (PI	DI) nm	Zetasizer Nano ZS /UCD UNIVLEEDS		321,9 (PDI:0,293)/ NM: 181,5 179,5 (PDI:0,502)
(suspension in water)			DCS (UCD) (RWtAv / RNumA	v)	
	Total concentration	mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_g	_{eo}) nm	SMPS TSI, DMA 3071 with C 3022A / KIT dispersed by electrospray	PC	
Solubility in	•	g/l			
Solubility in H ₂ O after	er 30 days	mg/ml	Extraction/ ICP-MS (ICN)		4.5
Specific surface area	1	cm²/g	BET by ASAP2020 (UU)		
Surface chemistry					
Zeta potential (surfac	ce charge)	eV	Zetasizer Nano ZS /UU		-10.0 ± 1.6 mV pH: 5.89

Summary of trace analyses		ICP-MS (KIT)	Assay1	Assay2
Na	µg/g		55.1	27.6
Mg	µg∕g			2.6
AI	µg/g		5.4	7.6
Са	µg/g		14.3	14.0
Fe	µg/g		11.4	11.6
Ni	µg/g		2.9	2.4
Cu	µg/g		2.1	2.4
Sr	µg∕g		27.4	26.6
Cd	µg∕g		4.3	
Ва	µg∕g		0.2	0.2
ТІ	µg/g		2.9	2.8
Pb	µg∕g		16.7	15.7
Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Micro	scopy by KIT (LEM); Diameter : 30-200	D nm	
UNIVLEEDS	Boo nm		nO NPs B 1-2	
Radical formation potential by DCF-Test:	14			
(H ₂ O ₂ as positive control) (KIT)	DCF fluorescence [fold Increase]	25 50 100 200 400	□ ZnO_NP002	H2O2
		Particle concentration [µg/ml]	- HRP	0.3 µM
	Result: ZnO_ concentrations	NP002 induced a moderate incre from 25 to 400 µg/ml.	ease of DCFH oxi	dation a
Comments and other relevant physic	al-chemical prope	rties and material characterizati	on information	

Na	NTATIVE TEST P nomaterial Identifica according to OECD I/MONO(2009)20/RI	ition	Qual	ity	Nano
Nanomaterial r	name ZnO	NPs B 1-3			
Particle Code	ZnO_	NP003	Manufacturer /Institut	e/Date	
			Yunhong Jiang; provi	ded by Uni	vleeds; 03/2012
Composition Method of proc	ZnO	Synthesis	Technology Expert: Y	unhong Jiar	ng
		Synthesis	Suspension	Powde	er 🖂
Kind of susp	ension:		Suspended in pH stabilizer		
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	crystalline	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X´Pert diffractometer (ICN)	$\begin{array}{c} 400000\\ 320000\\ gg \\ 10000\\ gg \\ 1000\\ gg \\ gg \\ 0\\ 20\\ 30\\ 30\\ 20\\ 30\\ 30\\ 30\\ 30\\ 30\\ 30\\ 30\\ 30\\ 30\\ 3$	
Crystallite size	tallite size		HRTEM (KIT)		
Octanol-water partition	on coefficient		Extraction/ ICP-MS (ICN)		P _{ow} =0
Photocatalytic activity	Photocatalytic activity		Rhodamin-B Bleaching/UV-B-100high10mg/ml in Water (ICN)		high
Porosity		-/- or %	n.a.		
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)		
			Zetasizer Nano ZS /UCD		203,8 (PDI:0,208)/ NM: 159,8
Size distribution: (suspension in	Modal value X_M (PDI)	nm	UNIVLEEDS		160,1(PDI:0,564)
water)			DCS (UCD) (RWtAv / RNu	umAv)	
	Total concentration	mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X _M (σ _{geo})	nm	SMPS TSI, DMA 3071 wit CPC 3022A / KIT dispersed by electrospray		
Solubility in	1	g/l			
Solubility in H ₂ O afte	r 30 days	mg/ml	Extraction/ ICP-MS (ICN)		Ca. 7.4
Specific surface area		cm²/g	BET by ASAP2020 (UU)		
Surface chemistry					
Zeta potential (surfac	e charge)	eV	Zetasizer Nano ZS /UU		-15.6 ± 2.3 mV pH: 5.97

Summary of trace analyses	ICP-MS / KIT	Assay1	Assay2
Na	hð\ð	74.7	80.1
Mg	hð\ð	21.4	20.8
AI	hð\ð	5.0	6.6
К	hð\ð	10.4	11.4
Са	hð\ð	135.5	137
Ті	hð\d	0.2	0.1
Mn	hð\ð	0.3	<0.2
Fe	hð\ð	25.9	8.3
Ni	hð\ð	2.5	0.5
Cu	hð\ð	3.6	3.8
Sr	hð\ð	60.4	61.2
Cd	hð\d	5.5	5.6
Ва	hð\ð	0.2	0.2
ТІ	hâ\â	3.4	3.6
Pb	hâ\â	18.7	19.7
SOP: See KIT (LEM) Magnification: 450.000	Electron Microscopy by KIT (LEM); Diam	eter : 30-200 nm	
UNIVLEEDS	200 nm	ZnO NPs B 1-3	
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	Result: ZnO_NP003 induced a mod	-	М
	concentrations from 25 to 400 µg/ml.		

Na	NTATIVE TEST F nomaterial Identifica according to OECE /MONO(2009)20/R	ation)	ua Research II	frastructure	Nano
Nanomaterial r	name ZnO	NPs B 2-1			
Particle Code	ZnO_	_NP004	Manufacturer /Institu	ute/Date	
			Yunhong Jiang; pro	vided by Univ	/leeds; 03/2012
Composition Method of proc	ZnO luction B2B	Synthesis	Technology Expert:	Yunhong Jiar	ng
			Suspension	Powde	r 🛛
Kind of susp	ension:		Suspended in pH stabilizer	none	
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	crystalline	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous	20 (10)
Crystallite size			HRTEM (KIT)		
Octanol-water partition	n coefficient		Extraction/ ICP-MS (ICN	Extraction/ ICP-MS (ICN)	
Photocatalytic activity	Photocatalytic activity		Rhodamin-B Bleaching/ 10mg/ml in Water (ICN)	UV-B-100	high
Porosity		-/- or %	n.a.		
Pour density		cm3/g	(BJH) Pore Size Distribu Volume by ASAP2020	// · · · ·	n.a.
Size distribution: (suspension in water)	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCI DCS (UCD) (RWtAv / RI		201.5 (PDI:0.212)/ NM: 117.8
	Total concentration	mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 w 3022A / KIT dispersed by electrospra		n.a.
Solubility in		g/l			
Solubility in H ₂ O afte	r 30 days	mg/ml	Extraction/ ICP-MS (IC)	N)	5
Specific surface area		cm²/g	BET by ASAP2020 (UU	J)	n.a.
Surface chemistry					
Zeta potential (surfac	e charge)	eV	Zetasizer Nano ZS (UU)		+23.0 ± 4.9 mV pH: 6.23

Summary of trace analyses	ICP-MS (KI	Т)		
Li	hð\ð	0.2		
Na	hð\ð	16.4		
Mg	hð\ð	5.5		
AI	hð\ð	5.5		
Ca	hð\ð	13.8		
Ti	hð\ð	3.2		
Mn	hð\ð	0.2		
Fe	µg/g	35.4		
Ni	µg/g	0.9		
Cu	µg/g	2.8		
Sr	hð/ð	19.1		
Мо	hð\ð	1.1		
Cd	hð\ð	4.4		
Ва	hð/ð	0.2		
ТІ	hô,ô	2.1		
Pb	hð\d	32.5		
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000				
UNIVLEEDS TEM/ TEM-EDX	Electron Microscopy by KIT (LEM)			
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	14 12 10 10 10 10 10 10 10 10 10 10	ZnO_NP004		
Particle concentration [μg/ml] - HRP 0.3 μM Result: ZnO_NP004 induced a moderate increase of DCFH oxidation a concentrations from 25 to 400 μg/ml. DCFH oxidation a concentration information				
Place, Date Karlsruhe, 29.11		oonsible HR. Paur, KIT		

Na	ENTATIVE TEST I anomaterial Identific according to OEC M/MONO(2009)20/F	ation D	Qual	ity	Nano
Nanomaterial	name ZnO	NPs B 2-2		-	
Particle Code	ZnO	_NP005	Manufacturer /Institut		
Composition	7.0		Yunhong Jiang; provi	ided by Uni	ivleeds; 03/2012
Composition Method of pro	ZnO duction B2B	Synthesis	Technology Expert: Yunhong Jiang		
I		5	Suspension	Powd	er 🛛
Kind of susp	ension:		Suspended in pH stabilizer	none_	
Property		unit	Method / Institute	Value	
Agglomeration/aggr	egation		HRTEM (KIT)	crystalline	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X´Pert diffractometer (ICN)	200000 160000 400000 400000 400000 400000 52 100 100 20 20 30 20 30	2 ⁽²⁷⁾ (¹⁰⁾ (¹⁰⁾ 40 50 60 70 80 50 2-4heta angle (degree)
Crystallite size			HRTEM (KIT)		
Octanol-water partition coefficient			Extraction/ ICP-MS (ICN)		P _{OW} =0
Photocatalytic activity			Rhodamin-B Bleaching/U 10mg/ml in Water (ICN)	Rhodamin-B Bleaching/UV-B-100high10mg/ml in Water (ICN)	
Porosity		-/- or %	n.a.		
Pour density		cm3/g	(BJH) Pore Size Distributi Volume by ASAP2020 (L		
			Zetasizer Nano ZS /UCD		606,2 (PDI:0,308) NM: 117,8
Size distribution: (suspension in	Modal value X_M (PDI)	nm	UNIVLEEDS		511,8 (PDI:0,297)
water)			DCS (UCD) (RWtAv / RN	DCS (UCD) (RWtAv / RNumAv)	
	Total concentration	mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	1000 - Luci)1 (0000- 0 -	10 particle diameter [m]
Solubility in	1	g/l		1	
Solubility in H ₂ O aft	er 30 days	mg/ml	Extraction/ ICP-MS (ICN)		4.5
Specific surface are	a	cm²/g	BET by ASAP2020 (UU)		
Surface chemistry					
Zeta potential (surfa	ce charge)	eV	Zetasizer Nano ZS (UU)		+20.3 ± 4.2 mV pH: 6.28

Summary of trace analyses	ICP-MS (KIT)	
Na	hð\ð	16.3
Mg	hð\ð	5.3
AI	hð\ð	4.7
Са	hð\ð	14.5
Ti	hâ\â	3.2
Mn	hâ\â	10.4
Fe	hâ\â	1080.0
Ni	hâ\â	1.1
Cu	hâ\â	3.0
Sr	hâ\â	20.1
Мо	hð\ð	1.2
Cd	hð\ð	4.6
Ва	hð\ð	0.2
ті	hð\ð	2.0
Pb	hð\ð	35.1
Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microscopy by KIT (LEM); Diam	eter : 30-300 nm
UNIVLEEDS	200 nm	ZnO NPs B 2-2
Radical formation potential by DCF-Test:	14	
(H ₂ O ₂ as positive control) (KIT)	$\begin{bmatrix} \mathbf{e} \\ \mathbf{e} $	
Comments and other relevant physica	concentrations from 25 to 400 μg/ml.	racterization information

Na	ENTATIVE TEST P anomaterial Identifica according to OECD //MONO(2009)20/R	ation	ual	ity	Nano
Nanomaterial nameZnO NPs B 2-3Particle CodeZnO_NP006			Manufacturer /Institute/Date		
CompositionZnOMethod of productionB2B SynthesisKind of suspension:		Yunhong Jiang; provided by Univleeds; 03/2012 Technology Expert: Yunhong Jiang			
			Suspension Powder Suspended in		
Property		unit	Method / Institute	Value	
Agglomeration/aggr	egation		HRTEM (KIT)	crystalline	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous	5 (10) (10) (10) (10) (10) (10) (10) (10)
Crystallite size			HRTEM (KIT)		
Octanol-water partition coefficient			Extraction/ ICP-MS (ICN)		P _{ow} =0
Photocatalytic activity			Rhodamin-B Bleaching/U 10mg/ml in Water (ICN)	Rhodamin-B Bleaching/UV-B-100 high 10mg/ml in Water (ICN)	
Porosity		-/- or %	n.a.		
Pour density		cm3/g	(BJH) Pore Size Distributi Volume by ASAP2020 (I		
Size distribution: (suspension in	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD UNIVLEEDS		675,2 (PDI:0,305)/ NM: 117,8 563,8 (PDI:0,432)
water)			DCS (UCD) (RWtAv / RN	DCS (UCD) (RWtAv / RNumAv)	
	Total concentration	mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	Lucia 1) degli ferenze	particle diameter [nm]
Solubility in	1	g/l			
Solubility in H ₂ O aft	er 30 days	mg/ml	Extraction/ ICP-MS (ICN)	Extraction/ ICP-MS (ICN) Ca.5	
Specific surface are	a	cm²/g	BET by ASAP2020 (UU)		
Surface chemistry					
Zeta potential (surfa	ce charge)	eV	Zetasizer Nano ZS (UU)		+20.9 ± 3.6 mV pH: 6.26

Summary of trace analyses		ICP-MS (KIT)	Assay1	Assay2
Li	µg/g		0.4	0.2
Na	µg∕g		17.7	16.0
Mg	hð\ð		12.2	5.4
AI	hð\ð		8.7	4.8
Ca	µg/g		16.8	15.2
Ті	µg/g		3.9	2.9
Mn	µg/g			0.2
Fe	hð\ð		36.6	34.8
Ni	hð\ð		1.0	1.0
Cu	µg/g		2.8	2.9
Sr	µg/g		20.8	20.2
Мо	µg/g		1.1	1.1
Cd	hð\ð		4.5	4.6
Ва	hð\ð		0.2	0.2
ТІ	µg/g		2.2	2.3
Pb	μg/g		35.0	34.2
Magnification: 450.000	Electron Microsoc	py by KIT (LEM); Diameter : 30	-200 nm	
UNIVLEEDS			ZnO NPs B 2-3	
Radical formation potential by DCF-Test:	Not analyzed.			
Comments and other relevant physica	I-chemical properti	es and material characteriz	zation information	
Place, Date Karlsruhe, 06.03	3.2013	Responsible F	IR. Paur, KIT	

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.		ua Research I	nfrastructure lity	Nano	
Nanomaterial r		O NPs B 3-1			
Particle Code	Zn	O_NP007	Manufacturer /Institu		
Composition	Zn	0	Yunhong Jiang; pro	-	
Method of proc		B Synthesis	Technology Expert:	Yunhong Jiar	ng
			Suspension	Powde	r 🛛
Kind of susp	Kind of suspension:		Suspended in pH stabilizer <u>none</u>		
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	crystalline	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	100000 second 20000 20000 200 2000 2	1 (12) (10) (10) 50 60 70 60 50 2-bits angle (Greene)
Crystallite size			HRTEM (KIT)		
Octanol-water partition coefficient			Extraction/ ICP-MS (ICN	1)	P _{ow} =0
Photocatalytic activity	1		Rhodamin-B Bleaching/ 10mg/ml in Water (ICN)		high
Porosity		-/- or %	n.a.		
Pour density		cm3/g	(BJH) Pore Size Distribution Volume by ASAP2020		
			Zetasizer Nano ZS /UCI	כ	647.9 (PDI:0.313)/ NM: 445.7
Size distribution: (suspension in water)	Modal value X _M (PDI) nm	UNIVLEEDS		131.0 PDI(:0.447)
,			DCS (UCD) (RWtAv / R	NUMAV)	1mg/ml
2	Total concentration	mg/ml	SMPS TSI. DMA 3071 v		ing/ini
Size distribution: (Aerosol)	Modal value X_{M} (σ_{geo}) nm	3022A / KIT dispersed by electrospray		
Solubility in		g/l			
Solubility in H ₂ O afte	r 30 days	mg/ml	Extraction/ ICP-MS (ICN	1)	7.5
Specific surface area		cm²/g	BET by ASAP2020 (UU)	
Surface chemistry					
Zeta potential (surfac	e charge)	eV	Zetasizer Nano ZS /UU		-5.9 ± 4.2 mV pH: 6.28

Summary of trace analyses		ICP-MS / KIT	
Na	µg/g		27.3
AI	µg/g		4.6
Са	µg/g		4.8
Ті	µg/g		0.4
Fe	µg/g		30.8
Со	µg/g		0.3
Ni	µg/g		6.6
Cu	µg/g		2.4
Cd	µg/g		<0.1
Pb	hð\ð		4.9
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Micro	Ascopy by KIT (LEM); Diameter	er : 30-200 nm
UNIVLEEDS	0.2 µmi	0.2.um	ZnO NPs B 3-1
TEM EDX UNIVLEEDS		алариянан 1000 годинан 2 (да) с б 7	2/0 83
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	The second process of	■ZnO_N = 50 100 200 400 0 400 = HRP	и 10 H2O2 0.3 µМ
Comments and other relevant physica	concentrations	s from 25 to 400 μg/ml.	ate increase of DCFH oxidation at
Place, Date Karlsruhe, 06.03	3.2013	Responsib	le HR. Paur, KIT

Na	NTATIVE TEST F nomaterial Identifica according to OECE MONO(2009)20/R	ation)	Qua	lity	Nano	
Nanomaterial		NPs B 3-2		ute/Dete		
Particle Code	ZnO_	_NP008	Manufacturer /Institu		deeder 02/2012	
Composition	ZnO		Yunhong Jiang; pro	-		
Method of prod	-	Synthesis	Technology Expert:	Technology Expert: Yunhong Jiang		
			Suspension	Powde	er 🖂	
Kind of susp	ension:		Suspended in pH stabilizer			
Property		unit	Method / Institute	Value		
Agglomeration/aggre	gation		HRTEM (KIT)	crystalline		
Crystalline phase			D5000 Diffractometer (UU) PANalytical X´Pert diffractometer (ICN)	Amorphous	10 102 102 102 102 102 102 102 1	
Crystallite size			HRTEM (KIT)			
Octanol-water partition	on coefficient		Extraction/ ICP-MS (ICN	1)	P _{OW} =0	
Photocatalytic activit	у		Rhodamin-B Bleaching/ 10mg/ml in Water (ICN)		high	
Porosity		-/- or %	n.a.			
Pour density		cm3/g	(BJH) Pore Size Distribu Volume by ASAP2020			
			Zetasizer Nano ZS /UCI	2	670.1 (PDI: 0.331)	
					/ NM: 343.6	
Size distribution: (suspension in water)	Modal value X_M (PDI)	nm	UNIVLEEDS DCS (UCD) (RWtAv / RNumAv)		130.2 (PDI: 0.492)	
	Total concentration	mg/ml			1mg/ml	
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 v 3022A / KIT dispersed by electrospra			
Solubility in		g/l				
Solubility in H ₂ O after	er 30 days	mg/ml	Extraction/ ICP-MS (ICI	N)	6.5	
Specific surface area	1	cm²/g	BET by ASAP2020 (UI	J)		
Surface chemistry						
Zeta potential (surface charge)		eV	Zetasizer Nano ZS /UU		+24.3 ± 3.3 mV pH: 6.43	

Summary of trace analyses	ICF	P-MS / KIT
Na	hð\ð	27.2
Mg	hð\ð	18.1
AI	hâ\à	7.3
Са	hâ\à	3.7
Ті	hâ\à	0.4
Fe	hâ\â	30.7
Co	hð\ð	0.3
Ni	hð\ð	3.2
Cu	hð\ð	2.5
Cd	hð\ð	<0.1
Pb	hð\ð	4.8
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microscopy by K	Tr (LEM); Diameter : 30-200 nm
UNIVLEEDS	100 nm	2.2 µm² 2nO NPs B 3-2
Radical formation potential by DCF-Test:	14	
$(H_2O_2 \text{ as positive control})$ (KIT)	DCL Huncessel 0 DCL Hu	[±] [±] [±] [±] [±] [±] [±] [±]
		duced a moderate increase of DCFH oxidation
Comments and other relevant phy	sical-chemical properties and	material characterization information
Place, Date Karlsruhe, 00	5.03.2013	Responsible HR. Paur, KIT

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			Research Ir	frastructure	Vano
Nanomaterial nameZnO NPs B 3-3Particle CodeZnO_NP009CompositionZnO		Manufacturer /Institu Yunhong Jiang; prov Technology Expert:	vided by Univ		
-		ynthesis	rechnology Expert.	fulliong Jian	ig
Kind of suspension:			Suspension Suspended in pH stabilizer	Powden none	r 🛛
Property		unit	Method / Institute	Value	
Agglomeration/aggree	gation		HRTEM (KIT)	crystalline	
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous	1) (10) (10) (10) (10) (20)
Crystallite size	Crystallite size		HRTEM (KIT)		
Octanol-water partitio	n coefficient		Extraction/ ICP-MS (ICN)		P _{ow} =0
Photocatalytic activity	,		Rhodamin-B Bleaching/U 10mg/ml in Water (ICN)	JV-B-100	high
Porosity		-/- or %	n.a.		
Pour density		cm3/g	(BJH) Pore Size Distribu Volume by ASAP2020		
			Zetasizer Nano ZS /UCE)	657.7 (PDI:0.311)/ NM: 422.7
Size distribution: (suspension in water)	Modal value X_M (PDI)	nm	UNIVLEEDS DCS (UCD) (RWtAv / RM	NumAv)	132.6 (PDI:0.573)
	Total concentration	mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI. DMA 3071 w 3022A / KIT dispersed by electrospra		
Solubility in		g/l			
Solubility in H ₂ O after	r 30 days	mg/ml	Extraction/ ICP-MS (ICN	1)	7.5
Specific surface area		cm²/g	BET by ASAP2020 (UL	J)	
Surface chemistry					
Zeta potential (surfac	e charge)	eV	Zetasizer Nano ZS /UU		+21.7 ± 3.6 mV pH: 6.46

Summary of trace analyses		ICP-MS (KIT)	
Na	µg/g		29.3
AI	µg∕g		8.5
Са	µg∕g		3.1
Ті	µg∕g		0.5
Fe	µg∕g		30.8
Со	µg∕g		0.3
Ni	µg∕g		5.3
Cu	µg∕g		2.7
Cd	µg∕g		<0.1
Pb	µg/g		6.4
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microso	popy by KIT (LEM); Diameter : 30-2	
UNIVLEEDS	200 nm	200 nm	ZnO NPs B 3-3
Radical formation potential by DCF-Test:	14		
(H ₂ O ₂ as positive control) (KIT)	DCF fluorescence [fold increase]	25 50 100 200 400 Particle concentration [µg/ml]	□ZnO_NP009
		P009 induced a moderate inc rom 25 to 400 µg/ml.	crease of DCFH oxidation a
Comments and other relevant physic	al-chemical propert	ies and material characteriza	ation information
Place, Date Karlsruhe, 06.0	3.2013	Responsible H.	-R. Paur. KIT

Supplemental S5: Physicochemical characterization data sheets of titania NMs

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			ua Research In	frastructure	Nano	
Nanomaterial r	name	TiO ₂ -N	NP			
Particle Code	le Code TiO ₂ NP_001		Manufacturer /Institu	ite/Date		
				Jordi Piella Bagaria;	provided by	ICN; 09/2012
Composition		TiO ₂		Technology Expert:	Jordi Piella B	agaria
Method of proc	duction	B2B S	ol-Gel synthesis			
Kind of suspension:		Suspension Suspended in pH stabilizer	рН <u>3</u>			
Property			unit	Method / Institute	Value	
Agglomeration/aggre	gation			HRTEM (KIT)	Crystalline/ Agglomerated	b
Crystalline phase				D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)		40 50 60 70 50 90 theta angle (degree)
Crystallite size				HRTEM (KIT)		
Octanol-water partition	on coefficient			Extraction/ ICP-MS (ICN)		P _{ow} =0
Photocatalytic activity	/			Rhodamin-B Bleaching/UV-B-100high10mg/ml in Water (ICN)		high
Porosity			-/- or %	n.a.		n.a.
Pour density			cm3/g	(BJH) Pore Size Distribu Volume by ASAP2020		n.a.
Size distribution:	Modal value X_M	(וחס)	nm	Zetasizer Nano ZS /UCE)	59.08 (PDI:0.163)
(suspension in				DCS (UCD) (RWtAv / RNumAv)		0.0233/0.0230
water)	Total concentrat	ion	mg/ml			1mg/ml
Size distribution: (Aerosol) Modal value X _M (σ _{geo}) nm		nm	SMPS TSI, DMA 3071 with CPC3022A (KIT)dispersed by electrospray		36 (σ _{geo} =1.23)	
	Total concentrat	ion	mg/cm ³ or #/cm ³			8.9x 10 ³ /cm ³
Solubility in	1		g/l			
Solubility in H2O afte	r 30 days		mg/ml	Extraction/ ICP-MS (ICN	۱)	none
Specific surface area			cm²/g	BET by ASAP2020 (UL	,	n.a.
Surface chemistry			-	- · · ·		
Zeta potential (surfac	e charge)		eV	Zetasizer Nano ZS /UU		-40.4 ± 1.4 mV pH (10.32)

Summary of trace analyses	ICP-MS / KIT			
Ва	hð\ð	16		
Са	hð\ð	215		
Fe	hð\ð	39		
К	µg/g	710		
Mg	μg/g	10		
Mn	μg/g	0.7		
Na	μg/g	7700		
Nb	μg/g	1.3		
Ni	μg/g	25		
Рb	μg/g	0.1		
Sn	μg/g	10		
Zn	hð\ð	144		
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) magnification: 450.000	Electron Microscopy by KIT (LEM); Diar	meter : 10 nm and smaller		
UNIVLEEDS TEM/ SEM		REAL REAL REAL REAL REAL REAL REAL REAL		
SEM-EDX				
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	9 8 7 7 1 0 0 2 5 4 3 0 0 2 5 5 1 0 0 2 5 5 1 0 0 2 5 5 1 0 0 2 5 5 1 0 0 1 1 1 1 1 1 1 1 1 1 1 1 1	400 H2O2 HRP 0.3 µM		
Comments and other relevant physic	Result: TiO2 NP_001 induced a low incr of 400 µg/ml (1.9 fold of nanoparticle fre cal-chemical properties and material ch			
Place, Date Karlsruhe, 29.11.2016 Responsible HR. Paur, KIT				

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.		Ua	lity	Nano	
Nanomaterial	name T	TiO ₂ -NP			
Particle Code	Г	TiO₂NP_002	Manufacturer /Institu	te/Date	
			Jordi Piella Bagaria;	provided by	/ ICN; 09/2012
Composition	Т	TiO ₂	Technology Expert:	Jordi Piella B	Bagaria
Method of pro	duction E	32B Sol-Gel synthesis			
Kind of susp	ension:		Suspension Suspended in pH stabilizer	☑ Powde miliQ-\ 3 <u>5 mM</u>	-
Property		unit	Method / Institute	Value	
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomera	ted /crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	7000 6000 8000 2000 1000 0 200	40 60 80 2.theta angle (degree)
Crystallite size			HRTEM (KIT)		
Octanol-water partition	on coefficient		Extraction/ ICP-MS (ICN)		P _{ow} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/U 10mg/ml in Water (ICN)	JV-B-100	high
Porosity		-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribut Volume by ASAP2020 (n.a.
Cize distribution	Madal velve V (D		Zetasizer Nano ZS /UCD		61.63 (PDI: 0.157)
Size distribution: (suspension in	Modal value X _M (P	DI) nm	DCS (UCD) (RWtAv / RN	lumAv)	0.0236/0.0233
water)	Total concentration	n mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ	_{geo}) nm	SMPS TSI, DMA 3071 wi 3022A / KIT dispersed by electrospray		33.5 (σ _{geo} =1.32)
	Total concentration	mg/cm ³ or #/cm ³			1.2x 10 ⁴ /cm ³
Solubility in	-1	g/l			
Solubility in H2O afte	er 30 days	mg/ml	Extraction/ ICP-MS (ICN)	none
Specific surface area	à	cm²/g	BET by ASAP2020 (UU)	n.a.
Surface chemistry					
Zeta potential (surfac	ce charge)	eV	Zetasizer Nano ZS /UU		-43.0 ± 0.4 mV pH(10.27)

Summary of trace analyses	1	CP-MS / KIT
Ва	µg/g	14
Са	µg/g	68
Cd	µg/g	0.2
К	hð\ð	23
Mg	µg∕g	2.8
Na	µg/g	101
Nb	µg/g	1.1
Pb	µg/g	0.5
Sn	µg/g	10
V	µg/g	5
Zn	µg/g	7.7
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microscopy by	KIT (LEM); Diameter : 10nm or smaller
UNIVLEEDS TEM/ SEM		No.m No.+ 61.41 K.K. Signed A.* 16.64 DH + 3.05 W Signed A.* 16.64 Signed A.* 16.64 EH + 3.05 W Signed A.* 16.64 Signed A.* 16.64
SEM-EDX		Specthank 6 Specthank 5 Al A Th Na Weight % 90%
Radical formation potential by DCF-Test:	9 <u></u>	T
$(H_2O_2 \text{ as positive control})$ (KIT)	$\begin{bmatrix} \mathbf{e}_{1} \\ \mathbf{e}_{2} \\ \mathbf{e}_{3} \\ \mathbf{e}_{4} \\ \mathbf{e}_{3} \\ \mathbf{e}_{4} \\ \mathbf{e}_{3} \\ \mathbf{e}_{4} \\ \mathbf{e}_{4$	
	Result: TiO2 NP_002 in of 400 µg/ml (1.6 fold of	duced a low increase of DCFH oxidation at high concentra nanoparticle free control).
Comments and other relevant physical	-chemical properties an	d material characterization information
Place, Date Karlsruhe, 29.11	.2016	Responsible HR. Paur, KIT

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			ua Research In	frastructure	Nano	
Nanomaterial	name	TiO ₂ -NP				
Particle Code		TiO ₂ NP_003		Manufacturer /Institu	te/Date	
				Jordi Piella Bagaria;	provided by	ICN; 09/2012
Composition		TiO ₂		Technology Expert:	Jordi Piella E	Bagaria
Method of pro	duction	B2B Sol-Gel	synthesis			
Kind of susp	ension:			SuspensionImage: PowderSuspended inmiliQ-waterpH5stabilizer5 mM TMAOH		vater
Property		unit		Method / Institute	Value	
Agglomeration/aggre	egation			HRTEM (KIT)	Agglomera	ted /crystalline
Crystalline phase				D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	14000 12000 10000 4000 4000 0 2000	40 60 80 2-theta angle (degree)
Crystallite size				HRTEM (KIT)		n.a.
Octanol-water partiti	on coefficient			Extraction/ ICP-MS (ICN)		P _{OW} =0
Photocatalytic activit	ty			Rhodamin-B Bleaching/U 10mg/ml in Water (ICN)	V-B-100	high
Porosity		-/- or %		n.a.		n.a.
Pour density		cm3/g		(BJH) Pore Size Distribut Volume by ASAP2020 (n.a.
Size distribution:	Madalushua X			Zetasizer Nano ZS /UCD		115.6 (PDI:0.174)
(suspension in	Modal value X _M	(PDI) nm		DCS (UCD) (RWtAv / RN	umAv)	0.0390/0.0325
water)	Total concentrat	ion mg/ml				1mg/ml
Size distribution: (Aerosol)	Modal value X_M	(σ _{geo}) nm		SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray		42.9 (σ _{geo} =1.5)
	Total concentrat	ion mg/cm ³	³ or #/cm ³			1.0x 10 ⁴ /cm ³
Solubility in		g/l				
Solubility in H2O after	er 30 days	mg/ml		Extraction/ ICP-MS (ICN)	none
Specific surface area	a	cm²/g		BET by ASAP2020 (UU)	n.a.
Surface chemistry						
Zeta potential (surfa	ce charge)	eV		Zetasizer Nano ZS /UU		-39.6 ± 0.8 mV pH(9.63)

Summary of trace analyses	ICP-MS	/ KIT
Ва	hð\ð	12
Са	hð\ð	39
К	hð\ð	24
Mg	μg/g	3.0
Na	hð\ð	7700
Nb	hð\ð	1.3
Ni	hð\ð	1.8
Sn	hð\ð	10
Zn	hð\ð	9.8
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microscopy by KIT (LE	EM); Diameter : 10nm or smaller
UNIVLEEDS TEM/ SEM		
SEM-EDX		XiOm May = 47.17.X.2 Bayes A.1 ML res Description Description <thdescription< th=""> Description</thdescription<>
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	B B B C C C C C C C C C C C C C	в ТЮ2№_003 0 400 H2O2 - HRP 0.3 µM
Comments and other relevant physica	of 400 µg/ml (2.0 fold of nanopa	
Place, Date Karlsruhe, 29.11	.2016 Re	sponsible HR. Paur, KIT

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			ua Research In	ity	Nano
Nanomaterial	name	TiO ₂ -NP			
Particle Code		TiO ₂ NP_004	Manufacturer /Institu	te/Date	
			Jordi Piella Bagaria;	provided by	ICN; 09/2012
Composition		TiO ₂	Technology Expert:	Jordi Piella E	Bagaria
Method of proc	duction	B2B Sol-Gel synthesi			0
Kind of susp	ension:		Suspension Suspended in pH stabilizer	✓ Powde miliQ-v 5 <u>5 mM⁻</u>	
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglomera	ted/ crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	10000 8000 6000 2000 0 2000	40 60 80
Crystallite size			HRTEM (KIT)		2-theta angle (degree)
Octanol-water partition	on coefficient		Extraction/ ICP-MS (ICN)		P _{OW} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/U 10mg/ml in Water (ICN)	V-B-100	high
Porosity		-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distributi Volume by ASAP2020 (I		n.a.
			Zetasizer Nano ZS /UCD		105.1 (PDI:0.171)
Size distribution: (suspension in	Modal value X_{M} (PDI) ^{nm}	DCS (UCD) (RWtAv / RN	umAv)	0.0366/0.0315
water)	Total concentration	on mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ _{geo}) nm	SMPS TSI, DMA 3071 with CPC 5 3022A / KIT dispersed by electrospray		50 (σ _{geo} =1.3)
	Total concentration	on mg/cm ³ or #/cm ³			5.5x 10 ³ /cm ³
Solubility in	1	g/l			
Solubility in H ₂ O afte	er 30 days	mg/ml	Extraction/ ICP-MS (ICN))	none
Specific surface area	1	cm²/g	BET by ASAP2020 (UU))	n.a.
Surface chemistry					
Zeta potential (surfac	ce charge)	eV	Zetasizer Nano ZS /UU		-40.0 ± 0.2 mV pH(9.93)

Summary of trace analyses	ICP-MS / KIT	
Ва	hð\ð	15
Са	µg/g	30
Fe	µg/g	6
К	µg/g	25
Mg	µg/g	1.8
Na	μg/g	6100
Nb	μg/g	1.2
Ni	µg/g	3.2
Pb	μg/g	0.1
Sn	μg/g	9
Zn	hð d	8.0
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microscopy by KIT (LEM); Dia	ameter : 10nm or smaller
UNIVLEEDS TEM/ SEM		May = 63.57.4 617 = 367.47 617 = 367.47 May = 43.57.41 May = 45.57.41 May = 45.57
SEM-EDX		jeetrum 9 jeetrum 5 jetris son,
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	P 7 - P 6 - 0 5 - 0 - - <t< td=""><td>D2NP_004 0 400 H2O2 - HRP 0.3 µM crease of DCFH oxidation at high concentration</td></t<>	D2NP_004 0 400 H2O2 - HRP 0.3 µM crease of DCFH oxidation at high concentration
Comments and other relevant physica	of 400 µg/ml (2.0 fold of nanoparticle f	ree control).
Place, Date Karlsruhe, 29.11	.2016 Respor	sible HR. Paur, KIT

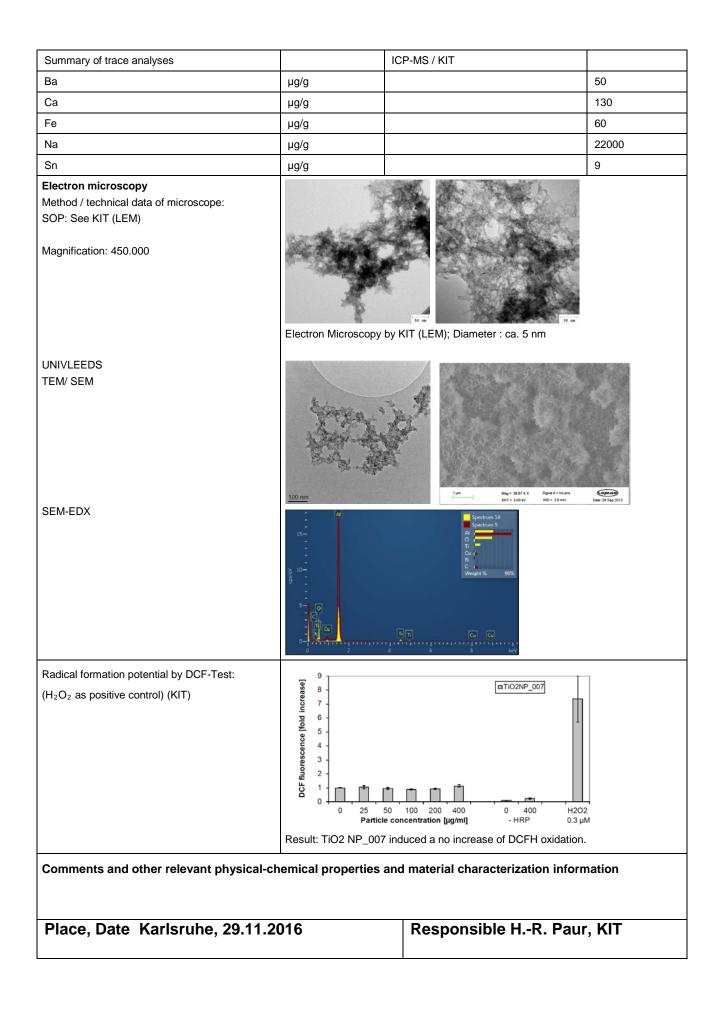
REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.		Research In Ua	frastructure	Nano	
Nanomaterial	name 1	TiO ₂ -NP			
Particle Code	Particle Code TiO ₂ NP_005		Manufacturer /Institu	te/Date	
			Jordi Piella Bagaria;	provided by	ICN; 09/2012
Composition	Г	ΓiO ₂	Technology Expert:	Jordi Piella B	Bagaria
Method of pro	duction E	32B Sol-Gel synthesis			0
			Suspension		
Kind of susp	ension:		Suspended in	<u>miliQ-v</u>	vater
			pH	<u>5</u>	ГМАОН
			stabilizer	<u>5 mini</u>	
Property		unit	Method / Institute	Value	
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerat	ed/ crystalline
Crystalline phase	rystalline phase		D5000 Diffractometer (UU) PANalytical X´Pert	14000 - 12000 - 10000 -	
			diffractometer (ICN)	2000 0 2000	40 60 80 2:theta angle (degree)
Crystallite size			HRTEM (KIT)		
Octanol-water partiti	on coefficient		Extraction/ ICP-MS (ICN)		P _{ow} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/U 10mg/ml in Water (ICN)	V-B-100	high
Porosity		-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribut Volume by ASAP2020 (n.a.
O I I I I I			Zetasizer Nano ZS /UCD		151.1 (PDI: 0.214)
Size distribution: (suspension in	Modal value X _M (P	DI) nm	DCS (UCD) (RWtAv / RN	umAv)	0.0499/0.0370
water)	Total concentration	n mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ	_{geo}) nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray		43.5 (σ _{geo} =1.39)
	Total concentration	n mg/cm ³ or #/cm ³			2.0x 10 ⁴ /cm ³
Solubility in		g/l			1
Solubility in H2O after	er 30 days	mg/ml	Extraction/ ICP-MS (ICN)	none
Specific surface area	a	cm²/g	BET by ASAP2020 (UU)	n.a.
Surface chemistry					
Zeta potential (surfac	ce charge)	eV	Zetasizer Nano ZS /UU		-36.9 ± 0.5 mV pH(10.28)

Ba µg'g 17 Ca µg'g 39 Co µg'g 0.5 Fe µg'g 11 K µg'g 26 Mg µg'g 13 Mg µg'g 6700 Na µg'g 6700 Nb µg'g 6700 Nb µg'g 6700 Nb µg'g 6700 Sn µg'g 13 Sn µg'g 10 Zn µg'g 8.8 Electron Microscope 8.8 SOP: See KIT (LEM) SSOP: See KIT (LEM) Magnification: 450.000 Image: See See See See See See See See See S	Summary of trace analyses		ICP-MS / KIT	
Co µ9'g 0.5 Fe µ9'g 11 K µ9'g 28 Mg µ9'g 6700 Na µ9'g 6700 Nb µ9'g 1.3 N µ9'g 1.3 N µ9'g 1.3 N µ9'g 1.3 N µ9'g 1.3 Sn µ9'g 8.8 Electron microscopy 8.8 Method / Lechnic data of microscope: SOP: See KIT (LEM) Magnification: 450.000 Electron Microscopy by KIT (LEM); Dameter : 10m or smaller UNIVLEEDS Electron Microscopy by KIT (LEM); Dameter : 10m or smaller SEM-EDX Image: Some set KIT (LEM); Some set KI	Ва	μg/g		17
Fe 19/9 11 K 19/9 28 Mg 19/9 1.8 Na 19/9 1.3 Ni 19/9 1.3 Ni 19/9 1.3 Sn 19/9 10 Zn 19/9 10 Zn 19/9 8.8 Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000 Electron Microscopy by KIT (LEM); Diameter : 10m or smaller UNIVLEEDS Electron Microscopy by KIT (LEM); Diameter : 10m or smaller SEM-EDX Image: See KIT (LEM) Image: See KIT (LEM) SEM-EDX Image: See KIT (LEM); Diameter : 10m or smaller Image: See KIT (LEM); Diameter : 10m or smaller SEM-EDX Image: See KIT (LEM); Diameter : 10m or smaller Image: See KIT (LEM); Diameter : 10m or smaller SEM-EDX Image: See KIT (LEM); Diameter : 10m or smaller Image: See KIT (LEM); Diameter : 10m or smaller SEM-EDX Image: See KIT (LEM); Diameter : 10m or smaller Image: See KIT (LEM); Diameter : 10m or smaller SEM-EDX Image: See KIT (LEM); Diameter : 10m or sm	Са	hð\ð		39
K H99 26 Mg H99 18 Na H99 6700 Nb H99 13 Ni H99 13 Sn H99 10 Zn H99 88 Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000 Image: Sope See KIT (LEM) Image: Sope See KIT (LEM) Magnification: 450.000 Image: Sope See KIT (LEM); Diameter : 10nn or smaller UNIVLEEDS Image: Sope See KIT (LEM); Diameter : 10nn or smaller SEM-EDX Image: Sope See KIT (LEM); Diameter : 10nn or smaller SEM-EDX Image: Sope See KIT (LEM); Diameter : 10nn or smaller Redical formation potential by DCF-Test: Image: Sope See KIT (LEM); Diameter : 10nn or smaller Redical formation potential by DCF-Test: Image: Sope See KIT (LEM); Diameter : 10nn or smaller Redical formation potential by DCF-Test: Image: Sope See KIT (LEM); Distribute or totto) (KIT) Image: Sope See KIT (LEM);	Со	hð\ð		0.5
Mg Hg/g 1.8 Na Hg/g 6700 Nb Hg/g 1.3 Ni Hg/g 1.3 Ni Hg/g 10 Sn Hg/g 10 Zri Hg/g 8.8 Electron microscopy Hg/g 8.8 Electron microscopy Second particular and the second particular and the second particular particular particular particular particular particular and the second particular particul	Fe	hð\ð		11
Na µg/g 6700 Nb µg/g 1.3 Ni µg/g 1.9 Sn µg/g 10 Zn µg/g 8.8 Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000 Image: See KIT (LEM) Image: See KIT (LEM) Magnification: 450.000 Image: See KIT (LEM) Image: See KIT (LEM) SEM-EDX Image: See KIT (LEM) Image: See KIT (LEM) SEM-EDX Image: See KIT (LEM) Image: See KIT (LEM) Radical formation potential by DCF-Test: Image: See KIT (LEM) Image: See KIT (LEM) Reduct formation potential by DCF-Test: Image: See KIT (LEM) Image: See KIT (LEM) Reduct formation potential by DCF-Test: Image: See KIT (LEM) Image: See KIT (LEM) Result: TIC 2 N=_005 induced a moderate increase of DCFH oxidation in deperior of concentration (3.3 fold of nanoparticle free control at 400 µg/ml). Image: See KIT (LEM) Result: TIC 2 N=_005 induced a moderate increase of DCFH oxidation in deperior of concentration (3.3 fold of nanoparticle free control at 400 µg/ml). Comments and other relevant physical-toemical properties and material characterization information	К	hð\ð		26
Nb µg/g 1.3 Ni µg/g 1.9 Sn µg/g 10 Zn µg/g 8.8 Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000 Electron Microscopy by KIT (LEM); Diameter : 10nm or smaller UNIVLEEDS Electron Microscopy by KIT (LEM); Diameter : 10nm or smaller SEM-EDX Image: See Mit (LEM); Diameter : 10nm or smaller Radical formation potential by DCF-Test: Image: See Mit (LEM); Diameter : 10nm or smaller Radical formation potential by DCF-Test: Image: See Mit (LEM); Diameter : 10nm or smaller Radical formation potential by DCF-Test: Image: See Mit (LEM); Diameter : 10nm or smaller Reduct formation potential by DCF-Test: Image: See Mit (LEM); Diameter : 10nm or smaller Reduct formation potential by DCF-Test: Image: See Mit (LEM); Diameter : 10nm or smaller Reduct formation potential by DCF-Test: Image: See Mit (LEM); Diameter : 10nm or smaller Reduct formation potential by DCF-Test: Image: See Mit (LEM); Diameter : 10nm or smaller Result: TOCE N= Color induced a moderate increase of DCFH oxidation in deperied concentration (S.3 fold of nanoparticle free control at 400 µg/m). Comments and other relevant physical-chemical properties and	Mg	hð\ð		1.8
Ni µg/g 1.9 Sn µg/g 10 Zn µg/g 8.8 Electron microscopy Wethod / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000 Electron Microscopy by KIT (LEM); Diameter : 10m or smaller UNIVLEEDS Electron Microscopy by KIT (LEM); Diameter : 10m or smaller SEM-EDX Image: Sop See Set (ST (LEM); Diameter : 10m or smaller) Radical formation potential by DCF-Test: Image: Sop See Set (ST (LEM); Diameter : 10m or smaller) Radical formation potential by DCF-Test: Image: Sop See Set (ST (LEM); Diameter : 10m or smaller) Radical formation potential by DCF-Test: Image: Sop See Set (ST (LEM); Diameter : 10m or smaller) Radical formation potential by DCF-Test: Image: Sop See Set (ST (LEM); Diameter : 10m or smaller) Radical formation potential by DCF-Test: Image: Sop See Set (ST (LEM); Diameter : 10m or smaller) Result: TOZ NP_005 induced a moderate increase of DCFH oxidation in deperd of the control (KT) Image: Sop See Set (ST	Na			6700
Sn µg/g 10 Zn µg/g 8.8 Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000 Image: Control of Microscope (LEM) Image: Control of Microscope (LEM) UNIVLEEDS Image: Control of Microscope (LEM) Image: Control of Microscope (LEM) SEM-EDX Image: Control of Microscope (KIT) Image: Control of Microscope (LEM) Radical formation potential by DCF-Test: Image: Control of Microscope (Mit) Image: Control of Microscope (LEM) Radical formation potential by DCF-Test: Image: Control of Microscope (Mit) Image: Control of Microscope (LEM) Radical formation potential by DCF-Test: Image: Control of Microscope (Mit) Image: Control of Microscope (LEM) Radical formation potential by DCF-Test: Image: Control of Microscope (Mit) Image: Control of Microscope (LEM) Image: Control of Microscope (LEM) Image: Control of Microscope (LEM) Image: Control of Microscope (LEM) Image: Control of Microscope (LEM) Image: Control of Microscope (LEM) Image: Control of Microscope (LEM) Result: TCOL NP_005 induced a moderate increase of DCFH oxidation in deperer of concentration (S3 fold of nanoparticle free control at 400 µg/m). Conments and other relevant physical-chemical properties and material characteri	Nb	hð\d		1.3
Zn μg'g 8.8 Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Electron Microscopy by KIT (LEM): Diameter : 10nm or smaller UNIVLEEDS TEM/ SEM Electron Microscopy by KIT (LEM): Diameter : 10nm or smaller SEM-EDX Image: Constraint of the second secon	Ni	hð\ð		1.9
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Image: Comparison of the second	Sn	hð\ð		10
Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000 Image: Constraint of the constrain	Zn			8.8
TEM/ SEM Image: Sem and the relevant physical-cemical properties and material characterization information SEM-EDX Image: Sem and the relevant physical-cemical properties and material characterization information Radical formation potential by DCF-Test: Image: Sem and the relevant physical-cemical properties and material characterization information Radical formation potential by DCF-Test: Image: Sem and the relevant physical-cemical properties and material characterization information Result: TIO2 NP_005 induced a moderate increase of DCFH oxidation in dependence Result: TIO2 NP_005 induced a moderate increase of DCFH oxidation in dependence Comments and other relevant physical-cemical properties and material characterization information Image: Sem and the relevant physical-cemical properties and material characterization information	Method / technical data of microscope: SOP: See KIT (LEM)	Electron Microscop	y by KIT (LEM); Diameter : 10nm of	or smaller
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT) H ₂ CO ₂ as positive control) (KIT) Result: TiO2 NP_005 induced a moderate increase of DCFH oxidation in dependence of concentration (3.3 fold of nanoparticle free control at 400 µg/ml).		100 mm	таран 100 карана на к Карана карана на каран	A CONSTRUCTION OF STIT
(H ₂ O ₂ as positive control) (KIT) (H ₂ O ₂ as positive control) (KIT) (KIT) (H ₂ O ₂ as positive control) (KIT) (H ₂ O ₂ as positive con	SEM-EDX	ः वित्व	Weight % 90%	
(H ₂ O ₂ as positive control) (KIT) (H ₂ O ₂ as positive control) (KIT) (KIT) (H ₂ O ₂ as positive control) (KIT) (H ₂ O ₂ as positive con	Radical formation potential by DCF-Test:	9 1		
		Result: TiO2 NP_00	100 200 400 0 400 H2O2 entration [µg/ml] - HRP 0.3 µM	DCFH oxidation in dependence at 400 μg/ml).
Place Date Karlsruhe 29.11.2016 Responsible H-R Paur KIT	Comments and other relevant physical	-chemical properties	s and material characterization	on information
	Place, Date Karlsruhe, 29.11			

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			Research In Ua	frastructure	Nano
Nanomaterial r	name TiO	2-NP			
Particle Code	TiO	₂ NP_006	Manufacturer /Institu	te/Date	
			Jordi Piella Bagaria;	provided by	ICN; 09/2012
Composition	TiO	-	Technology Expert:	Jordi Piella	Bagaria
Method of proc	JUCTION B2	3 Sol-Gel synthesis	Suspension	Powde	r 🗆
Kind of suspension:			Suspended in pH stabilizer	<u>miliQ-w</u> 5	
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglomerat	ed/ crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	10000 12000 - 12000 - 12000 - 12000 - 12000 - 12000 - 2000 - 20 300	40 50 60 70 50 50 20hsta angle (dogree)
Crystallite size			HRTEM (KIT)		
Octanol-water partition	on coefficient		Extraction/ ICP-MS (ICN)		P _{ow} =0
Photocatalytic activity	1		Rhodamin-B Bleaching/UV-B-100high10mg/ml in Water (ICN)		high
Porosity		-/- or %	n.a. n.a		n.a.
Pour density		cm3/g		(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	
Ciza diatribution.		nm	Zetasizer Nano ZS /UCD		217.0 (PDI:0.388)
Size distribution: (suspension in	Modal value X _M (PDI)	1111	DCS (UCD) (RWtAv / RN	umAv)	0.0542/0.0386
water)	Total concentration	mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 wi 3022A / KIT dispersed by electrospray		56.5 (σ _{geo} =1.47)
	Total concentration	mg/cm ³ or #/cm ³			1.2x 10 ⁴ /cm ³
Solubility in	I	g/l			
Solubility in H2O afte	Solubility in H2O after 30 days		Extraction/ ICP-MS (ICN)	none
Specific surface area	Specific surface area		BET by ASAP2020 (UU)	n.a.
Surface chemistry					
Zeta potential (surfac	e charge)	eV	Zetasizer Nano ZS /UU		-33.6 ± 1.2 mV pH(10.10)

Place, Date Karlsruhe, 29.11		Responsible H	
Comments and other relevant physica	I-chemical properti	es and material characteri	zation information
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	Result: TiO2 NP_	ncentration [µg/ml] - HRP 0.3	202 μM e of DCFH oxidation in dependenc trol at 400 μg/ml).
SEM-EDX		Spectrum 11 Spectrum 5 A Spectrum 5 A	
UNIVLEEDS TEM/ SEM	100 mm	100 mm 11 mm 12	Biget A* Huns MD - 13 em
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000	Electron Microsco	bpy by KIT (LEM); Diameter : 10	nm or smaller
Zn	hð\ð		9.6
Sn	hð ð		11
Pb	μg/g		1.2
Nb	μg/g		1.1
Na	hð\ð		140
Mg	hð\ð		4
Fe K	hð\ð		52
Ca	hð\ð		80
Ва	hð\ð		21

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			ua Research In	frastructure	Nano
Nanomaterial r	name T	iO ₂ -NP			
Particle Code	Т	iO₂NP_007	Manufacturer /Institu	te/Date	
			Jordi Piella Bagaria;	provided by	ICN; 09/2012
Composition	т	iO ₂	Technology Expert:	Jordi Pie	ella Bagaria
Method of proc	duction B	2B Sol-Gel synthesis			
Kind of suspension:			Suspension Suspended in pH stabilizer	✓ Powde miliQ-v 5 <u>5 mM⁻</u>	
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglomerat	ted/ crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	7000 5000 (mtg) 4000 2000 1000 0 200 0 200 0 0 0	40 50 60 70 80 90 2 theta angle (degree)
Crystallite size			HRTEM (KIT)		
Octanol-water partition	on coefficient		Extraction/ ICP-MS (ICN)		P _{OW} =0
Photocatalytic activity	/		Rhodamin-B Bleaching/UV-B-100medium10mg/ml in Water (ICN)		medium
Porosity		-/- or %	n.a. n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution and n.a. Volume by ASAP2020 (UU)		n.a.
Size distribution:		ווכ	Zetasizer Nano ZS /UCD		281.3 (PDI:0.409)
(suspension in	Modal value X _M (PI		DCS (UCD) (RWtAv / RN	lumAv)	0.0700/0.0406
water)	Total concentration	mg/ml			1mg/ml
Size distribution: (Aerosol)	Modal value X_M (σ_g	_{leo}) nm	SMPS TSI, DMA 3071 wi 3022A / KIT dispersed by electrospray		59 (σ _{geo} =1.45)
	Total concentration	mg/cm ³ or #/cm ³			6.0x 10 ³ /cm ³
Solubility in	I	g/l			
Solubility in H ₂ O afte	Solubility in H ₂ O after 30 days		Extraction/ ICP-MS (ICN)		none
Specific surface area		cm²/g	BET by ASAP2020 (UU)	n.a.
Surface chemistry					
Zeta potential (surfac	e charge)	eV	Zetasizer Nano ZS /UU		-37.4 ± 1.4 mV pH(9.13)

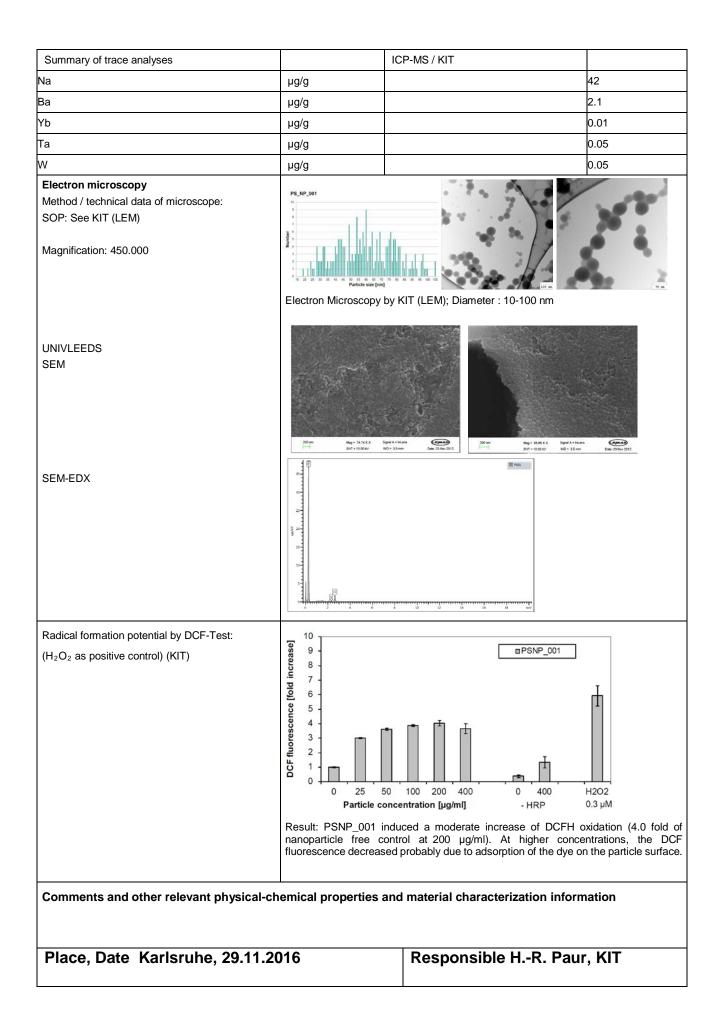


REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			ES	Research In	frastructure	Nano
Nanomaterial	name	TiO ₂ -NP				
Particle Code		TiO ₂ NP_008	Manufact	urer /Institu	te/Date	
			Jordi Piel	la Bagaria;	provided by	ICN; 09/2012
Composition		TiO ₂	Technolo	av Expert:	Jordi Piella E	Bagaria
Method of proc	duction	B2B Sol-Gel sy				0
Kind of suspension:				pH <u>7</u>		
Property		unit	Method /	Institute	Value	
Agglomeration/aggre	egation		HRTEM (K	IT)	Agglomerat	ed/ crystalline
Crystalline phase			D5000 Diffr (UU) PANalytica diffractome	X Pert	8000 6000 2000 0 2000	40 60 80 2-theta angle (degree)
Crystallite size			HRTEM (K	IT)		
Octanol-water partition	on coefficient		Extraction/	Extraction/ ICP-MS (ICN) Po		P _{OW} =0
Photocatalytic activit	у			Rhodamin-B Bleaching/UV-B-100 None-m 10mg/ml in Water (ICN)		None-medium
Porosity		-/- or %	n.a.	n.a. n.a.		n.a.
Pour density		cm3/g		Size Distribut ASAP2020 (n.a.
		(==) m	Zetasizer N	lano ZS /UCD		265.3 (PDI:0.287)
Size distribution: (suspension in	Modal value X_M	(PDI) nm	DCS (UCD) (RWtAv / RN	lumAv)	0.0618/0.0407
water)	Total concentrat	ion mg/ml				1mg/ml
Size distribution: (Aerosol)	Modal value X_{M}	(σ _{geo}) nm	3022A / KI	DMA 3071 wi r by electrospray		70 (σ _{geo} =1.5)
	Total concentrat	ion mg/cm ³ or	#/cm ³			3.7x 10 ³ /cm ³
Solubility in	1	g/l				
Solubility in H2O after 30 days		mg/ml	Extraction/	ICP-MS (ICN)	none
Specific surface area	à	cm²/g	BET by AS	AP2020 (UU)	n.a.
Surface chemistry						
Zeta potential (surfac	ce charge)	eV	Zetasizer N	lano ZS /UU		-36.9 ± 0.3 mV pH 10.23

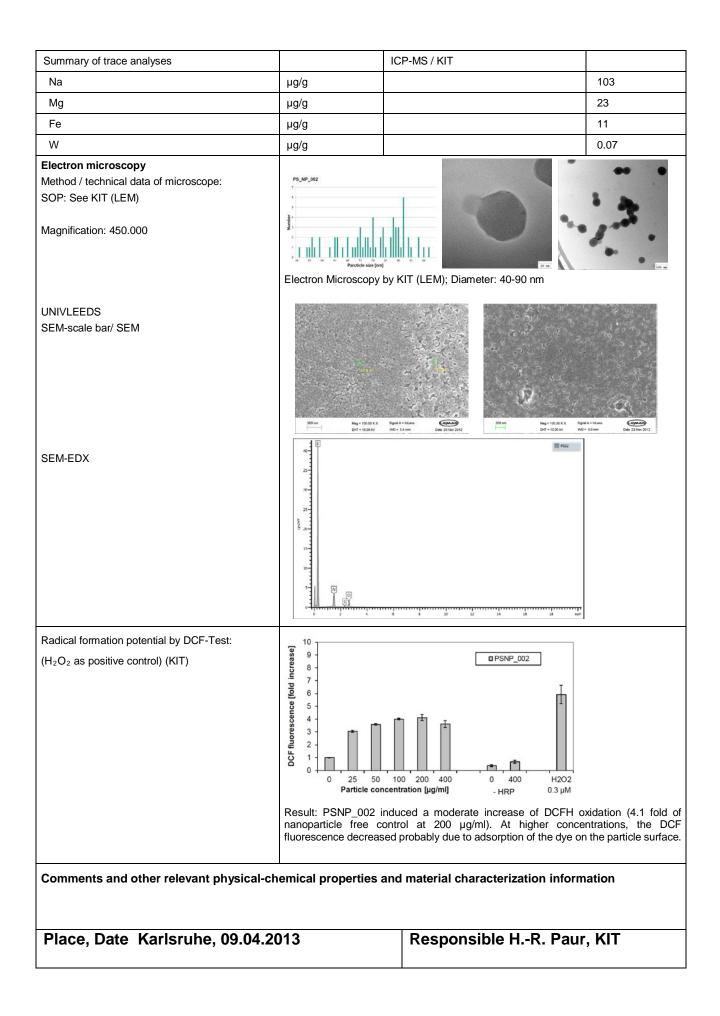
Summary of trace analyses		ICP-MS / KIT	
Ва	µg/g		28
Са	µg/g		128
Fe	μg/g		25
К	μg/g		129
Na	μg/g		96000
Nb	μg/g		1.3
Ni	hð\ð		2.2
Pb	hð/ð		0.2
Sn	hð\ð		8
Electron microscopy Method / technical data of microscope: SOP: See KIT (LEM) Magnification: 450.000			a na
UNIVLEEDS TEM/ SEM		oscopy by KIT (LEM); Diameter : 5	AKE Sput-Huins
SEM-EDX		ert - so Spectrum 13 Spectrum 5 T T T Cu Weight % Son 4 6 8 kiv	W KG + 2 if me. Date 38 fmp 3012
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	Result: TiO2 I		H2O2 0.3 μM DCFH oxidation at high concentration
Comments and other relevant physi		(1.5 fold of nanoparticle free contro	
Place, Date Karlsruhe, 29.	11.2016	Responsible	HR. Paur, KIT

Supplemental S6: Physicochemical characterization data sheets of PS-NH2 NMs

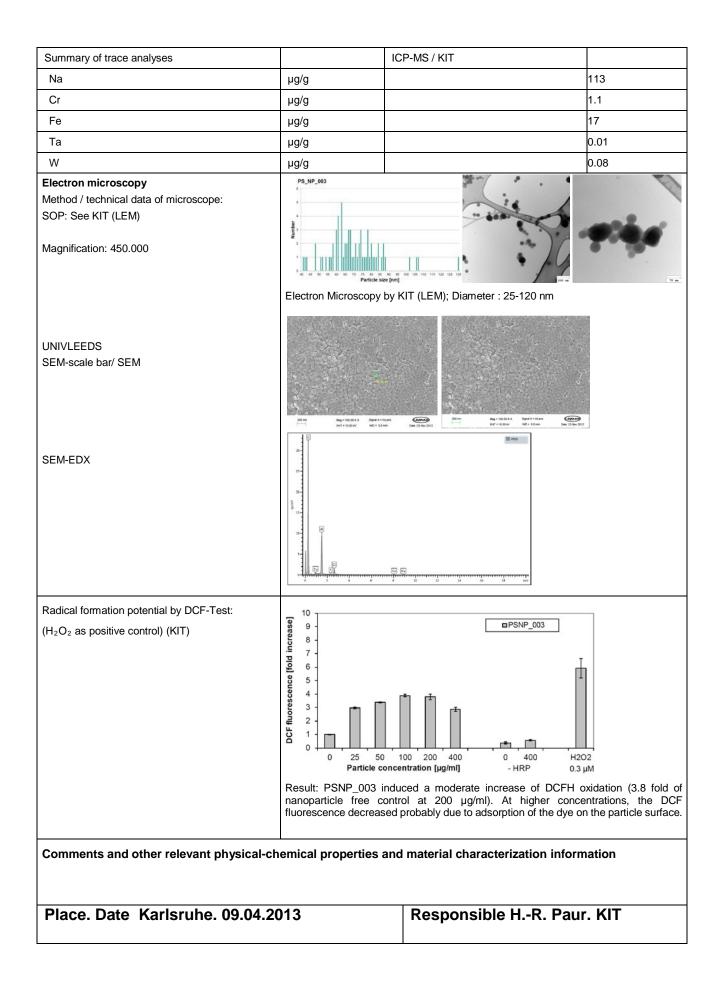
REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			Research Infrastructure	Nano
Nanomaterial name Latex Particle Code PSNP_001		-	Manufacturer /Institute/Date Eugene Mahon ; provided by UCD; 10/2012 Technology Expert: Eugene Mahon	
CompositionPSMethod of productionSol-Gel synthesis		Gel synthesis		
Kind of suspension:			Suspension Powder Suspended in Pure water pH stabilizer	
Property		unit	Method / Institute	Value
Agglomeration/aggr	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partit	ion coefficient		Determination of absorbance (ICN)	P _{OW} =0
Photocatalytic activi	ty		Rhodamin-B Bleaching/UV-B-100 0.05mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	none
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	none
Size distribution:		nm	Zetasizer Nano ZS /UCD	115.9 (PDI:0.029) NM: 94.29
(suspension in	Modal value X_M (PDI)		DCS (UCD) (RWtAv / RNumAv)	n.a.
water)	Total concentration	mg/ml		10
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI, DMA 3071 with CPC 3022A / KIT dispersed by electrospray	120 (σ _{geo} =1.15)
	Total concentration	mg/cm ³ or #/cm ³		3.4x 10 ³ /cm ³
Solubility in	1	g/l		
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	n.a.
Specific surface are	a	m²/g	BET by ASAP2020 (UU)	none
Surface chemistry				
Zeta potential (surfa	ce charge)	mV	Zetasizer Nano ZS /UU	+48.7 ± 0.5 pH: 6.1



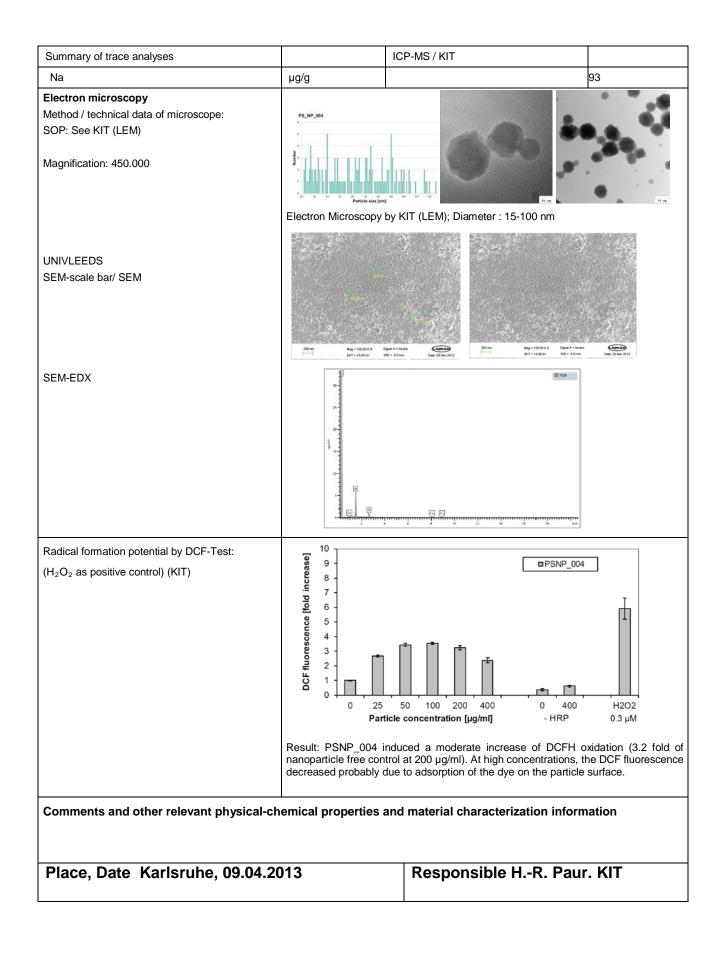
Na	ENTATIVE TEST F anomaterial Identifica according to OECI //MONO(2009)20/R	ation D	Research Infrastructure	Nano
Nanomaterial Particle Code	PSN	x P_002	Manufacturer /Institute/Date Eugene Mahon ; provided by UCD; 10/2012 Technology Expert: Eugene Mahon	
Composition Method of pro	PS duction Sol-0	Gel synthesis		
Kind of susp	ension:		SuspensionPowdeSuspended in pHPure way pHstabilizernone	-
Property		unit	Method / Institute	Value
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partiti	on coefficient		Determination of absorbance (ICN)	P _{ow} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/UV-B-100 0.05mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	none
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	none
	Madalushus X (DDI)	nm	Zetasizer Nano ZS /UCD	119.1 (PDI:0.80) NM: 91.2
Size distribution: (suspension in	Modal value X _M (PDI)	1011	UNIVLEEDS	120.5 (PDI: 0.113)
water)			DCS (UCD) (RWtAv / RNumAv)	
	Total concentration	mg/ml		10
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI. DMA 3071 with CPC 3022A / KIT dispersed by electrospray	106 (σ _{geo} =1.12)
	Total concentration	mg/cm ³ or #/cm ³		4.4x 10 ³ /cm ³
Solubility in		g/l		
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	
Specific surface area		m²/g	BET by ASAP2020 (UU)	none
Surface chemistry				
Zeta potential (surface charge)		mV	Zetasizer Nano ZS /UU	+44.4 ± 0.3 pH: 6.0



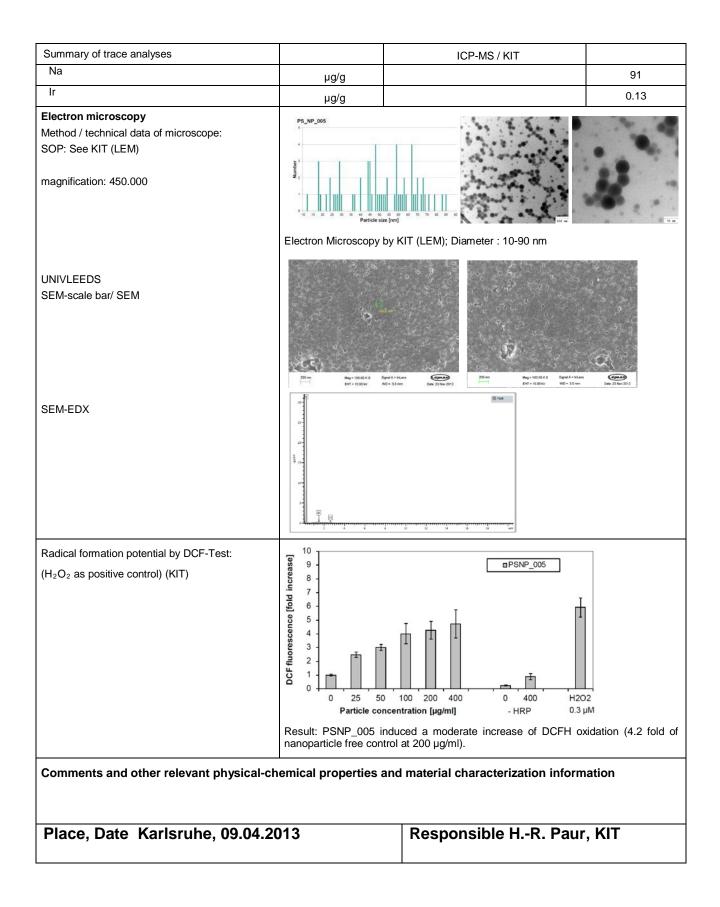
REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			uality	Nano
Nanomaterial nameLatexParticle CodePSNP_003CompositionPS			Manufacturer /Institute/Date Eugene Mahon ; provided by UCD; 10/2012 Technology Expert: Eugene Mahon	
Method of pro	duction Sol-	Gel synthesis		
Kind of suspension:			Suspension Powde Suspended in Pure was pH	-
			stabilizer none	
Property		unit	Method / Institute	Value
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partiti	on coefficient		Determination of absorbance (ICN)	P _{OW} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/UV-B-100 0.05mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	none
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	none
			Zetasizer Nano ZS /UCD	140.8 (PDI:0.011) NM: 121.0
Size distribution: (suspension in	Modal value X _M (PDI)	nm	UNIVLEEDS	123.4 (PDI: 0.101)
water)			DCS (UCD) (RWtAv / RNumAv)	
	Total concentration	mg/ml		10
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI. DMA 3071 with CPC 3022A / KIT dispersed by electrospray	88.2 (σ _{geo} =1.18)
	Total concentration	mg/cm ³ or #/cm ³		3.1x 10 ⁴ /cm ³
Solubility in		g/l		
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	
Specific surface area		m²/g	BET by ASAP2020 (UU)	none
Surface chemistry				
Zeta potential (surfa	ce charge)	mV	Zetasizer Nano ZS /UU	+50.9 ± 1.9 pH:6.1



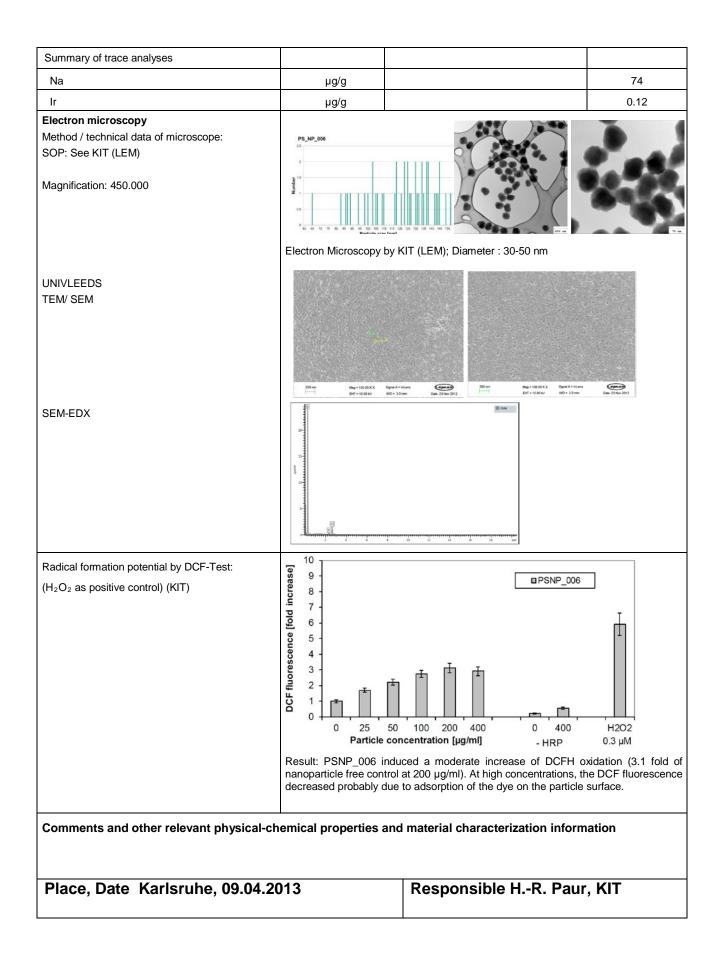
Na	ENTATIVE TEST I nomaterial Identific according to OECI //MONO(2009)20/R	ation D	Research Infrastructure	Nano
Nanomaterial Particle Code	PSN	x P_004	Manufacturer /Institute/Date Eugene Mahon ; provided by UCE Technology Expert: Eugene Maho	
Composition Method of pro-	PS duction Sol-(Gel synthesis		
Kind of suspension:			Suspension Powder Suspended in Pure water pH stabilizer	
Property		unit	Method / Institute	Value
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partition	on coefficient		Determination of absorbance (ICN)	P _{OW} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/UV-B-100 0.05mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	none
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	none
	Madalusha X (DDI)	nm	Zetasizer Nano ZS /UCD	130.9 (PDI:0.033) NM: 108.4
Size distribution: (suspension in	Modal value X _M (PDI)		UNIVLEEDS	123.8 (PDI:0.049)
water)			DCS (UCD) (RWtAv / RNumAv)	
	Total concentration	mg/ml		10
Size distribution: (Aerosol)	Modal value X_{M} (σ_{geo})	nm	SMPS TSI. DMA 3071 with CPC 3022A / KIT dispersed by electrospray	135 (σ _{geo} =1.18)
	Total concentration	mg/cm ³ or #/cm ³		1.5x 10 ⁴ /cm ³
Solubility in		g/l		
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	
Specific surface area		m²/g	BET by ASAP2020 (UU)	none
Surface chemistry				
Zeta potential (surfac	ce charge)	mV	Zetasizer Nano ZS /UU	+49.7 ± 0.6 pH:6.1



Na	ENTATIVE TEST anomaterial Identific according to OEC //MONO(2009)20/F	cation D	Research Infrastructure	Nano
Nanomaterial Particle Code	PSN	ex NP_005	Manufacturer /Institute/Date Eugene Mahon ; provided by UCE Technology Expert: Eugene Maho	
Composition Method of pro	PS duction Sol-	Gel synthesis		
Kind of suspension:			Suspension Powder Suspended in Pure water pH stabilizer	
Property		unit	Method / Institute	Value
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partiti	on coefficient		Determination of absorbance (ICN)	P _{OW} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/UV-B-100 0.05mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	none
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	none
Size distribution:	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD	105.7 (PDI:0.015) NM: 86.9
(suspension in			UNIVLEEDS	103.3 (PDI:0.068)
water)			DCS (UCD) (RWtAv / RNumAv)	10
	Total concentration	mg/ml		10
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI. DMA 3071 with CPC 3022A / KIT dispersed by electrospray	94 (σ _{geo} =1.15)
	Total concentration	mg/cm ³ or #/cm ³		2.3x 10 ⁴ /cm ³
Solubility in		g/l		
Solubility in H_2O		g/l	Extraction/ ICP-MS (ICN)	
Specific surface area		m²/g	BET by ASAP2020 (UU)	none
Surface chemistry				
Zeta potential (surfa	ce charge)	mV	Zetasizer Nano ZS /UU	+52.1 ± 0.2 pH:6.1



REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			esearch Infrastructure	Nano
Nanomaterial nameLatexParticle CodePSNP_006CompositionPS		NP_006	Manufacturer /Institute/Date Eugene Mahon ; provided by UCD; 10/2012 Technology Expert: Eugene Mahon	
Method of pro	duction So	I-Gel synthesis		
Kind of suspension:			SuspensionPowderSuspended inPure waterpHstabilizernone	
Property		unit	Method / Institute	Value
Agglomeration/aggre	egation		HRTEM (KIT)	Agglomerated
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	Amorphous
Crystallite size			HRTEM (KIT)	n.a.
Octanol-water partiti	on coefficient		Determination of absorbance (ICN)	P _{OW} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/UV-B-100 0.05mg/ml in Water (ICN)	none
Porosity		-/- or %	n.a.	none
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)	none
			Zetasizer Nano ZS /UCD	153.7 (PDI:0.041) NM: 132.8
Size distribution: (suspension in	Modal value X _M (PDI)	nm	UNIVLEEDS	144.3 (PDI:0.020)
water)			DCS (UCD) (RWtAv / RNumAv)	
	Total concentration	mg/ml		10
Size distribution: (Aerosol)	Modal value X_M (σ_{geo}) nm	SMPS TSI. DMA 3071 with CPC 3022A / KIT dispersed by electrospray	168.5 (σ _{geo} =1.09)
	Total concentration	mg/cm ³ or #/cm ³		1.5x 10 ⁴ /cm ³
Solubility in		g/l		
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)	
Specific surface area		m²/g	BET by ASAP2020 (UU)	none
Surface chemistry				
Zeta potential (surface charge)		mV	Zetasizer Nano ZS /UU	+50.7 ± 1.0 pH:6.1



Supplemental S7: Physicochemical characterization data sheets of ceria NMs

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REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			uali	tyl	Nano
Nanomaterial name CeO ₂ Particle Code CeO ₂		CeO₂ CeO₂NP_001	Manufacturer /Institute/Date Jordi Piella Bagaria; provided by ICN; 12/2012 Technology Expert: Jordi Piella Bagaria		
CompositionCeO2Method of productionSol Gel synthesis					
			Suspension	Powde	r
Kind of suspension:			Suspended in pH stabilizer	water 	
Property		unit	Method / Institute		Value
Agglomeration/aggre	gation		HRTEM (KIT)		Agglomerated and crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	7000 6000 (mt) 4000 1000 1000 200	
Crystallite size			HRTEM (KIT)		a success of the feedbacks
Octanol-water partition	on coefficient		Determination of absorbance	(ICN)	P _{OW} =0
Photocatalytic activit	ý		Rhodamin-B Bleaching/UV-B- 0.05mg/ml in Water (ICN)	·100	none
Porosity		-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution a Volume by ASAP2020 (UU)	and	n.a.
			Zetasizer Nano ZS /UCD		74.03 (PDI:0.407) NM: 26.31
Size distribution: (suspension in water)	Modal value X _M (PDI)	DI) nm	UNIVLEEDS DCS (UCD) (RWtAv / RNumA		105.5 (PDI:0.26)
,	Total concentration	n mg/ml		3.2	
Size distribution: (Aerosol)	Modal value X_M (σ		SMPS TSI, DMA 3071 with Cl 3022A / KIT dispersed by electrospray	PC	46 (σ _{geo} =1.13)
Total concentration		mg/cm ³ or #/cm ³			8.18 x 10 ³ /cm ³
Solubility in		g/l			
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)		
Specific surface area		m²/g	BET by ASAP2020 (UU)		n.a.
Surface chemistry Zeta potential (surfac	Surface chemistry Zeta potential (surface charge)		Zetasizer Nano ZS /UU		+49.3 ± 1.3 pH: 3.81

Summary of trace analyses		ICP-MS / KIT	CeO	CeO ₂
AI	hð\ð		27	22
В	µg∕g		4	3
Ва	hð\ð		8.2	6.7
Са	µg/g		83	68
Gd	µg/g		19	16
La	µg/g		1.3	1.1
Lu	µg/g		0.4	0.3
Mg	µg/g		1.4	1.2
Mn	µg/g		0.3	0.2
Nd	µg/g		0.8	0.6
Pb	µg/g		0.2	0.1
Pt	µg/g		0.6	0.5
Sm	hð\d		2.0	1.6
Sr	µg/g		0.5	0.4
Ti	µg/g		41	33
Yb	hð ð		2.7	2.2
Zn	hð\d		3	2
Zr	hð\d		0.8	0.7
Magnification: 450.000 UNIVLEEDS TEM	Electron Microsco	by by KIT (LEM); Diameter: maxi	mum around 10 nm	
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT) $ \begin{pmatrix} y & y \\ y$				
Comments and other relevant physical	concentration of 4	00 μg/ml (10.1 fold of nanopartic s and material characteriza	le free control).	on at nign
Place, Date Karlsruhe, 08.04	.2013	Responsible H	R. Paur, KIT	

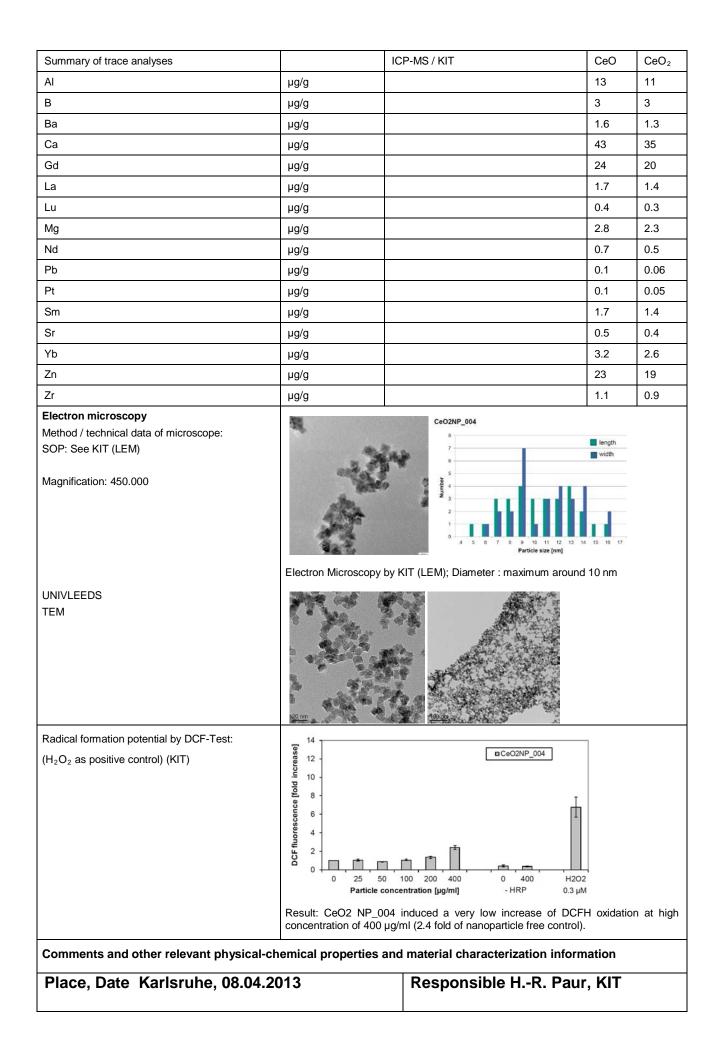
Na	INTATIVE TEST Inomaterial Identific according to OEC MMONO(2009)20/	cation CD	uali	ty	Nano
Nanomaterial nameCeO2Particle CodeCeO2		D₂ D₂NP_002	Manufacturer /Institute/Date Jordi Piella Bagaria; provided by ICN; 12/2012 Technology Expert: Jordi Piella Bagaria		
CompositionCeO2Method of productionSol Ge		D ₂ Gel synthesis	-		
Kind of susp	ension:		Suspension Suspended in pH stabilizer	Powde water none	er
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglome	erated and crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	7000 6000 5000 900 0 0 2000 3000	4 4 50 60 10 80 2 theta angle (degree)
Crystallite size			HRTEM (KIT)		
Octanol-water partition	on coefficient		Determination of absorbance	e (ICN)	P _{OW} =0
Photocatalytic activity			Rhodamin-B Bleaching/UV-B 0.05mg/ml in Water (ICN)	3-100	none
Porosity		-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)		n.a.
Size distribution:	Medel velue X (DDI)	nm	Zetasizer Nano ZS /UCD		138 (PDI:0.367) NM: 24.65
(suspension in water)	Modal value X _M (PDI)		UNIVLEEDS DCS (UCD) (RWtAv / RNum/	Av)	240.3 (PDI:0.527)
	Total concentration	mg/ml			3.2
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI. DMA 3071 with C 3022A / KIT dispersed by electrospray	CPC	59 (σ _{geo} =1.18)
	Total concentration	mg/cm ³ or #/cm ³			1.8 x 10 ⁴ /cm ³
Solubility in		g/l			
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)		
Specific surface area		m²/g	BET by ASAP2020 (UU)		n.a.
Surface chemistry					
Zeta potential (surface charge)		mV	Zetasizer Nano ZS /UU		+48.5 ± 1.6 pH: 3.69

Summary of trace analyses		ICP-MS / KIT	CeO	CeO ₂
AI	µg/g		27	22
В	µg/g		4	3
Ва	µg/g		8.2	6.7
Са	µg/g		83	68
Gd	µg/g		19	16
La	µg/g		1.3	1.1
Lu	µg/g		0.4	0.3
Mg	µg/g		1.4	1.2
Mn	µg/g		0.3	0.2
Nd	µg/g		0.8	0.6
Pb	µg/g		0.2	0.1
Pt	µg/g		0.6	0.5
Sm	µg/g		2.0	1.6
Sr	hð/g		0.5	0.4
Ti	µg/g		41	33
Yb	hð/g		2.7	2.2
Zn	hð/g		3	2
Zr	hð/g		0.8	0.7
Electron microscopy	100	CeO2NP_002		-
Magnification: 450.000 UNIVLEEDS TEM		by KIT (LEM); Diameter: smaller	than 10 nm	
Radical formation potential by DCF-Test: (H_2O_2 as positive control) (KIT)	Result: CeO2 NP_0	The second secon		on at higi
Comments and other relevant physical				
Place, Date Karlsruhe, 08.04	.2013	Responsible HF	R. Paur, KIT	

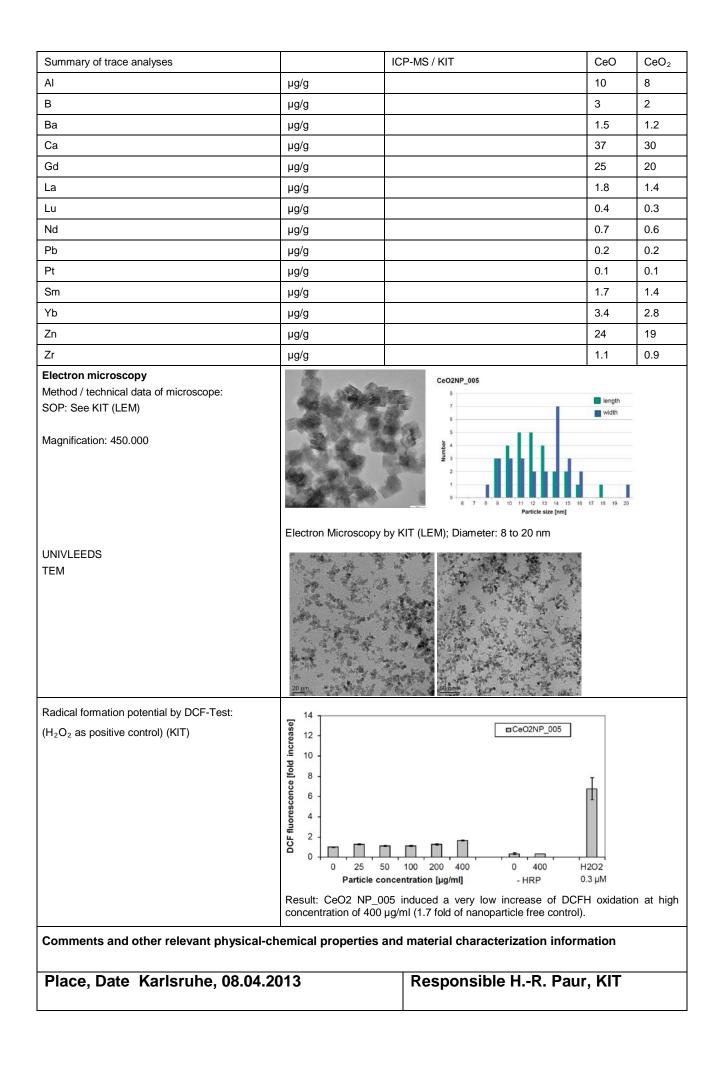
Na	anomaterial lo according to M/MONO(200	dentification OECD	tion	esearch Infrast	ty	Nano
Nanomaterial name CeO ₂ Particle Code CeO ₂		NP_003	Manufacturer /Institute/Date Jordi Piella Bagaria; provided by ICN; 12/2012 Technology Expert: Jordi Piella Bagaria			
CompositionCeO2Method of productionSol Get			el synthesis	-		
Kind of suspension:			Suspension Suspended in pH stabilizer	Powde water none	er	
Property			unit	Method / Institute	Value	
Agglomeration/aggre	egation			HRTEM (KIT)		merated and crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	7000 6000 1 1 1 1 2000 1 2000 1 2000 2000	10 40 50 60 70 50 20rda argie (digree)	
Crystallite size				HRTEM (KIT)		
Octanol-water partiti	on coefficient			Determination of absorbance	(ICN)	P _{ow} =0
Photocatalytic activit	у			Rhodamin-B Bleaching/UV-B- 0.05mg/ml in Water (ICN)	·100	none
Porosity			-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution and Volume by ASAP2020 (UU)		n.a.	
Size distribution: (suspension in water)	Modal value X		nm	Zetasizer Nano ZS /UCD UNIVLEEDS DCS (UCD) (RWtAv / RNumA	v)	146.1 (PDI:0.423) NM: 25.47 147.5 (PDI:0.347)
	Total concentr	ation	mg/ml			3.2
Size distribution: (Aerosol)	Modal value X	_M (σ _{geo})	nm	SMPS TSI. DMA 3071 with CPC 3022A / KIT dispersed by electrospray		40.5 (σ _{geo} =1.15)
	Total concentr	ation	mg/cm ³ or #/cm ³			3.5 x 10 ⁴ /cm ³
Solubility in			g/l			
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)			
Specific surface area		m²/g	BET by ASAP2020 (UU)		n.a.	
Surface chemistry						
Zeta potential (surface charge)		mV	Zetasizer Nano ZS /UU		+46.4 ± 0.7 pH: 3.66	

Summary of trace analyses		ICP-MS / KIT	CeO	CeO ₂
Al	µg/g		34	27
В	hð\ð		7	5
Ва	hð\ð		4.3	3.5
Са	hð\ð		139	113
Gd	hð\ð		23	19
La	hð\ð		1.7	1.4
Lu	hð\ð		0.4	0.4
Mg	hð\ð		2.9	2.4
Mn	µg/g		1.3	1.0
Nd	hð\ð		0.9	0.7
Ni	µg/g		3.4	2.7
Pb	µg/g		0.3	0.2
Pt	µg/g		0.6	0.5
Sm	μg/g		2.2	1.8
Sr	hð\ð		0.6	0.5
Ti	hð\ð		1.7	1.4
Yb	µg/g		3.3	2.6
Zn	µg/g		5	4
Zr	µg/g		1.0	0.8
Magnification: 450.000 UNIVLEEDS TEM	Electron Microscop	y by KIT (LEM); Diameter : smaller	than 10 nm	
Radical formation potential by DCF-Test: (H ₂ O ₂ as positive control) (KIT)	Result: CeO2 NP_			on at high
Comments and other relevant physical	-chemical properties	and material characterization	n information	
Place, Date Karlsruhe, 08.04	.2013	Responsible HR	. Paur, KIT	

Na	ENTATIVE TEST nomaterial Identif according to OE 1/MONO(2009)20	ication CD	Research Infra	ty	Nano
Nanomaterial name CeO ₂ Particle Code CeO ₂ NP		202 202NP_004	Manufacturer /Institute/Date Jordi Piella Bagaria; provided by ICN; 12, Technology Expert: Jordi Piella Bagaria		
Composition Method of proc		eO2 I Gel synthesis			
Kind of susp	ension:		Suspension Suspended in pH stabilizer	Powde water none	er
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglom	erated and crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	10000 8000 7000 7000 5000 8000 3000 1000 20	10 40 50 60 70 80 2014ct angle (degree)
Crystallite size			HRTEM (KIT)		
Octanol-water partition	on coefficient		Determination of absorbance	e (ICN)	P _{OW} =0
Photocatalytic activity	/		Rhodamin-B Bleaching/UV-B 0,05mg/ml in Water (ICN)	8-100	none
Porosity		-/- or %	n.a.		n.a.
Pour density		cm³/g	(BJH) Pore Size Distribution Volume by ASAP2020 (UU)		n.a.
Size distribution:	Madaluatus X. (DDI) nm	Zetasizer Nano ZS /UCD		63.21 (PDI:0.199) NM: 31.86
(suspension in water)	Modal value X _M (PDI) """	UNIVLEEDS DCS (UCD) (RWtAv / RNum,	Av)	52.7 (PDI:0.172)
	Total concentration	mg/ml			3.2
Size distribution: (Aerosol)	Modal value X_M (σ_{geo}) nm	SMPS TSI. DMA 3071 with C 3022A / KIT dispersed by electrospray	CPC	74.5 (σ _{geo} =1.25)
	Total concentration	mg/cm ³ or #/cm ³			3.1 x 10 ⁴ /cm ³
Solubility in		g/l			
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)		
Specific surface area		m²/g	BET by ASAP2020 (UU)		n.a.
Surface chemistry					
Zeta potential (surfac	e charge)	mV	Zetasizer Nano ZS /UU		+39.2 ± 0.5 pH: 5.97



Na	ENTATIVE TES nomaterial Identi according to OE //MONO(2009)20	fication CD	Research Infra	ty	Nano
Nanomaterial nameCeO2Particle CodeCeO2NP_00		-	Manufacturer /Institute/I Jordi Piella Bagaria; pro Technology Expert: Jord	ovided by	
Composition Method of pro-	-	eO ₂ ol Gel synthesis	_		
Kind of susp	ension:		Suspension Suspended in pH stabilizer	Powde water none	er
Property		unit	Method / Institute	Value	
Agglomeration/aggre	egation		HRTEM (KIT)	Agglome	erated and crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	10000 9000- 10000 1000- 900- 900- 1000- 1000- 1000- 200- 1000- 200- 1000- 200- 10000	10 40 50 60 70 80 24theta angle (degree)
Crystallite size			HRTEM (KIT)	1	
Octanol-water partiti	on coefficient		Determination of absorbance	e (ICN)	P _{OW} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/UV-B 0,05mg/ml in Water (ICN)	-100	none
Porosity		-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution Volume by ASAP2020 (UU)		n.a.
Size distribution:	Medal value X (DD	I) nm	Zetasizer Nano ZS /UCD		71.3 (PDI:0.212) NM: 36.4
(suspension in water)	Modal value X _M (PD	"	UNIVLEEDS DCS (UCD) (RWtAv / RNum,	Av)	56.08 (PDI:0.179)
	Total concentration	mg/ml			3.2
Size distribution: (Aerosol)	Modal value X_M (σ_{ge}	_{o)} nm	SMPS TSI. DMA 3071 with C 3022A / KIT dispersed by electrospray	CPC	70.0 (σ _{geo} =1.30)
	Total concentration	mg/cm ³ or #/cm ³			1.0 x 10 ⁴ /cm ³
Solubility in		g/l			
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)		
Specific surface area	a	m²/g	BET by ASAP2020 (UU)		n.a.
Surface chemistry Zeta potential (surfac	ce charge)	mV	Zetasizer Nano ZS /UU		+33.5 ± 4.9 pH: 6.04



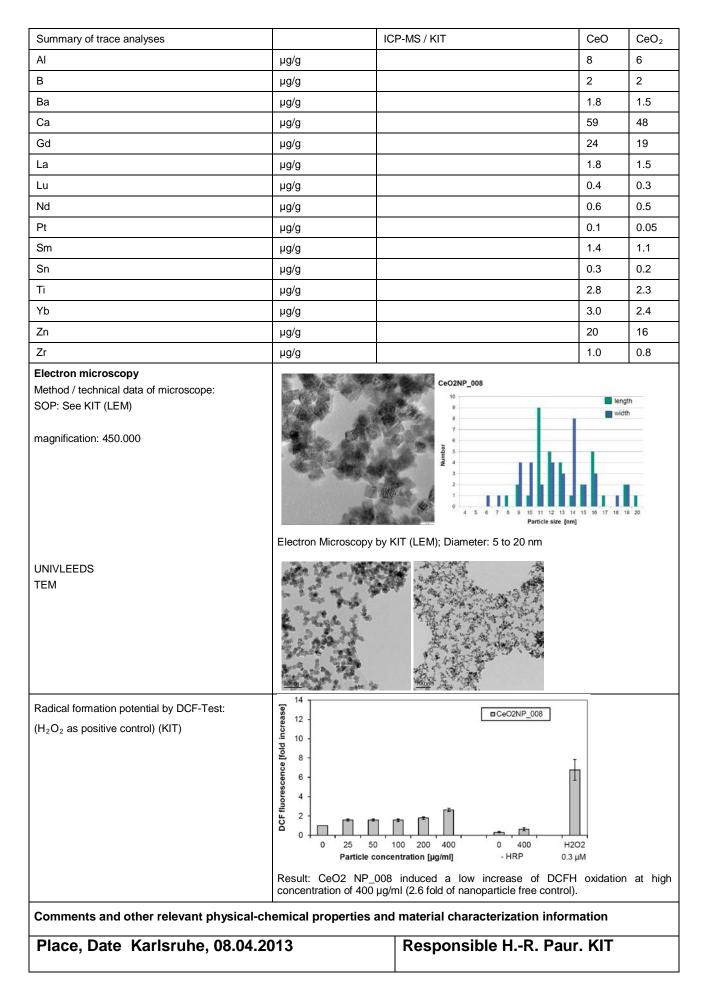
Na	ENTATIVE TEST nomaterial Identif according to OE M/MONO(2009)20	ication CD	Research Infra	ty	Nano
Nanomaterial nameCeO2Particle CodeCeO2NP_006		=	Manufacturer /Institute/ Jordi Piella Bagaria; pro Technology Expert: Jord	ovided by	
Composition Method of proc		eO2 I Gel synthesis			
Kind of susp	ension:		Suspension Suspended in pH stabilizer	Powde water none	er
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglom	erated and crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	10000 9000- 3000- 3000- 3000- 3000- 3000- 2000- 2000- 2000- 2000- 200- 2	10 40 50 60 70 80 2-theta angle (degree)
Crystallite size			HRTEM (KIT)	•	
Octanol-water partition	on coefficient		Determination of absorbance	e (ICN)	P _{ow} =0
Photocatalytic activit	ý		Rhodamin-B Bleaching/UV-E 0,05mg/ml in Water (ICN)	3-100	none
Porosity		-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution Volume by ASAP2020 (UU)		n.a.
Size distribution: (suspension in water)	Modal value X _M (PDI	·	Zetasizer Nano ZS /UCD UNIVLEEDS DCS (UCD) (RWtAv / RNumAv)		71.6 (PDI:0.187) NM: 30.21 63.9 (PDI:0.618) 3.2
	Total concentration	mg/ml	SMPS TSI. DMA 3071 with 0		
Size distribution: (Aerosol)	Modal value X_M (σ_{geo}	.) nm	3022A / KIT dispersed by electrospray		64.0 (σ _{geo} =1.40)
	Total concentration	mg/cm ³ or #/cm ³			2.2 x 10 ⁴ /cm ³
Solubility in	•	g/l			
Solubility in H_2O		g/l	Extraction/ ICP-MS (ICN)		
Specific surface area	l	m²/g	BET by ASAP2020 (UU)		n.a.
Surface chemistry					
Zeta potential (surfac	ce charge)	mV	Zetasizer Nano ZS /UU		+30.5 ± 2.2 pH: 6.04

Summary of trace analyses		ICP-MS / KIT	CeO	CeO ₂
Al	hð\ð		7	6
В	µg/g		2	2
Ва	µg/g		2.5	2.0
Са	µg/g		70	57
Gd	µg/g		23	19
La	µg/g		1.6	1.3
Lu	µg/g		0.4	0.3
Nd	µg/g		0.6	0.5
Pb	µg/g		0.1	0.1
Pt	µg/g		1.0	0.8
Sm	µg/g		1.4	1.2
Ті	µg/g		3.6	3.0
Yb	µg/g		3.2	2.6
Zn	hā\ð		22	18
Zr	hð\ð		0.9	0.8
Magnification: 450.000 UNIVLEEDS TEM	Electron Microscopy	by KIT (LEM); Diameter: 8 to 20	13 14 15 16 17 18 19 20 cle size [m]	
Radical formation potential by DCF-Test:	50 nm		2.006	
(H ₂ O ₂ as positive control) (KIT)	10 10 10 8 6 - - - - - - - - - - - - -	ישיים 1, ה, ה, ה, ה	0 H2O2 0.3 μM se of DCFH oxidatio	m at higi
			,	
Comments and other relevant physical	-chemical properties	and material characterizati	on information	

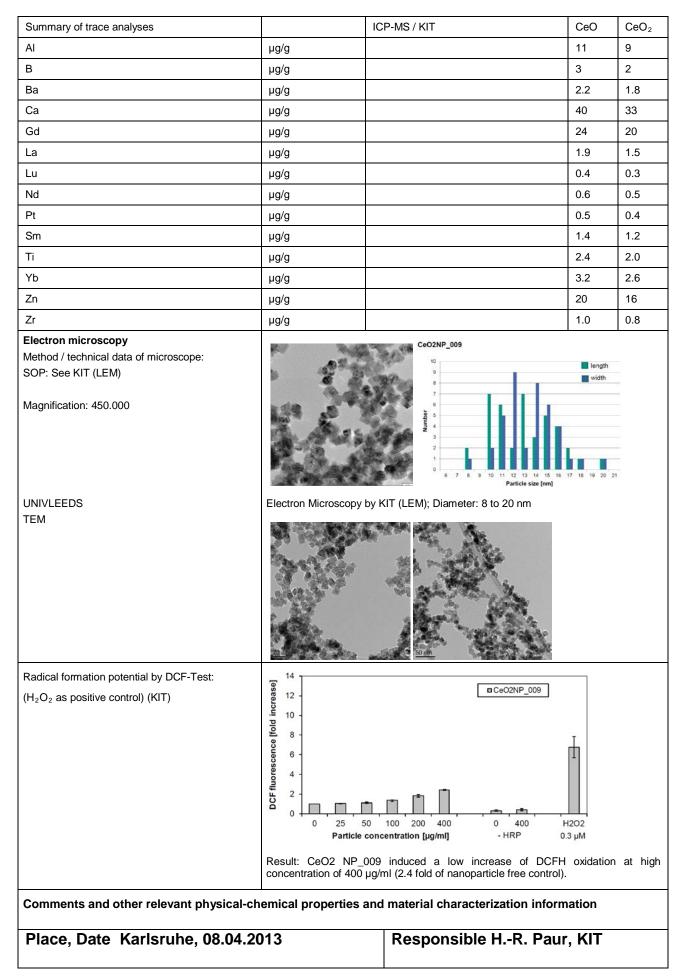
Na	ENTATIVE TEST nomaterial Identifi according to OEC //MONO(2009)20/	cation CD	Research Infra		Nano
Nanomaterial nameCeO2Particle CodeCeO2NP_007		-	Manufacturer /Institute/I Jordi Piella Bagaria; pro Technology Expert: Jord	ovided by	
Composition Method of pro-	Ce0 duction Sol	D₂ Gel synthesis	-		
Kind of susp	ension:		Suspension Suspended in pH stabilizer	Powde water none	er
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglome	erated and crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	14000 12000 1000000	Mi Uhrand 30 40 50 60 70 80 2/theta angle (dogree)
Crystallite size			HRTEM (KIT)		
Octanol-water partition	on coefficient		Determination of absorbance	e (ICN)	P _{OW} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/UV-B 0,05mg/ml in Water (ICN)	9-100	high
Porosity		-/- or %	n.a.		n.a.
Pour density		cm³/g	(BJH) Pore Size Distribution Volume by ASAP2020 (UU)		n.a.
Size distribution: (suspension in water)	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD UNIVLEEDS	A)	74.29 (PDI:0.204) NM: 40.26 64.79 (PDI:0.166)
water)	Total concentration	mg/ml	DCS (UCD) (RWtAv / RNum,	AV)	3.2
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	nm	SMPS TSI. DMA 3071 with C 3022A / KIT dispersed by electrospray	CPC	71.1 (σ _{geo} =1.18)
	Total concentration	mg/cm ³ or #/cm ³			2.2 x 10 ⁴ /cm ³
Solubility in	1	g/l			1
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)		
Specific surface area	à	m²/g	BET by ASAP2020 (UU)		n.a.
Surface chemistry					
Zeta potential (surfac	ce charge)	mV	Zetasizer Nano ZS /UU		+39.3 ± 0.8 pH: 6.1

Summary of trace analyses		ICP-MS / KIT	CeO	CeO ₂
Al	hð\ð		8	7
В	µg/g		5	4
Ва	µg/g		2.3	1.9
Са	µg/g		53	43
Gd	µg/g		22	18
La	µg/g		1.6	1.3
Lu	hð\ð		0.4	0.3
Nd	hð\ð		0.6	0.5
Pt	hð\ð		0.2	0.1
Sm	hð\ð		1.3	1.1
Ti	hð\ð		6.0	4.9
Yb	hð\ð		2.8	2.3
Zn	hð\ð		19	15
Zr	μg/g		0.9	0.8
Magnification: 450.000	Electron Microscopy	by KIT (LEM); Diameter : Rough	ticle size [nm] estimate of particle-	size
UNIVLEEDS TEM	distribution, the maximum of the max	imum of the distribution seems to		5 1111
Radical formation potential by DCF-Test: $(H_2O_2 \text{ as positive control})$ (KIT)	Result: CeO2 NP_	DOT induced a low increase pg/ml (2.6 fold of nanoparticle free	H2O2 0.3 μM of DCFH oxidatio	n at hig
Comments and other relevant physical				
Place, Date Karlsruhe, 08.04		Responsible HI		

REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.			Research Infras	ty	Nano
Nanomaterial nameCeO2Particle CodeCeO2NP_008		-	Manufacturer /Institute/I Jordi Piella Bagaria; pro Technology Expert: Jord	ovided by	·
Composition Method of proc	Ce duction So	O ₂ I Gel synthesis			
Kind of susp	ension:		Suspension Suspended in pH stabilizer	Powde water none	er
Property		unit	Method / Institute	Value	
Agglomeration/aggre	gation		HRTEM (KIT)	Agglom	erated and crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X'Pert diffractometer (ICN)	8000 7000 - 6000 - 1000 - 1000 - 1000 - 20	10 40 50 60 70 80 2-theta angle (degree)
Crystallite size			HRTEM (KIT)		
Octanol-water partition	on coefficient		Determination of absorbance	e (ICN)	P _{OW} =0
Photocatalytic activity	ý		Rhodamin-B Bleaching/UV-B 0.05mg/ml in Water (ICN)	5-100	none
Porosity		-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution Volume by ASAP2020 (UU)		n.a.
Size distribution:	Modal value X _M (PDI)	nm	Zetasizer Nano ZS /UCD		65.34 (PDI:0.158) NM: 36.9
(suspension in			UNIVLEEDS		63.61 (PDI:0.153)
water)		malmi	DCS (UCD) (RWtAv / RNum/	Av)	3.2
Size distribution: (Aerosol)	Total concentration Modal value X_M (σ_{geo}	mg/ml	SMPS TSI. DMA 3071 with C 3022A / KIT dispersed by electrospray	CPC	65.0 (σ _{geo} =1.22)
	Total concentration	mg/cm ³ or #/cm ³			8.4 x 10 ⁴ /cm ³
Solubility in	1	g/l			
Solubility in H ₂ O		g/l	Extraction/ ICP-MS (ICN)		
Specific surface area		m²/g	BET by ASAP2020 (UU)		n.a.
Surface chemistry					
Zeta potential (surfac	ce charge)	mV	Zetasizer Nano ZS /UU		+33.5 ± 3.6 pH: 6.04



REPRESENTATIVE TEST PARTICLES Nanomaterial Identification according to OECD ENV/JM/MONO(2009)20/REV pp29.		uali	ty	Nano	
Nanomaterial nameCeO2Particle CodeCeO2NP_009		-	Manufacturer /Institute/I Jordi Piella Bagaria; pro Technology Expert: Jord	ovided by	
Composition Method of pro	Ce duction Sol	O ₂ Gel synthesis			
Kind of susp	ension:		Suspension Suspended in pH stabilizer	Powde water none	er
Property		unit	Method / Institute	Value	
Agglomeration/aggre	egation		HRTEM (KIT)	Agglom	erated and crystalline
Crystalline phase			D5000 Diffractometer (UU) PANalytical X´Pert diffractometer (ICN)	8000 7000 - (10) 12 4000 - 1000 - 1000 - 2000 - 2000 - 200 -	30 40 50 60 2.theta angle (degree)
Crystallite size			HRTEM (KIT)		
Octanol-water partiti	on coefficient		Determination of absorbance	e (ICN)	P _{ow} =0
Photocatalytic activit	у		Rhodamin-B Bleaching/UV-B 0.05mg/ml in Water (ICN)	-100	high
Porosity		-/- or %	n.a.		n.a.
Pour density		cm3/g	(BJH) Pore Size Distribution Volume by ASAP2020 (UU)		n.a.
Size distribution: (suspension in water)	Modal value X_M (PDI)	nm	Zetasizer Nano ZS /UCD UNIVLEEDS DCS (UCD) (RWtAv / RNum/	Αν)	71.05 (PDI:0.202) NM: 42.14 56.32 (PDI:0.167)
	Total concentration	mg/ml		•	3.2
Size distribution: (Aerosol)	Modal value X_M (σ_{geo})	, nm	SMPS TSI. DMA 3071 with CPC 3022A / KIT dispersed by electrospray		71.8 (σ _{geo} =1.45)
	Total concentration	mg/cm ³ or #/cm ³			9.6 x 10 ⁴ /cm ³
Solubility in		g/l			
Solubility in H_2O		g/l	Extraction/ ICP-MS (ICN)		
Specific surface area	a	m²/g	BET by ASAP2020 (UU)		n.a.
Surface chemistry					
Zeta potential (surfa	ce charge)	mV	Zetasizer Nano ZS /UU		+37.7 ± 0.5 pH: 6.1



Supplemental S8: Comparison of B2B to JRC data

Table S8-1: Comparison of physicochemical data for the B2B Stöber synthesized Silica NM and the JRC precipitated SAS (synthetic amorphous silica)

Particle Property	B2B Stöber Silica NMs	NM-200, NM-201, NM-204
Number of batches	8	3
Trace impurities (Main elements)	Up to 36 µg/g Na	>1 µg/g Na and Al
	Al < detection limit	
	36 to 82 µg/g Ca	
Dissolution in water	< detection limit	Not analyzed
Crystal structure	Amorphous	Amorphous
Crystal size		
Mobility diameter	33 to 118 nm	Not analyzed
Hydrodynamic diameter (DLS)	25 to 120 nm	NM200: 180 to 240 nm
	23 to 120 mm	dep. on lab
Zeta potential (surface charge)	-45 to -66 mV	-30 to -40 mV
	(pH 8.4±0.57)	(pH ~8)
Photocatalytic activity	No	Not analyzed
Octanol- water partition coefficient	Not analyzed	Not analyzed
Radical formation	2 – 24.2-fold	< detection limit
Reference		[2]

Table S8-2: Comparison of physicochemical data for the B2B flame synthesized silica NMs and the JRC fumed synthesized amorphous silica (SAS)

Particle Property	B2B Flame Silica NMs	NM-202, NM-203
Number of batches	6	2
Trace impurities (Main elements)	Up to 75 µg/g (Al)	< detection limit
Dissolution in water	6 to 10 wt %	Not analyzed
Crystal structure	Amorphous	Amorphous
Crystal size		
Mobility diameter	32 to 160 nm.	Not analyzed
Hydrodynamic diameter (DLS)	200 to 380 nm	NM200: 147 to 2453nm
	200 to 380 fill	dep. on lab
Zeta potential (surface charge)	-15 to -18 mV	-30 to -40 mV
	(pH ~4.3)	(pH ~8)
Photocatalytic activity	No	Not analyzed
Octanol- water partition coefficient	< detection limit	Not analyzed
Radical formation	2 - 6.2-fold	< detection limit
Reference		[2]

Particle Property	B2B Zinc oxide NMs	NM-110, NM-111,
		NM-112, NM-113
Number of batches	9	4
Trace impurities (Main elements)	7 - 77 μg/g Na	3 - 176 μg/g Na
	1.8 – 3.7 μg/g Cu	3 – 120 µg/g Cu
	3 – 136 µg/g Ca	40 – 680 μg/g Ca
	8 – 1080 μg/g Fe	
	19 – 60 µg/g Sr	
Dissolution in water	7 wt %	1 - 400 wt-‰
Crystal structure	Crystalline	Crystalline
	hexagonal zinc oxide or	
	'Wurtzite'	
Crystal size	20 to 30 nm	24 to 42 nm
Mobility diameter	25 to 55 nm	278 nm (only NM-110)
Hydrodynamic diameter (DLS)	130 to 900 nm	253 to 508 nm
Zeta potential (surface charge)	-15 to +24 mV	20.2 – 24.6 mV
	(pH ~6)	(pH not indicated)
Photocatalytic activity	High	No
Octanol- water partition coefficient	< detection limit	Not analyzed
Radical formation	3- to 4-fold	Not analyzed
Reference		[1]

Table S8-3: Comparison of physicochemical data for the B2B zinc oxide NM and the JRC zinc oxide NM

Table S8-4: Comparison of physicochemical data for the B2B titania NMs and the JRC titania

Particle Property	Titanium dioxide NMs	NM-100, NM-101, NM- 102, NM-103, NM-104, NM-105
Number of batches	8	6
Trace impurities (Main elements)	Up to 96 mg/g Na	>1 mg/g Na and Al
Dissolution in water	n.d.	Not analyzed
Crystal structure	Crystalline	Crystalline
	anatase with small	anantase, rutile or
	fraction of brookite	mixture (NM-1005)
Crystal size	4.5 to 6 nm	< 100 nm, 57nm, > 80nm
		depending on lab
Mobility diameter	33 to 70 nm.	Not analyzed
Hydrodynamic diameter (DLS)	60 to 280 nm	113 to 423 nm
Zeta potential (surface charge)	33 to 40 mV (pH ~10)	-40mV to >30 mV depending on pH pH 10: ~ -25 to -40 mV
Photocatalytic activity	Low	Not analyzed
Octanol- water partition coefficient	< detection limit	Not analyzed
Radical formation	1 - 4.8 fold	Not analyzed
Reference		[3]

Table S8-5: Comparison of physicochemical data for the B2B Cerium dioxide NMs and the JRC Cerium dioxide

Particle Property	Cerium dioxide NMs	NM-211, NM-212,
		NM-213
Number of batches	9	3
Trace impurities (Main elements)	87 to 187 μg/g Ca	100 μg/g Ca
Dissolution in water	< detection limit	1.05 to 5.085 ng/g
Crystal structure	Crystalline:	Crystalline:
	cubic lattice	cubic lattice
Crystal size	5 to 8 nm	10.3 to 33.3 nm (NPL)
		or 9 to 49 nm (JRC)
		depending on lab
Mobility diameter	40 to 74 nm.	Not analyzed
Hydrodynamic diameter (DLS)	63 to 146 nm	213 to 349 nm
Zeta potential (surface charge)	30 to 49 mV	-7 to +33 mV
	(pH 3.8 to 6.1)	(pH not indicated)
Photocatalytic activity	No	No or low
Octanol- water partition	< detection limit	Not analyzed
coefficient		
Radical formation	2 to 12-fold	Not analyzed
Reference		[4]

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